Freescale Semiconductor

Data Sheet: Technical Data

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P3041 QorlQ Integrated Processor Hardware Specifications



P3041

FC-PBGA-1295 37.5 mm x 37.5 mm

The P3041 QorIQ integrated processor utilizes four processor cores built on Power Architecture® technology. The cores include high-performance data path acceleration logic and network and peripheral bus interfaces required for networking, telecom/datacom, wireless infrastructure, and aerospace applications.

This chip can be used for combined control, data path, and application layer processing in routers, switches, base station controllers, and general-purpose embedded computing. Its high level of integration offers significant performance benefits compared to multiple discrete devices while also greatly simplifying board design.

The chip includes the following functions and features:

- Four e500mc Power Architecture cores, each with a backside 128 KB L2 cache with ECC
 - Three levels of instructions: User, supervisor, and hypervisor
 - Independent boot and reset
 - Secure boot capability
- CoreNet fabric supporting coherent and non-coherent transactions amongst CoreNet end-points
- CoreNet platform cache with ECC
- CoreNet bridges between the CoreNet fabric the I/Os, datapath accelerators, and high and low speed peripheral interfaces
- One 10-Gigabit Ethernet (XAUI) controller
- Five 1-Gigabit Ethernet controllers
 - SGMII interfaces
 - 2.5 Gbps SGMII interfaces
 - RGMII interfaces
- One 64-bit DDR3 SDRAM memory controller with ECC
- Multicore programmable interrupt controller
- Four I²C controllers
- Four 2-pin UARTs or two 4-pin UARTs
- Two 4-channel DMA engines

- Enhanced local bus controller (eLBC)
- Four PCI Express 2.0 controllers/ports
- Two serial RapidIO® controllers/ports (sRIO port) supporting version 1.3 with features from 2.1
- Two serial ATA (SATA 2.0) controllers
- Enhanced secure digital host controller (SD/MMC)
- Enhanced serial peripheral interfaces (eSPI)
- 2× high-speed USB 2.0 controllers with integrated PHYs



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P3041 **Power Architecture®** 28-Kbyte e500mc Core 1024-Kbyte 64-bit DDR3/3L Backside 32-Kbyte I-Cache L2 Cache 32-Kbyte Frontside D-Cache **CoreNet Platform** Memory Controller Cache eOpenPIC 1 \$ ᡟ PreBoot CoreNet Coherency Fabric Loader Security Peripheral Access Mgmt Unit < Monitor PAMU PAMU PAMU PAMU PAMU Interna 1 1 1 1 **BootROM** Power Mgmt Frame Manager **Real Time Debug** SD/MMC Parse, Classify, Distribute Security Queue Watchpoint 2x DMA eLBC 4.2 Mgr Cross SPI Trigger SATA 2.0 SATA 2.0 Buffer 2x DUART $4x l^2C$ Perf CoreNet Pattern 1GE PCIe 2.0 RapidIO PCle 2.0 Buffer Mgr PCIe 2.0 Match 1GE Monitor Trace RMan PCle 2x USB 2.0 PHY RIO 1.3/2.1 RIO 1.3/2.1 Engine 10GE 1GE 2.1 1GE Aurora Clocks/Reset 1GE **GPIO** ¥ CCSR 18-Lane 5-GHz SerDes

This figure shows the major functional units within the chip.

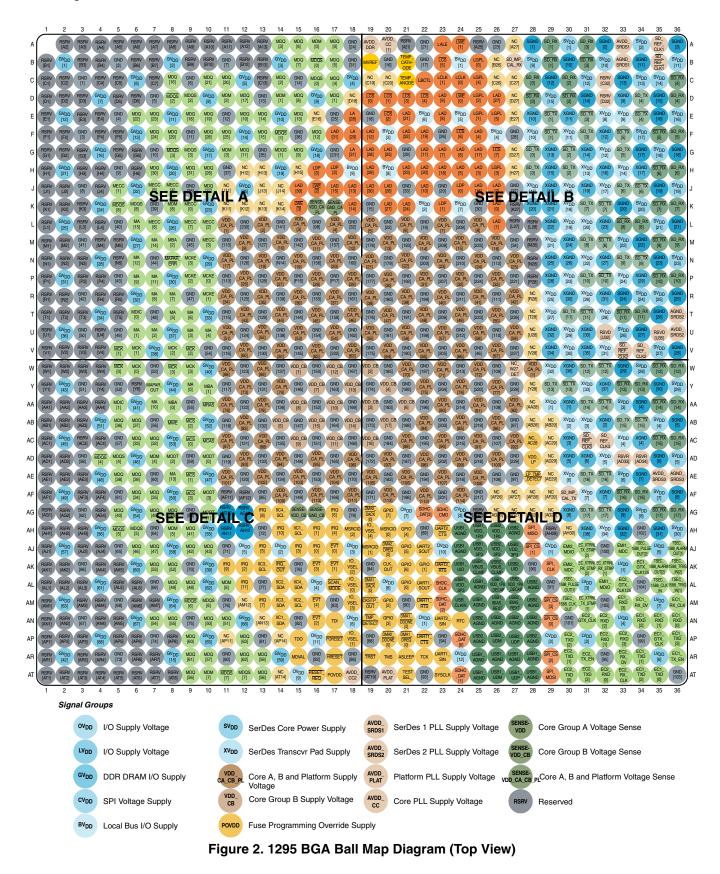
Figure 1. Block Diagram

1 Pin Assignments and Reset States

This section contains top view and detailed quadrant views of the FC-PBGA ball map diagram followed by a pinout list.

1.1 1295 FC-PBGA Ball Layout Diagrams

These figures show the FC-PBGA ball map diagrams.



| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 |
|---|--------------|--------------------------|--------------|--------------------------|--------------|--------------------------|--------------------------|--------------------------|-------------------|--------------------------|-----------------------|--------------------------|-----------------------|--------------------------|-----------------------|--------------------------|-------------------------|-------------------------|
| A | | RSRV [A2] | RSRV [A3] | RSRV [A4] | RSRV [A5] | RSRV [A6] | RSRV [A7] | RSRV [A8] | RSRV [A9] | RSRV [A10] | RSRV [A11] | RSRV [A12] | RSRV [A13] | MDQ [3] | MDQ [6] | MDM [0] | MDQ [0] | GND [24] |
| В | RSRV [B1] | GV _{DD} [1] | RSRV [B3] | RSRV [B4] | GND [2] | RSRV [B6] | RSRV [B7] | GV _{DD} [2] | RSRV [B9] | RSRV [B10] | GND [7] | RSRV [B12] | RSRV [B13] | GV _{DD} [3] | MDQ [7] | MDQS [0] | MDQ [5] | GND [31] |
| С | RSRV [C] | RSRV [C2] | GND [1] | RSRV [C4] | RSRV [C5] | GV _{DD} [6] | RSRV [C7] | MDQ [16] | GND [6] | MDQ [21] | MDQ [20] | GV _{DD} [5] | RSRV [C13] | MDQ [2] | GND [14] | MDQS [0] | MDQ [4] | GV _{DD} [4] |
| D | RSRV [D1] | RSRV [D2] | RSRV [D3] | GV _{DD} [7] | RSRV [D5] | RSRV [D6] | GND [5] | MDQS [2] | MDQS [2] | GV _{DD} [8] | MDM [2] | MDQ [17] | GND [13] | MDM [1] | MDQ [8] | GV _{DD} [9] | MDQ [1] | NC [D18] |
| E | RSRV [E1] | GV _{DD} [12] | RSRV [E3] | RSRV [E4] | GND [4] | MDQ [22] | MDQ [23] | GV _{DD} [11] | MDQ [18] | MDQ [19] | GND [12] | MDQ [10] | MDQ [14] | GV _{DD} [10] | MDQ [13] | NC [E16] | GND [25] | LAD [28] |
| F | RSRV [F1] | RSRV [F2] | GND [3] | RSRV [F4] | RSRV [F5] | GV _{DD} [13] | MDQ [24] | MDQ [29] | GND [11] | MDQ [28] | MDQ [25] | GV _{DD} [14] | MDQ [15] | MDQS [1] | GND [36] | MDQ [12] | LAD [31] | LAD [29] |
| G | RSRV [G1] | RSRV [G2] | RSRV [G3] | GV _{DD} [16] | RSRV [G5] | RSRV [G6] | GND [10] | MDQS [3] | MDQS [3] | GV _{DD} [17] | MDM [3] | MDQ [11] | GND [35] | MDQS [1] | MDQ [9] | GV _{DD} [18] | GND [231] | LA [31] |
| Н | RSRV [H1] | GV _{DD} [21] | RSRV [H3] | RSRV [H4] | GND [9] | RSRV [H6] | MDQ [30] | GV _{DD} [20] | MDQ [31] | MDQ [26] | GND [37] | NC [H12] | NC [H13] | GV _{DD} [19] | NC [H15] | LDP [3] | LDP [2] | BV _{DD} [9] |
| J | RSRV [J1] | RSRV [J2] | GND [8] | RSRV [J4] | MECC [1] | GV _{DD} [22] | MECC [5] | MECC [4] | GND [38] | MDQ [27] | NC [J11] | GV _{DD} [25] | NC [J13] | NC [J14] | LAD [30] | LWE [2] | LAD [15] | LAD [13] |
| К | RSRV [K1] | RSRV [K2] | RSRV [K3] | GV _{DD} [24] | MDQS [8] | MDQS [8] | GND [39] | MDM [8] | MECC [0] | GV _{DD} [23] | NC [K11] | NC [K12] | NC [K13] | NC [K14] | LWE [3] | SENSE- VDD_CA _PL | SENSE- GND_CA _PL | LAD [14] |
| L | RSRV [L1] | GV _{DD} [25] | RSRV [L3] | RSRV [L4] | GND [40] | MA [15] | MECC [6] | GV _{DD} [26] | MECC [7] | MECC [2] | VDD _CA_PL [1] | GND [230] | VDD _CA_PL [2] | GND [141] | VDD _CA_PL [3] | GND [98] | VDD _CA_PL [4] | GND [32] |
| М | RSRV [M1] | RSRV [M2] | GND [41] | RSRV [M4] | RSRV [M5] | GV _{DD} [27] | MA [14] | MBA [2] | GND [45] | MECC [3] | GND [113] | VDD _CA_PL [9] | GND [127] | VDD _CA_PL [10] | GND [142] | VDD _CA_PL [11] | GND [157] | VDD _CA_PL [12] |
| Ν | RSRV [N1] | RSRV [N2] | RSRV [N3] | GV _{DD} [28] | RSRV [N5] | MA [12] | GND [44] | MAPAR_ ERR | MCKE [3] | GV _{DD} [29] | VDD _CA_PL [17] | GND [126] | VDD _CA_PL [19] | GND [N14] | VDD _CA_PL [19] | GND [156] | VDD _CA_PL [20] | GND 160] |
| Ρ | RSRV [P1] | GV _{DD} [31] | RSRV [P3] | RSRV [P4] | GND [43] | MA [9] | MA [11] | GV _{DD} [30] | MCKE [2] | MCKE [0] | GND [113] | VDD _CA_PL [26] | GND [128] | VDD _CA_PL [27] | GND [P15] | VDD _CA_PL [28] | GND [P17] | VDD _CA_PL [29] |
| R | RSRV [R1] | RSRV [R2] | GND [42] | RSRV [R4] | RSRV [R5] | GV _{DD} [32] | MA [8] | MA [7] | GND [47] | MCKE [1] | VDD _CA_PL [34] | GND [125] | VDD _CA_PL [35] | GND [139] | VDD _CA_PL [36] | GND [155] | VDD _CA_PL [37] | GND [161] |
| Т | RSRV [T1] | RSRV [T2] | RSRV [T3] | GV _{DD} [34] | RSRV [T5] | MDIC [0] | GND [48] | MA [5] | MA [6] | GV _{DD} [33] | GND [115] | VDD _CA_PL [43] | GND [129] | VDD _CA_PL [44] | GND [144] | VDD _CA_PL [45] | GND [159] | VDD _CA_PL [46] |
| U | RSRV [U1] | GV _{DD} [36] | GND [50] | RSRV [U4] | GND [49] | MA [1] | MA [2] | GV _{DD} [37] | MA [3] | MA [4] | VDD _CA_PL [51] | GND [124] | VDD _CA_PL [52] | GND [138] | VDD _CA_PL [53] | GND [154] | VDD _CA_PL [54] | GND [162] |
| V | RSRV [V1] | RSRV [V2] | RSRV [V3] | RSRV [V4] | MCK [1] | MCK [1] | GV _{DD} [38] | MCK [2] | <u>МСК</u> [2] | GND [54] | GND [116] | VDD _CA_PL [60] | GND [130] | VDD _CA_PL [61] | GND [145] | VDD _CA_PL [62] | GND [222] | VDD _CA_PL [63] |

Figure 3. 1295 BGA Ball Map Diagram (Detail View A)

| 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | 27 | 28 | 29 | 30 | 31 | 32 | 33 | 34 | 35 | 36 | |
|-----------------------|-------------------------|-----------------------|-------------------------|-----------------------|-------------------------|-----------------------|-------------------------|-----------------------|--------------------------|--------------------------|--------------------------|--------------------------|--------------------------|--------------------------|--------------------------|--------------------------|--------------------------|---|
| AVDD_ DDR | AVDD_ CC [1] | RSRV [A21] | GND [21] | LALE | LWE [1] | RSRV [A25] | GND [23] | NC [A27] | SGND [1] | SD_RX [1] | SV _{DD} [1] | SD_RX [3] | SGND [2] | AVDD_ SRDS1 | SV _{DD} [2] | SD_ REF_ CLK1 | SGND [3] | A |
| MVREF | GND [16] | CATH- ODE | GND [17] | LCS [5] | BV _{DD} [1] | LGPL [0] | NC [B26] | SD_IMP_ CAL_RX | SV _{DD} [9] | SD_RX [1] | SGND [10] | SD_RX [3] | SV _{DD} [10] | AGND_ SRDS1 | SGND [11] | SD_ REF_ CLK1 | SV _{DD} [11] | в |
| NC [C19] | NC [C20] | TEMP_ ANODE | LBCTL | LCLK [1] | LCLK [0] | LGPL [4] | NC [C26] | NC [C27] | SD_RX [0] | SGND [12] | SD_RX [2] | SV _{DD} [12] | RSVR [C32] | SGND [13] | SV _{DD} [13] | SV _{DD} [14] | SD_RX [4] | С |
| LCS [0] | LCS [1] | LCS [3] | LCS [4] | LAD [9] | LWE [0] | LGPL [2] | LAD [27] | NC [D27] | SD_RX [0] | SV _{DD} [15] | SD_RX [2] | SGND [14] | RSVD [D32] | XGND [9] | SD_TX [4] | SGND [15] | SD_RX [4] | D |
| GND [18] | LCS [2] | LAD [21] | BV _{DD} [6] | LAD [8] | BV _{DD} [5] | LGPL [1] | LGPL [5] | NC [E27] | XGND [10] | SD_TX [1] | XGND [11] | SD_TX [3] | XV _{DD} [8] | XV _{DD} [9] | SD_TX [4] | SGND [16] | SV _{DD} [16] | Е |
| LAD [12] | BV _{DD} [3] | LAD [22] | LAD [19] | GND [26] | LCS [6] | LAD [4] | BV _{DD} [4] | GND [28] | XV _{DD} [10] | SD_TX [1] | XV _{DD} [11] | SD_TX [3] | XGND [12] | SD_TX [5] | SV _{DD} [17] | SD_RX [5] | SD_RX [5] | F |
| LAD [28] | LAD [25] | GND [29] | LAD [11] | LAD [7] | LAD [6] | LAD [17] | LCS [7] | NC [G27] | SD_TX [0] | XGND [13] | SD_TX [2] | XGND [14] | XV _{DD} [12] | SD_TX [5] | SGND [17] | SV _{DD} [18] | SGND [18] | G |
| LAD [29] | BV _{DD} [8] | LAD [23] | LAD [20] | LAD [18] | LAD [5] | LAD [3] | LGPL [3] | NC [H27] | SD_TX [0] | XGND [15] | SD_TX [2] | XV _{DD} [13] | XGND [16] | XV _{DD} [14] | XGND [17] | SD_RX [6] | SD_RX [6] | н |
| LAD [30] | LAD [26] | GND [33] | LAD [10] | GND [20] | LDP [0] | LAD [16] | LAD [2] | GND [27] | XV _{DD} [15] | XGND [18] | XV _{DD} [16] | XGND [19] | XV _{DD} [17] | SD_TX [6] | SD_TX [6] | SGND [19] | SV _{DD} [19] | J |
| GND [15] | LAD [27] | LAD [24] | BV _{DD} [2] | LDP [1] | BV _{DD} [7] | GND [30] | LAD [0] | RSRV [K27] | XGND [20] | XGND [21] | XV _{DD} [18] | SD_TX [7] | SD_TX [7] | SGND [20] | SV _{DD} [20] | SD_RX [7] | SD_RX [7] | к |
| VDD _CA_PL [5] | GND [22] | VDD _CA_PL [6] | GND [19] | VDD _CA_PL [7] | GND [209] | VDD _CA_PL [8] | LAD [1] | RSRV [L27] | RSRV [L28] | XGND [22] | XV _{DD} [19] | XV _{DD} [20] | XGND [23] | SD_RX [8] | SD_RX [8] | SV _{DD} [21] | SGND [21] | L |
| GND [178] | VDD _CA_PL [13] | GND [193] | VDD _CA_PL [14] | GND [208] | VDD _CA_PL [15] | GND [225] | VDD _CA_PL [16] | GND [34] | RSRV [M28] | XV _{DD} [21] | XGND [24] | SD_TX [8] | SD_TX [8] | SV _{DD} [22] | SGND [22] | SD_RX [9] | SD_RX [9] | М |
| VDD _CA_PL [21] | GND [179] | VDD _CA_PL [22] | GND [200] | VDD _CA_PL [23] | GND [210] | VDD _CA_PL [24] | GND [112] | VDD _CA_PL [25] | RSRV [N28] | XGND [25] | XGND [26] | XV _{DD} [22] | XGND [27] | SD_TX [9] | SD_TX [9] | SGND [23] | SV _{DD} [23] | N |
| GND [177] | VDD _CA_PL [30] | GND [192] | VDD _CA_PL [31] | GND [207] | VDD _CA_PL [32] | GND [224] | VDD _CA_PL [33] | GND [221] | RSRV [P28] | XGND [28] | XV _{DD} [23] | SD_TX [10] | SD_TX [10] | XV _{DD} [24] | XGND [29] | SD_RX [10] | SD_RX [10] | Ρ |
| VDD _CA_PL [38] | GND [180] | VDD _CA_PL [39] | GND [199] | VDD _CA_PL [40] | GND [211] | VDD _CA_PL [41] | GND [111] | VDD _CA_PL [42] | NC [R28] | XV _{DD} [25] | XGND [30] | XV _{DD} [26] | XGND [31] | SGND [24] | SV _{DD} [24] | SV _{DD} [25] | SGND [25] | R |
| GND [176] | VDD _CA_PL [47] | GND [191] | VDD _CA_PL [48] | GND [206] | VDD _CA_PL [49] | GND [223] | VDD _CA_PL [50] | GND [226] | NC [T28] | XV _{DD} [27] | SD_TX [11] | SD_TX [11] | XV _{DD} [28] | SD_RX [11] | SD_RX [11] | SGND [26] | AGND_ SRDS2 | т |
| VDD _CA_PL [55] | GND [181] | VDD _CA_PL [56] | GND [198] | VDD _CA_PL [57] | GND [212] | VDD _CA_PL [58] | GND [110] | VDD _CA_PL [59] | NC [U28] | XGND [32] | XV _{DD} [29] | XGND [33] | RSVD [U32] | SV _{DD} [26] | SGND [27] | RSVR [U35] | AVDD_ SRDS2 | U |
| GND [175] | VDD _CA_PL [64] | GND [190] | VDD _CA_PL [65] | GND [205] | VDD _CA_PL [66] | GND [46] | VDD _CA_PL [67] | GND [227] | NC [V28] | XGND [34] | XV _{DD} [30] | XGND [35] | XV _{DD} [31] | SD_ REF_ CLK2 | SD_ REF_ CLK2 | SV _{DD} [27] | SGND [28] | v |

Figure 4. 1295 BGA Ball Map Diagram (Detail View B)

| 7 | 7 | | | | | | | | | | | | | | | | | |
|----|---------------|--------------------------|---------------|--------------------------|---------------|--------------------------|---------------|--------------------------|-------------|--------------------------|------------------------|--------------------------|------------------------|--------------------------|-------------------------|--------------------------|------------------------|-------------------------|
| W | RSRV [W1] | RSRV [W2] | RSRV [W3] | RSRV [W4] | MCK [0] | MCK [0] | GND [53] | MCK [3] | MCK [3] | GV _{DD} [40] | VDD _CA_PL [68] | GND [123] | VDD _CA_PL [69] | GND [137] | VDD_CB [1] | GND [150] | VDD_CB [12] | GND [167] |
| Y | RSRV [Y1] | GV _{DD} [43] | GND [51] | RSRV [Y4] | GND [52] | RSRV [Y6] | MAPAR_ OUT | GV _{DD} [44] | MA [0] | MBA [1] | GND [117] | VDD _CA_PL [73] | GND [131] | VDD _CA_PL [74] | GND [146] | VDD_CB [7] | GND [163] | VDD_CB [13] |
| AA | RSRV [AA1] | RSRV [AA2] | RSRV [AA3] | RSRV [AA4] | MDIC [1] | GV _{DD} [41] | MA [10] | MBA [0] | GND [55] | MRAS | VDD _CA_PL [78] | GND [122] | VDD _CA_PL [79] | GND [136] | VDD_CB [8] | GND [152] | VDD_CB [10] | GND [169] |
| AB | RSRV [AB1] | RSRV [AB2] | RSRV [AB3] | GV _{DD} [51] | MDQ [36] | MDQ [37] | GND [56] | MWE | MCS [2] | GV _{DD} [52] | GND [118] | VDD _CA_PL [83] | GND [132] | VDD_CB [5] | GND [147] | VDD_CB [15] | GND [164] | VDD_CB [14] |
| AC | RSRV [AC1] | GV _{DD} [45] | RSRV [AC3] | RSRV [AC4] | GND [57] | MDQ [33] | MDQ [32] | GV _{DD} [53] | MCS [0] | MCAS | VDD _CA_PL [87] | GND [121] | VDD _CA_PL [88] | GND [135] | VDD_CB [9] | GND [151] | VDD_CB [11] | GND [168] |
| AD | RSRV [AD1] | RSRV [AD2] | GND [58] | MDQS [4] | MDQS [4] | GV _{DD} [46] | MDM [4] | MODT [2] | GND [59] | MODT [0] | GND [119] | VDD _CA_PL [93] | GND [133] | VDD _CA_PL [94] | GND [148] | VDD _CA_PL [95] | GND [165] | VDD _CA_PL [96] |
| AE | RSRV [AE1] | RSRV [AE2] | RSRV [AE3] | GV _{DD} [48] | MDQ [38] | MDQ [39] | GND [60] | MA [13] | MCS [1] | GV _{DD} [47] | VDD _CA_PL [101] | GND [120] | VDD _CA_PL [102] | GND [134] | VDD _CA_PL [103] | GND [153] | VDD _CA_PL [104] | GND [170] |
| AF | RSRV [AF1] | GV _{DD} [49] | RSRV [AF3] | RSRV [AF4] | GND [61] | MDQ [34] | MDQ [35] | GV _{DD} [50] | MCS [3] | MODT [3] | RSRV [AF11] | RSRV [AF12] | GND [85] | VDD _CA_PL [109] | GND [149] | VDD _CA_PL [110] | GND [166] | VDD _CA_PL [111] |
| AG | RSRV [AG1] | RSRV [AG2] | GND [62] | RSRV [AG4] | MDQ [40] | GV _{DD} [54] | MDQ [45] | MDQ [44] | GND [63] | MODT [1] | RSRV_ AG11 | RSRV_ AG12 | IRQ [8] | IIC4_ SCL | SENSE- VDD_CB | SENSE- GND_CB | IRQ [6] | GND [79] |
| AH | RSRV [AH1] | RSRV [AH2] | RSRV [AH3] | GV _{DD} [56] | MDQS [5] | MDQS [5] | GND [64] | MDM [5] | MDQ [41] | GV _{DD} [55] | RSRV_ AH11 | RSRV_ AH12 | GND [72] | IRQ [10] | IIC1_ SCL | IRQ [1] | IRQ [4] | MSRCID [2] |
| AJ | RSRV [AJ1] | GV _{DD} [57] | RSRV [AJ3] | RSRV [AJ4] | GND [65] | MDQ [46] | MDQ [47] | GV _{DD} [58] | MDQ [42] | MDQ [43] | GND [71] | OV _{DD} [5] | IRQ [5] | OV _{DD} [2] | IRQ [3] | IRQ [0] | EVT [0] | OV _{DD} [3] |
| AK | RSRV [AK1] | RSRV [AK2] | GND [66] | RSRV [AK4] | RSRV [AK5] | GV _{DD} [60] | MDQ [53] | MDQ [52] | GND [70] | GV _{DD} [39] | IRQ [9] | IRQ [2] | IIC3_ SCL | IRQ_ OUT | GND [78] | EVT [3] | EVT [1] | IO_ VSEL [2] |
| AL | RSRV [AL1] | RSRV [AL2] | RSRV [AL3] | GV _{DD} [61] | RSRV [AL5] | RSRV [AL6] | GND [69] | MDQ [49] | MDQ [48] | GV _{DD} [62] | MDM [6] | IRQ [11] | GND [77] | IIC2_ SDA | IIC4_ SDA | OV _{DD} [4] | SCAN_ MODE | IO_ VSEL [0] |
| AM | RSRV [AM1] | GV _{DD} [63] | RSRV [AM3] | RSRV [AM4] | GND [68] | RSRV [AM6] | RSRV [AM7] | GV _{DD} [64] | MDQS [6] | MDQS [6] | GND [76] | NC [AM12] | IRQ [7] | IIC3_ SDA | IIC2_ SCL | EVT [4] | GND [83] | IO_ VSEL [3] |
| AN | RSRV [AN1] | RSRV [AN2] | GND [67] | RSRV [AN4] | RSRV [AN5] | GV _{DD} [67] | MDQ [54] | MDQ [55] | GND [75] | MDQ [50] | MDQ [51] | GV _{DD} [66] | NC [AN13] | IIC1_ SDA | GND [82] | EVT [2] | TDI | OV _{DD} [6] |
| AP | RSRV [AP1] | RSRV [AP2] | RSRV [AP3] | GV _{DD} [68] | RSRV [AP5] | RSRV [AP6] | GND [74] | RSRV [AP8] | MDQ [60] | GV _{DD} [65] | NC [AP11] | MDQ [63] | GND [81] | NC [AP14] | TDO | OV _{DD} [11] | PORESET | IO_ VSEL [1] |
| AR | RSRV [AR1] | GV _{DD} [42] | RSRV [AR3] | RSRV [AR4] | GND [73] | RSRV [AR6] | RSRV [AR7] | GV _{DD} [15] | MDQ [61] | MDQ [57] | GND [80] | MDQ [62] | MDQ [59] | GV _{DD} [59] | MDVAL | GND [92] | HRESET | GND [86] |
| AT | RSRV [AT1] | RSRV [AT2] | RSRV [AT3] | RSRV [AT4] | RSRV [AT5] | RSRV [AT6] | RSRV [AT7] | RSRV [AT8] | MDQ [56] | MDM [7] | MDQS [7] | MDQS [7] | MDQ [58] | NC [AT14] | OV _{DD} [9] | RESET_ REQ | POVDD | AVDD_ CC2 |
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 |
| | | | | | Figur | e 5. 1 | 295 B(| GA Ba | all Ma | p Diag | gram (| Detail | View | C) | | | | |

| | | | | | | | | | | | | | | | | | ~ | |
|------------------------|-------------------------|-------------------------|-------------------------|--------------------------|--------------------------|------------------------|----------------------------|----------------------------|----------------------|--------------------------|-------------------------------|-----------------------------|-----------------------------|-------------------------|--------------------------------|--------------------------------|--------------------------------|----|
| VDD_CB [2] | GND [185] | VDD _CA_PL [70] | GND [197] | VDD _CA_PL [71] | GND [213] | VDD _CA_PL [72] | GND [109] | NC_ W27_ DET | VDD _CA_PL [1] | XV _{DD} [32] | XGND [36] | SD_TX [12] | SD_TX [12] | SGND [29] | SV _{DD} [28] | SD_RX [12] | SD_RX [12] | Ŵ |
| GND [174] | VDD_CB [4] | GND [189] | VDD _CA_PL [75] | GND [204] | VDD _CA_PL [76] | GND [220] | VDD _CA_PL [77] | GND [228] | NC [Y28] | SD_TX [13] | SD_TX [13] | XV _{DD} [33] | XGND [37] | SD_RX [13] | SD_RX [13] | SGND [30] | SV _{DD} [29] | Y |
| VDD_CB [3] | GND [183] | VDD_CB [6] | GND [196] | VDD _CA_PL [80] | GND [214] | VDD _CA_PL [81] | GND [108] | VDD _CA_PL [82] | NC [AA28] | XV _{DD} [1] | XGND [1] | SD_TX [14] | SD_TX [14] | SV _{DD} [3] | SGND [4] | SD_RX [14] | SD_RX [14] | AA |
| GND [173] | VDD_CB [17] | GND [188] | VDD _CA_PL [84] | GND [203] | VDD _CA_PL [85] | GND [219] | VDD _CA_PL [86] | GND [87] | NC [AB28] | NC [AB29] | XV _{DD} [2] | XV _{DD} [3] | XGND [2] | SD_TX [15] | SD_TX [15] | SV _{DD} [4] | SGND [5] | AB |
| VDD_CB [16] | GND [184] | VDD _CA_PL [89] | GND [195] | VDD _CA_PL [90] | GND [215] | VDD _CA_PL [91] | GND [107] | VDD _CA_PL [92] | NC_ AC28 | NC [AC29] | XGND [3] | SD_ REF_ CLK3 | SD_ REF_ CLK3 | XV _{DD} [4] | XGND [4] | SD_RX [15] | SD_RX [15] | AC |
| GND [172] | VDD _CA_PL [97] | GND [187] | VDD _CA_PL [98] | GND [202] | VDD _CA_PL [99] | GND [218] | VDD _CA_PL [100] | GND [229] | VDD_ LP | NC [AD29] | XGND [5] | XGND [6] | XV _{DD} [5] | RSVR [AD33] | RSVR [AD34] | SGND [6] | SV _{DD} [5] | AD |
| VDD _CA_PL [105] | GND [182] | VDD _CA_PL [106] | GND [194] | VDD _CA_PL [107] | GND [216] | VDD _CA_PL [108] | GND [106] | GND [97] | | NC [AE29] | XV _{DD} [6] | SD_TX [16] | SD_TX [16] | SV _{DD} [6] | SGND [7] | AVDD_ SRDS3 | AGND_ SRDS3 | AE |
| GND [171] | VDD _CA_PL [112] | GND [186] | VDD _CA_PL [113] | GND [201] | VDD _CA_PL [114] | GND [217] | NC [AF26] | NC [AF27] | NC [AF28] | NC [AF29] | SD_IMP_ CAL_TX | XV _{DD} [7] | XGND [7] | SD_RX [16] | SD_RX [16] | SV _{DD} [7] | SGND [8] | AF |
| DMA2_ DACK [0] | GPIO [7] | OV _{DD} [7] | SDHC _DAT[3] | SDHC _CMD | CV _{DD} [3] | RSRV [AG25] | NC [AG26] | NC [AG27] | NC [AG28] | NC [AG29] | XGND [8] | SD_TX [17] | SD_TX [17] | SGND [9] | SV _{DD} [8] | SD_RX [17] | SD_RX [17] | AG |
| IO_ VSEL [4] | MSRCID [0] | GPIO [4] | GND [89] | UART2_ CTS | USB1_ AGND | USB1_ VDD_ 1P0 | USB2_ VDD_ 1P0 | USB2_ AGND | SPI_ MISO | RSRV [AH29] | NC [AH30] | XGND [38] | XV _{DD} [34] | SGND [32] | GND [102] | SGND [31] | SV _{DD} [30] | AH |
| MSRCID [1] | DMA2_ DREQ [0] | GPIO [5] | UART2_ SOUT | OV _{DD} [10] | USB1_ AGND | USB1_ VDD_ 3P3 | USB2_ VDD_ 3P3 | USB2_ VDD_ 3P3 | SPI_CS [1] | CV _{DD} [1] | EMI2_ MDIO | EC_XTRNL _TX_STMP [2] | GND [100] | EMI1_ MDC | TSEC_ 1588_PULSI _OUT[2] | LV _{DD} | TSEC_ 1588_ALARM _OUT[1] | AJ |
| GND [84] | CLK_ OUT | GPIO [6] | GPIO [1] | UART2_ RTS | USB1_ UID | USB1_ VBUS_ CLMP | USB2_ VBUS_ CLMP | USB2_ UID | GND [96] | SPI_ CLK | EMI2_ MDC | EC_XTRNL | EC_XTRNL _RX_STMP [1] | LV _{DD} [1] | EC1_ GTX_ CLK125 | TSEC_ 1588_ALARM _OUT[2] | TSEC_ 11588_TRIG _IN[2] | AK |
| DMA1_ DACK [0] | OV _{DD} [8] | GPIO [0] | UART1_ SOUT | SHDC_ CLK | USB1_ VDD_ 3P3 | USB1_ AGND | USB1_ VDD_1P8 _DECAP | USB2_ VDD_1P8 _DECAP | USB2_ AGND | GND [91] | TSEC_ 1588_PULS _OUT[1] | IVDD | EMI1_ MDIO | EC2_ GTX_ CLK125 | GND [104] | TSEC_ 1588_CLK _IN | TSEC_ 1588_TRIG _IN[1] | AL |
| CKSTP_ OUT | GPIO [2] | GND [90] | UART1_ RTS | SDHC_ DAT [2] | USB_ CLKIN | USB1_ AGND | USB1_ IBIAS_ REXT | USB2_ IBIAS_ REXT | USB2_ AGND | SPI_CS [3] | TSEC_ 1588_CLK_ OUT | EC_XTRNL TX_STMP [1] | GND [105] | EC1_ RXD [3] | EC1_ RX_DV | LV _{DD} [7] | EC1_ RX_CLK | AM |
| TMP_ DETECT | GPIO [3] | DMA1_ DDONE [0] | OV _{DD} [1] | UART2_ SIN | RTC | USB2_ AGND | USB2_ AGND | USB2_ AGND | USB2_ AGND | SPI_CS [0] | GND [101] | EC2_ GTX_CLK | EC2_ RXD [2] | LV _{DD} [4] | EC1_ RXD [2] | EC1_ RXD [1] | EC1_ RXD [0] | AN |
| GND [88] | DMA2_ DDONE [0] | DMA1_ DREQ [0] | UART1_ CTS | GND [94] | SDHC _DAT [0] | USB2_ AGND | USB2_ UDM | USB2_ UDP | USB2_ AGND | CV _{DD} [2] | EC2_ TXD [2] | LV _{DD} [2] | EC2_ RXD [1] | EC2_ RXD [3] | GND [99] | EC1_ GTX_ CLK | EC1_ TXD [3] | AP |
| TRST | TMS | ASLEEP | тск | UART1_ SIN | OV _{DD} [12] | USB1_ AGND | USB1_ AGND | USB1_ AGND | USB1_ AGND | SPI_CS [2] | EC2_ TXD [1] | EC2_ TX_EN | GND [95] | EC2_ RX_ DV | EC1_ TXD [1] | LV _{DD} [6] | EC1_ TX_EN | AR |
| RSRV [AT19] | AVDD_ PLAT | TEST SEL_ | GND [93] | SYSCLK | SDHC _DAT [1] | USB1_ AGND | USB1_ UDM | USB1_ UDP | USB1_ AGND | SPI_ MOSI | EC2_ TXD [0] | EC2_ TXD [3] | EC2_ RXD [0] | EC2_ RX_ CLK | EC1_ TXD [2] | EC1_ TXD [0] | GND [103] | AT |
| 19 | 20 | 21 | 22 | 23 | 24 | 25 | 26 | 27 | 28 | 29 | 30 | 31 | 32 | 33 | 34 | 35 | 36 | |
| | | | | Fi | gure (| 6. 1295 | 5 BGA | Ball | Map D | iagra | m (De | tail Vi | ew D) | | | | | |

1.2 Pinout List

This table provides the pinout listing for the 1295 FC-PBGA package by bus.

Table 1. Pins List by Bus

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|----------------------------|-----------------------|-------------|-------------------------|-------|
| | DDR SDRAM Memory Interface | | 11 | | |
| MDQ00 | Data | A17 | I/O | GV _{DD} | — |
| MDQ01 | Data | D17 | I/O | GV_{DD} | — |
| MDQ02 | Data | C14 | I/O | GV_{DD} | — |
| MDQ03 | Data | A14 | I/O | GV_{DD} | — |
| MDQ04 | Data | C17 | I/O | GV_{DD} | - |
| MDQ05 | Data | B17 | I/O | GV _{DD} | — |
| MDQ06 | Data | A15 | I/O | GV _{DD} | — |
| MDQ07 | Data | B15 | I/O | GV _{DD} | — |
| MDQ08 | Data | D15 | I/O | GV _{DD} | — |
| MDQ09 | Data | G15 | I/O | GV _{DD} | - |
| MDQ10 | Data | E12 | I/O | GV _{DD} | |
| MDQ11 | Data | G12 | I/O | GV _{DD} | |
| MDQ12 | Data | F16 | I/O | GV _{DD} | — |
| MDQ13 | Data | E15 | I/O | GV _{DD} | |
| MDQ14 | Data | E13 | I/O | GV _{DD} | |
| MDQ15 | Data | F13 | I/O | GV _{DD} | — |
| MDQ16 | Data | C8 | I/O | GV _{DD} | — |
| MDQ17 | Data | D12 | I/O | GV _{DD} | — |
| MDQ18 | Data | E9 | I/O | GV _{DD} | — |
| MDQ19 | Data | E10 | I/O | GV_{DD} | - |
| MDQ20 | Data | C11 | I/O | GV_{DD} | — |
| MDQ21 | Data | C10 | I/O | GV_{DD} | — |
| MDQ22 | Data | E6 | I/O | GV_{DD} | - |
| MDQ23 | Data | E7 | I/O | GV _{DD} | — |
| MDQ24 | Data | F7 | I/O | GV _{DD} | - |
| MDQ25 | Data | F11 | I/O | GV _{DD} | — |
| MDQ26 | Data | H10 | I/O | GV _{DD} | — |
| MDQ27 | Data | J10 | I/O | GV _{DD} | — |
| MDQ28 | Data | F10 | I/O | GV _{DD} | — |
| MDQ29 | Data | F8 | I/O | GV _{DD} | — |
| MDQ30 | Data | H7 | I/O | GV _{DD} | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|-----------------------|-----------------------|-------------|-------------------------|----------|
| MDQ31 | Data | H9 | I/O | GV _{DD} | — |
| MDQ32 | Data | AC7 | I/O | GV_{DD} | — |
| MDQ33 | Data | AC6 | I/O | GV_{DD} | — |
| MDQ34 | Data | AF6 | I/O | GV_{DD} | — |
| MDQ35 | Data | AF7 | I/O | GV_{DD} | — |
| MDQ36 | Data | AB5 | I/O | GV_{DD} | — |
| MDQ37 | Data | AB6 | I/O | GV_{DD} | — |
| MDQ38 | Data | AE5 | I/O | GV_{DD} | — |
| MDQ39 | Data | AE6 | I/O | GV_{DD} | — |
| MDQ40 | Data | AG5 | I/O | GV _{DD} | — |
| MDQ41 | Data | AH9 | I/O | GV _{DD} | — |
| MDQ42 | Data | AJ9 | I/O | GV_{DD} | — |
| MDQ43 | Data | AJ10 | I/O | GV _{DD} | _ |
| MDQ44 | Data | AG8 | I/O | GV_{DD} | — |
| MDQ45 | Data | AG7 | I/O | GV_{DD} | — |
| MDQ46 | Data | AJ6 | I/O | GV _{DD} | — |
| MDQ47 | Data | AJ7 | I/O | GV_{DD} | — |
| MDQ48 | Data | AL9 | I/O | GV_{DD} | — |
| MDQ49 | Data | AL8 | I/O | GV _{DD} | — |
| MDQ50 | Data | AN10 | I/O | GV _{DD} | — |
| MDQ51 | Data | AN11 | I/O | GV_{DD} | — |
| MDQ52 | Data | AK8 | I/O | GV _{DD} | — |
| MDQ53 | Data | AK7 | I/O | GV_{DD} | — |
| MDQ54 | Data | AN7 | I/O | GV_{DD} | — |
| MDQ55 | Data | AN8 | I/O | GV_{DD} | — |
| MDQ56 | Data | AT9 | I/O | GV_{DD} | — |
| MDQ57 | Data | AR10 | I/O | GV_{DD} | — |
| MDQ58 | Data | AT13 | I/O | GV_{DD} | — |
| MDQ59 | Data | AR13 | I/O | GV_{DD} | — |
| MDQ60 | Data | AP9 | I/O | GV _{DD} | — |
| MDQ61 | Data | AR9 | I/O | GV _{DD} | — |
| MDQ62 | Data | AR12 | I/O | GV _{DD} | — |
| MDQ63 | Data | AP12 | I/O | GV _{DD} | — |
| MECC0 | Error Correcting Code | K9 | I/O | GV _{DD} | <u> </u> |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------|-----------------------|-----------------------|-------------|-----------------------------|-------|
| MECC1 | Error Correcting Code | J5 | I/O | GV _{DD} | - |
| MECC2 | Error Correcting Code | L10 | I/O | GV _{DD} | _ |
| MECC3 | Error Correcting Code | M10 | I/O | GV _{DD} | _ |
| MECC4 | Error Correcting Code | J8 | I/O | GV _{DD} | _ |
| MECC5 | Error Correcting Code | J7 | I/O | GV _{DD} | _ |
| MECC6 | Error Correcting Code | L7 | I/O | GV _{DD} | _ |
| MECC7 | Error Correcting Code | L9 | I/O | GV _{DD} | _ |
| MAPAR_ERR | Address Parity Error | N8 | Ι | GV _{DD} | 4 |
| MAPAR_OUT | Address Parity Out | Y7 | 0 | GV _{DD} | _ |
| MDM0 | Data Mask | A16 | 0 | GV _{DD} | — |
| MDM1 | Data Mask | D14 | 0 | GV _{DD} | _ |
| MDM2 | Data Mask | D11 | 0 | GV _{DD} | — |
| MDM3 | Data Mask | G11 | 0 | GV _{DD} | — |
| MDM4 | Data Mask | AD7 | 0 | GV_{DD} | — |
| MDM5 | Data Mask | AH8 | 0 | GV_{DD} | — |
| MDM6 | Data Mask | AL11 | 0 | GV_{DD} | — |
| MDM7 | Data Mask | AT10 | 0 | GV_{DD} | — |
| MDM8 | Data Mask | K8 | 0 | GV_{DD} | — |
| MDQS0 | Data Strobe | C16 | I/O | GV_{DD} | — |
| MDQS1 | Data Strobe | G14 | I/O | GV_{DD} | — |
| MDQS2 | Data Strobe | D9 | I/O | GV_{DD} | — |
| MDQS3 | Data Strobe | G9 | I/O | GV_{DD} | — |
| MDQS4 | Data Strobe | AD5 | I/O | GV_{DD} | — |
| MDQS5 | Data Strobe | AH6 | I/O | GV_DD | _ |
| MDQS6 | Data Strobe | AM10 | I/O | $\mathrm{GV}_{\mathrm{DD}}$ | — |
| MDQS7 | Data Strobe | AT12 | I/O | GV_{DD} | — |
| MDQS8 | Data Strobe | K6 | I/O | $\mathrm{GV}_{\mathrm{DD}}$ | _ |
| MDQS0 | Data Strobe | B16 | I/O | GV_DD | — |
| MDQS1 | Data Strobe | F14 | I/O | GV_DD | _ |
| MDQS2 | Data Strobe | D8 | I/O | $\mathrm{GV}_{\mathrm{DD}}$ | - |
| MDQS3 | Data Strobe | G8 | I/O | GV _{DD} | - |
| MDQS4 | Data Strobe | AD4 | I/O | GV _{DD} | — |
| MDQS5 | Data Strobe | AH5 | I/O | GV_DD | - |
| MDQS6 | Data Strobe | AM9 | I/O | GV_{DD} | — |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|-----------------------|-----------------------|-------------|-------------------------|-------|
| MDQS7 | Data Strobe | AT11 | I/O | GV _{DD} | _ |
| MDQS8 | Data Strobe | K5 | I/O | GV _{DD} | _ |
| MBA0 | Bank Select | AA8 | 0 | GV_{DD} | — |
| MBA1 | Bank Select | Y10 | 0 | GV _{DD} | — |
| MBA2 | Bank Select | M8 | 0 | GV _{DD} | — |
| MA00 | Address | Y9 | 0 | GV_{DD} | — |
| MA01 | Address | U6 | 0 | GV _{DD} | — |
| MA02 | Address | U7 | 0 | GV _{DD} | _ |
| MA03 | Address | U9 | 0 | GV _{DD} | _ |
| MA04 | Address | U10 | 0 | GV _{DD} | _ |
| MA05 | Address | Т8 | 0 | GV _{DD} | _ |
| MA06 | Address | Т9 | 0 | GV _{DD} | _ |
| MA07 | Address | R8 | 0 | GV _{DD} | |
| MA08 | Address | R7 | 0 | GV _{DD} | _ |
| MA09 | Address | P6 | 0 | GV _{DD} | _ |
| MA10 | Address | AA7 | 0 | GV _{DD} | |
| MA11 | Address | P7 | 0 | GV _{DD} | _ |
| MA12 | Address | N6 | 0 | GV _{DD} | — |
| MA13 | Address | AE8 | 0 | GV _{DD} | _ |
| MA14 | Address | M7 | 0 | GV _{DD} | _ |
| MA15 | Address | L6 | 0 | GV _{DD} | _ |
| MWE | Write Enable | AB8 | 0 | GV _{DD} | _ |
| MRAS | Row Address Strobe | AA10 | 0 | GV _{DD} | |
| MCAS | Column Address Strobe | AC10 | 0 | GV _{DD} | _ |
| MCS0 | Chip Select | AC9 | 0 | GV _{DD} | _ |
| MCS1 | Chip Select | AE9 | 0 | GV _{DD} | _ |
| MCS2 | Chip Select | AB9 | 0 | GV _{DD} | |
| MCS3 | Chip Select | AF9 | 0 | GV _{DD} | |
| MCKE0 | Clock Enable | P10 | 0 | GV _{DD} | _ |
| MCKE1 | Clock Enable | R10 | 0 | GV _{DD} | _ |
| MCKE2 | Clock Enable | P9 | 0 | GV _{DD} | - 1 |
| MCKE3 | Clock Enable | N9 | 0 | GV _{DD} | - |
| MCK0 | Clock | W6 | 0 | GV _{DD} | _ |
| MCK1 | Clock | V6 | 0 | GV _{DD} | |

| Table 1 | Pins | l ist | hv | Bus (| (continued) |
|---------|----------|-------|-----|-------|-------------|
| | F 1113 1 | LISU | IJУ | Dus | (continueu) |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------------------|-----------------------|-------------|-------------------------|-------|
| MCK2 | Clock | V8 | 0 | GV _{DD} | - |
| МСКЗ | Clock | W9 | 0 | GV_{DD} | — |
| МСКО | Clock complements | W5 | 0 | GV_{DD} | — |
| MCK1 | Clock complements | V5 | 0 | GV_{DD} | — |
| MCK2 | Clock complements | V9 | 0 | GV_{DD} | — |
| МСКЗ | Clock complements | W8 | 0 | GV_{DD} | — |
| MODT0 | On-die termination | AD10 | 0 | GV_{DD} | — |
| MODT1 | On-die termination | AG10 | 0 | GV _{DD} | — |
| MODT2 | On-die termination | AD8 | 0 | GV_{DD} | — |
| MODT3 | On-die termination | AF10 | 0 | GV_{DD} | — |
| MDIC0 | Driver impedance calibration | T6 | I/O | GV_{DD} | 16 |
| MDIC1 | Driver impedance calibration | AA5 | I/O | GV_{DD} | 16 |
| | Local Bus Controller Interface | e | I I | | |
| LAD00 | Muxed data/address | K26 | I/O | BV _{DD} | 3 |
| LAD01 | Muxed data/address | L26 | I/O | BV _{DD} | 3 |
| LAD02 | Muxed data/address | J26 | I/O | BV _{DD} | 3 |
| LAD03 | Muxed data/address | H25 | I/O | BV _{DD} | 3 |
| LAD04 | Muxed data/address | F25 | I/O | BV _{DD} | 3 |
| LAD05 | Muxed data/address | H24 | I/O | BV_DD | 3 |
| LAD06 | Muxed data/address | G24 | I/O | BV _{DD} | 3 |
| LAD07 | Muxed data/address | G23 | I/O | BV _{DD} | 3 |
| LAD08 | Muxed data/address | E23 | I/O | BV_DD | 3 |
| LAD09 | Muxed data/address | D23 | I/O | BV_DD | 3 |
| LAD10 | Muxed data/address | J22 | I/O | BV_DD | 3 |
| LAD11 | Muxed data/address | G22 | I/O | BV_DD | 3 |
| LAD12 | Muxed data/address | F19 | I/O | BV_DD | 3 |
| LAD13 | Muxed data/address | J18 | I/O | BV_DD | 3 |
| LAD14 | Muxed data/address | K18 | I/O | BV_DD | 3 |
| LAD15 | Muxed data/address | J17 | I/O | BV_DD | 3 |
| LAD16 | Muxed data/address | J25 | I/O | BV_DD | 35 |
| LAD17 | Muxed data/address | G25 | I/O | BV_DD | 35 |
| LAD18 | Muxed data/address | H23 | I/O | BV_DD | 35 |
| LAD19 | Muxed data/address | F22 | I/O | BV _{DD} | 35 |
| LAD20 | Muxed data/address | H22 | I/O | BV_DD | 35 |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|----------------------|-----------------------|-------------|------------------|-------|
| LAD21 | Muxed data/address | E21 | I/O | BV _{DD} | 35 |
| LAD22 | Muxed data/address | F21 | I/O | BV _{DD} | 35 |
| LAD23 | Muxed data/address | H21 | I/O | BV _{DD} | 3 |
| LAD24 | Muxed data/address | K21 | I/O | BV _{DD} | 3 |
| LAD25 | Muxed data/address | G20 | I/O | BV _{DD} | 35 |
| LAD26 | Muxed data/address | J20 | I/O | BV_DD | 3,32 |
| LAD27 | Muxed data/address | D26 | I/O | BV_DD | — |
| LAD28 | Muxed data/address | E18 | I/O | BV _{DD} | - |
| LAD29 | Muxed data/address | F18 | I/O | BV _{DD} | - |
| LAD30 | Muxed data/address | J15 | I/O | BV _{DD} | |
| LAD31 | Muxed data/address | F17 | I/O | BV _{DD} | _ |
| LDP0 | Data parity | J24 | I/O | BV _{DD} | _ |
| LDP1 | Data parity | K23 | I/O | BV _{DD} | — |
| LDP2 | Data parity | H17 | I/O | BV _{DD} | _ |
| LDP3 | Data parity | H16 | I/O | BV _{DD} | _ |
| LA27 | Non-muxed address | K20 | 0 | BV _{DD} | |
| LA28 | Non-muxed address | G19 | 0 | BV _{DD} | 35 |
| LA29 | Non-muxed Address | H19 | 0 | BV _{DD} | 35 |
| LA30 | Non-muxed Address | J19 | 0 | BV _{DD} | 35 |
| LA31 | Non-muxed Address | G18 | 0 | BV _{DD} | 35 |
| LCS0 | Chip selects | D19 | 0 | BV _{DD} | 5 |
| LCS1 | Chip selects | D20 | 0 | BV _{DD} | 5 |
| LCS2 | Chip selects | E20 | 0 | BV _{DD} | 5 |
| LCS3 | Chip selects | D21 | 0 | BV _{DD} | 5 |
| LCS4 | Chip selects | D22 | 0 | BV _{DD} | 5 |
| LCS5 | Chip selects | B23 | 0 | BV _{DD} | 5 |
| LCS6 | Chip selects | F24 | 0 | BV _{DD} | 5 |
| LCS7 | Chip selects | G26 | 0 | BV_DD | 5 |
| LWE0 | Write enable | D24 | 0 | BV _{DD} | — |
| LWE1 | Write enable | A24 | 0 | BV _{DD} | - |
| LWE2 | Write enable | J16 | 0 | BV _{DD} | - |
| LWE3 | Write enable | K15 | 0 | BV _{DD} | - |
| LBCTL | Buffer control | C22 | 0 | BV _{DD} | - |
| LALE | Address latch enable | A23 | I/O | BV _{DD} | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes | | | |
|-------------------------------|--|-----------------------|-------------|-------------------------------------|-------|--|--|--|
| LGPL0/LFCLE | UPM general purpose line 0/ LFCLE—FCM | B25 | 0 | BV _{DD} | 3, 4 | | | |
| LGPL1/LFALE | UPM general purpose line 1/ LFALE—FCM | E25 | 0 | BV _{DD} | 3, 4 | | | |
| LGPL2/LOE/LFRE | UPM general purpose line 2/ LOE_B—Output Enable | D25 | 0 | BV _{DD} | 3, 4 | | | |
| LGPL3/LFWP | UPM general purpose line 3/ LFWP_B—FCM | H26 | 0 | BV _{DD} | 3, 4 | | | |
| LGPL4/LGTA/LUPWAIT/LPBSE | UPM general purpose line 4/ LGTA_B—FCM | C25 | I/O | BV _{DD} | 40 | | | |
| LGPL5 | UPM general purpose line 5/Amux | E26 | 0 | BV _{DD} | 3, 4 | | | |
| LCLK0 | Local Bus Clock | C24 | 0 | BV _{DD} | _ | | | |
| LCLK1 | Local Bus Clock | C23 | 0 | BV _{DD} | | | | |
| | DMA | 1 | | | | | | |
| DMA1_DREQ0/GPIO18 | DMA1 channel 0 request | AP21 | Ι | OV _{DD} | 26 | | | |
| DMA1_DACK0/GPIO19 | DMA1 channel 0 acknowledge | AL19 | 0 | OV _{DD} | 26 | | | |
| DMA1_DDONE0 | DMA1 channel 0 done | AN21 | 0 | OV _{DD} | 27 | | | |
| DMA2_DREQ0/GPIO20/ALT_MDVAL | DMA2 channel 0 request | AJ20 | I | OV _{DD} | 26 | | | |
| DMA2_DACK0/EVT7/ALT_MDSRCID0 | DMA2 channel 0 acknowledge | AG19 | 0 | OV _{DD} | 26 | | | |
| DMA2_DDONE0/EVT8/ALT_MDSRCID1 | DMA2 channel 0 done | AP20 | 0 | OV _{DD} | 26 | | | |
| | USB Host Port 1 | | | | | | | |
| USB1_UDP | USB1 PHY data plus | AT27 | I/O | USB_V _{DD} _3P3 | _ | | | |
| USB1_UDM | USB1 PHY data minus | AT26 | I/O | USB_V _{DD} _3P3 | | | | |
| USB1_VBUS_CLMP | USB1 PHY VBUS divided signals | AK25 | I | USB_V _{DD} _3P3 | 38 | | | |
| USB1_UID | USB1 PHY ID detect | AK24 | I | USB1_V _{DD} _1P8 _DECAP | | | | |
| USB_CLKIN | USB PHY clock input | AM24 | I | OV _{DD} | _ | | | |
| USB1_DRVVBUS/GPIO4 | USB1 5V supply enable | AH21 | 0 | OV _{DD} | _ | | | |
| USB1_PWRFAULT/GPIO5 | USB1 Power fault | AJ21 | I | OV _{DD} | _ | | | |
| | USB Host Port 2 | | | | | | | |
| USB2_UDP | USB2 PHY data plus | AP27 | I/O | USB_V _{DD} _3P3 | _ | | | |
| USB2_UDM | USB2 PHY data minus | AP26 | I/O | USB_V _{DD} _3P3 | — | | | |
| USB2_VBUS_CLMP | USB2 PHY VBUS divided signals | AK26 | Ι | USB_V _{DD} _3P3 | 38 | | | |
| USB2_UID | USB2 PHY ID detect | AK27 | I | USB2_V _{DD} _1P8 _DECAP | — | | | |
| USB2_DRVVBUS/GPIO6 | USB2 5V supply enable | AK21 | 0 | OV _{DD} | | | | |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-------------------------|-------------------------------|-----------------------|-------------|------------------|--------------|
| USB2_PWRFAULT/GPIO7 | USB2 Power Fault | AG20 | I | OV _{DD} | _ |
| | Programmable Interrupt Contro | ller | | | |
| IRQ00 | External Interrupts | AJ16 | I | OV _{DD} | _ |
| IRQ01 | External Interrupts | AH16 | Ι | OV _{DD} | — |
| IRQ02 | External Interrupts | AK12 | I | OV _{DD} | — |
| IRQ03/GPIO21 | External Interrupts | AJ15 | Ι | OV _{DD} | 26 |
| IRQ04/GPIO22 | External Interrupts | AH17 | Ι | OV_{DD} | 26 |
| IRQ05/GPIO23 | External Interrupts | AJ13 | Ι | OV _{DD} | 26 |
| IRQ06/GPIO24 | External Interrupts | AG17 | Ι | OV _{DD} | 26 |
| IRQ07/GPIO25 | External Interrupts | AM13 | I | OV _{DD} | 26 |
| IRQ08/GPIO26 | External Interrupts | AG13 | Ι | OV _{DD} | 26 |
| IRQ09/GPIO27 | External Interrupts | AK11 | Ι | OV _{DD} | 26 |
| IRQ10/GPIO28 | External Interrupts | AH14 | I | OV _{DD} | 26 |
| IRQ11/GPIO29 | External Interrupts | AL12 | Ι | OV _{DD} | 26 |
| IRQ_OUT/EVT9 | Interrupt Output | AK14 | 0 | OV _{DD} | 1, 2, 26 |
| | Trust | | 11 | | 1 |
| TMP_DETECT | Tamper detect | AN19 | I | OV_{DD} | 27 |
| LP_TMP_DETECT | Low power tamper detect | AE28 | I | $V_{DD_{LP}}$ | 27 |
| | eSDHC | | | | |
| SDHC_CMD | Command/response | AG23 | I/O | CV _{DD} | _ |
| SDHC_DAT0 | Data | AP24 | I/O | CV_{DD} | — |
| SDHC_DAT1 | Data | AT24 | I/O | CV _{DD} | — |
| SDHC_DAT2 | Data | AM23 | I/O | CV_{DD} | — |
| SDHC_DAT3 | Data | AG22 | I/O | OV_{DD} | — |
| SDHC_DAT4/SPI_CS0 | Data | AN29 | 0 | CV _{DD} | 26, 31 |
| SDHC_DAT5/SPI_CS1 | Data | AJ28 | 0 | CV _{DD} | 26, 31 |
| SDHC_DAT6/SPI_CS2 | Data | AR29 | 0 | CV _{DD} | 26, 31 |
| SDHC_DAT7/SPI_CS3 | Data | AM29 | 0 | CV _{DD} | 26, 31 |
| SDHC_CLK | Host to card clock | AL23 | 0 | CV _{DD} | _ |
| SDHC_CD/IIC3_SCL/GPIO16 | Card detection | AK13 | I | OV_{DD} | 26, 27,31 |
| SDHC_WP/IIC3_SDA/GPIO17 | Card write protection | AM14 | Ι | OV _{DD} | 26, 27,31 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|---|---------------------------------|-----------------------|-------------|------------------|--------------|
| | eSPI | | | | • |
| SPI_MOSI | Master out slave in | AT29 | I/O | CV _{DD} | — |
| SPI_MISO | Master in slave out | AH28 | Ι | CV _{DD} | - |
| SPI_CLK | eSPI clock | AK29 | 0 | CV _{DD} | - |
| SPI_CS0/SDHC_DAT4 | eSPI chip select | AN29 | 0 | CV_{DD} | 26 |
| SPI_CS1/SDHC_DAT5 | eSPI chip select | AJ28 | 0 | CV _{DD} | 26 |
| SPI_CS2/SDHC_DAT6 | eSPI chip select | AR29 | 0 | CV _{DD} | 26 |
| SPI_CS3/SDHC_DAT7 | eSPI chip select | AM29 | 0 | CV_{DD} | 26 |
| | IEEE 1588 | | | | |
| TSEC_1588_CLK_IN | Clock in | AL35 | I | LV _{DD} | — |
| TSEC_1588_TRIG_IN1 | Trigger in 1 | AL36 | I | LV _{DD} | - |
| TSEC_1588_TRIG_IN2/EC1_RX_ER | Trigger in 2 | AK36 | I | LV _{DD} | - |
| TSEC_1588_ALARM_OUT1 | Alarm out 1 | AJ36 | 0 | LV _{DD} | - |
| TSEC_1588_ALARM_OUT2/EC1_COL/G PIO30 | Alarm out 2 | AK35 | 0 | LV _{DD} | 26 |
| TSEC_1588_CLK_OUT | Clock out | AM30 | 0 | LV _{DD} | — |
| TSEC_1588_PULSE_OUT1 | Pulse out1 | AL30 | 0 | LV _{DD} | - |
| TSEC_1588_PULSE_OUT2/EC1_CRS/GP IO31 | Pulse out2 | AJ34 | 0 | LV _{DD} | 26 |
| | Ethernet Management Interface 1 | | | | |
| EMI1_MDC | Management data clock | AJ33 | 0 | LV _{DD} | — |
| EMI1_MDIO | Management data in/out | AL32 | I/O | LV _{DD} | _ |
| | Ethernet Management Interface 2 | | | | |
| EMI2_MDC | Management data clock | AK30 | 0 | 1.2 V | 2, 18, 22 |
| EMI2_MDIO | Management data in/out | AJ30 | I/O | 1.2 V | 2, 18, 22 |
| | Ethernet Reference Clock | | | | |
| EC1_GTX_CLK125 | Reference clock (RGMII) | AK34 | Ι | LV _{DD} | 27 |
| EC2_GTX_CLK125 | Reference clock (RGMII) | AL33 | Ι | LV _{DD} | 27 |
| | Ethernet External Timestamping | 1 | II | | 1 |
| EC_XTRNL_TX_STMP1 | External timestamp transmit 1 | AM31 | Ι | LV _{DD} | _ |
| EC_XTRNL_RX_STMP1 | External timestamp receive 1 | AK32 | I | LV _{DD} | _ |
| EC_XTRNL_TX_STMP2 | External timestamp transmit 2 | AJ31 | I | LV _{DD} | - |
| l | 1 | 1 | 1 | | 1 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------------------------|--------------------------------|-----------------------|-------------|------------------|--------|
| EC_XTRNL_RX_STMP2 | External timestamp receive 2 | AK31 | I | LV _{DD} | — |
| | Three-Speed Ethernet Controlle | er 1 | | | • |
| EC1_TXD3 | Transmit data | AP36 | 0 | LV _{DD} | - |
| EC1_TXD2 | Transmit data | AT34 | 0 | LV _{DD} | — |
| EC1_TXD1 | Transmit data | AR34 | 0 | LV _{DD} | — |
| EC1_TXD0 | Transmit data | AT35 | 0 | LV _{DD} | — |
| EC1_TX_EN | Transmit enable | AR36 | 0 | LV _{DD} | 15 |
| EC1_GTX_CLK | Transmit clock out (RGMII) | AP35 | 0 | LV _{DD} | 26 |
| EC1_RXD3 | Receive data | AM33 | Ι | LV _{DD} | 27 |
| EC1_RXD2 | Receive data | AN34 | I | LV _{DD} | 27 |
| EC1_RXD1 | Receive data | AN35 | Ι | LV _{DD} | 27 |
| EC1_RXD0 | Receive data | AN36 | Ι | LV _{DD} | 27 |
| EC1_RX_DV | Receive data valid | AM34 | Ι | LV _{DD} | 27 |
| EC1_RX_CLK | Receive clock | AM36 | Ι | LV _{DD} | 27 |
| TSEC_1588_TRIG_IN2 | Trig In 1 | AK36 | Ι | LV _{DD} | — |
| TSEC_1588_ALARM_OUT2 | 1588 alarm out 2 | AK35 | 0 | LV _{DD} | 26 |
| GPIO31/TSEC_1588_PULSE_OUT2 | Pulse out 2 | AJ34 | 0 | LV _{DD} | 26 |
| | Three-Speed Ethernet Controlle | er 2 | | | • |
| EC2_TXD3 | Transmit data | AT31 | 0 | LV _{DD} | - |
| EC2_TXD2 | Transmit data | AP30 | 0 | LV _{DD} | _ |
| EC2_TXD1 | Transmit data | AR30 | 0 | LV _{DD} | — |
| EC2_TXD0 | Transmit data | AT30 | 0 | LV _{DD} | — |
| EC2_TX_EN | Transmit enable | AR31 | 0 | LV _{DD} | 15 |
| EC2_GTX_CLK | Transmit clock out (RGMII) | AN31 | 0 | LV _{DD} | 26 |
| EC2_RXD3 | Receive data | AP33 | Ι | LV _{DD} | 27 |
| EC2_RXD2 | Receive data | AN32 | Ι | LV _{DD} | 27 |
| EC2_RXD1 | Receive data | AP32 | I | LV _{DD} | 26, 27 |
| EC2_RXD0 | Receive data | AT32 | Ι | LV _{DD} | 26, 27 |
| EC2_RX_DV | Receive data valid | AR33 | 1 | LV _{DD} | 27 |
| EC2_RX_CLK | Receive clock | AT33 | I | LV _{DD} | 27 |
| | UART | | | | |
| UART1_SOUT/GPIO8 | Transmit data | AL22 | 0 | OV _{DD} | 26 |
| UART2_SOUT/GPIO9 | Transmit data | AJ22 | 0 | OV _{DD} | 26 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------------------------|---------------------------------------|-----------------------|-------------|------------------|--------------|
| UART1_SIN/GPIO10 | Receive data | AR23 | Ι | OV _{DD} | 26 |
| UART2_SIN/GPIO11 | Receive data | AN23 | Ι | OV _{DD} | 26 |
| UART1_RTS/UART3_SOUT/GPIO12 | Ready to send | AM22 | 0 | OV _{DD} | 26 |
| UART2_RTS/UART4_SOUT/GPIO13 | Ready to send | AK23 | 0 | OV _{DD} | 26 |
| UART1_CTS/UART3_SIN/GPIO14 | Clear to send | AP22 | Ι | OV_{DD} | 26 |
| UART2_CTS/UART4_SIN/GPIO15 | Clear to send | AH23 | I | OV_{DD} | 26 |
| | I ² C Interface | | | | |
| IIC1_SCL | Serial clock | AH15 | I/O | OV _{DD} | 2, 14 |
| IIC1_SDA | Serial data | AN14 | I/O | OV _{DD} | 2, 14 |
| IIC2_SCL | Serial clock | AM15 | I/O | OV _{DD} | 2, 14 |
| IIC2_SDA | Serial data | AL14 | I/O | OV _{DD} | 2, 14 |
| IIC3_SCL/SDHC_CD/GPIO16 | Serial clock | AK13 | I/O | OV_{DD} | 2, 14, 27 |
| IIC3_SDA/SDHC_WP/GPIO17 | Serial data | AM14 | I/O | OV _{DD} | 2, 14, 27 |
| IIC4_SCL/EVT5 | Serial clock | AG14 | I/O | OV _{DD} | 2, 14 |
| IIC4_SDA/EVT6 | Serial data | AL15 | I/O | OV _{DD} | 2, 14 |
| SerDe | es (x18) PCIe, Serial RapidIO, Aurora | a, 10GE, 1GE | I | | - |
| SD_TX17 | Transmit data (positive) | AG31 | 0 | XV _{DD} | _ |
| SD_TX16 | Transmit data (positive) | AE31 | 0 | XV _{DD} | - |
| SD_TX15 | Transmit data (positive) | AB33 | 0 | XV _{DD} | - |
| SD_TX14 | Transmit data (positive) | AA31 | 0 | XV _{DD} | - |
| SD_TX13 | Transmit data (positive) | Y29 | 0 | XV _{DD} | — |
| SD_TX12 | Transmit data (positive) | W31 | 0 | XV _{DD} | _ |
| SD_TX11 | Transmit data (positive) | T30 | 0 | XV _{DD} | _ |
| SD_TX10 | Transmit data (positive) | P31 | 0 | XV _{DD} | _ |
| SD_TX09 | Transmit data (positive) | N33 | 0 | XV _{DD} | _ |
| SD_TX08 | Transmit data (positive) | M31 | 0 | XV _{DD} | _ |
| SD_TX07 | Transmit data (positive) | K31 | 0 | XV _{DD} | _ |
| SD_TX06 | Transmit data (positive) | J33 | 0 | XV _{DD} | 1 - |
| SD_TX05 | Transmit data (positive) | G33 | 0 | XV _{DD} | — |
| SD_TX04 | Transmit data (positive) | D34 | 0 | XV _{DD} | _ |
| SD_TX03 | Transmit data (positive) | F31 | 0 | XV _{DD} | - |
| SD_TX02 | Transmit data (positive) | H30 | 0 | XV _{DD} | _ |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|---------|--------------------------|-----------------------|-------------|------------------|-------|
| SD_TX01 | Transmit data (positive) | F29 | 0 | XV _{DD} | — |
| SD_TX00 | Transmit data (positive) | H28 | 0 | XV _{DD} | — |
| SD_TX17 | Transmit data (negative) | AG32 | 0 | XV _{DD} | — |
| SD_TX16 | Transmit data (negative) | AE32 | 0 | XV _{DD} | — |
| SD_TX15 | Transmit data (negative) | AB34 | 0 | XV _{DD} | — |
| SD_TX14 | Transmit data (negative) | AA32 | 0 | XV _{DD} | — |
| SD_TX13 | Transmit data (negative) | Y30 | 0 | XV _{DD} | — |
| SD_TX12 | Transmit data (negative) | W32 | 0 | XV _{DD} | — |
| SD_TX11 | Transmit data (negative) | T31 | 0 | XV _{DD} | — |
| SD_TX10 | Transmit data (negative) | P32 | 0 | XV _{DD} | |
| SD_TX09 | Transmit data (negative) | N34 | 0 | XV _{DD} | |
| SD_TX08 | Transmit data (negative) | M32 | 0 | XV _{DD} | |
| SD_TX07 | Transmit data (negative) | K32 | 0 | XV _{DD} | |
| SD_TX06 | Transmit data (negative) | J34 | 0 | XV _{DD} | |
| SD_TX05 | Transmit data (negative) | F33 | 0 | XV _{DD} | |
| SD_TX04 | Transmit data (negative) | E34 | 0 | XV _{DD} | |
| SD_TX03 | Transmit data (negative) | E31 | 0 | XV _{DD} | — |
| SD_TX02 | Transmit data (negative) | G30 | 0 | XV _{DD} | — |
| SD_TX01 | Transmit data (negative) | E29 | 0 | XV _{DD} | |
| SD_TX00 | Transmit data (negative) | G28 | 0 | XV _{DD} | — |
| SD_RX17 | Receive data (positive) | AG36 | I | XV _{DD} | — |
| SD_RX16 | Receive data (positive) | AF34 | Ι | XV _{DD} | — |
| SD_RX15 | Receive data (positive) | AC36 | I | XV _{DD} | — |
| SD_RX14 | Receive data (positive) | AA36 | Ι | XV _{DD} | — |
| SD_RX13 | Receive data (positive) | Y34 | Ι | XV _{DD} | — |
| SD_RX12 | Receive data (positive) | W36 | Ι | XV _{DD} | — |
| SD_RX11 | Receive data (positive) | T34 | Ι | XV _{DD} | — |
| SD_RX10 | Receive data (positive) | P36 | Ι | XV _{DD} | — |
| SD_RX09 | Receive data (positive) | M36 | I | XV _{DD} | — |
| SD_RX08 | Receive data (positive) | L34 | I | XV _{DD} | _ |
| SD_RX07 | Receive data (positive) | K36 | I | XV _{DD} | — |
| SD_RX06 | Receive data (positive) | H36 | I | XV _{DD} | _ |
| SD_RX05 | Receive data (positive) | F36 | Ι | XV _{DD} | _ |
| SD_RX04 | Receive data (positive) | D36 | Ι | XV _{DD} | _ |

| Table 1. | Pins | List by | Bus | (continued) |
|----------|------|---------|-----|-------------|
| | | | Buo | (continuou) |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-------------|---|-----------------------|-------------|------------------|-------|
| SD_RX03 | Receive data (positive) | A31 | I | XV _{DD} | _ |
| SD_RX02 | Receive data (positive) | C30 | I | XV _{DD} | - |
| SD_RX01 | Receive data (positive) | A29 | I | XV_{DD} | — |
| SD_RX00 | Receive data (positive) | C28 | I | XV _{DD} | — |
| SD_RX17 | Receive data (negative) | AG35 | I | XV _{DD} | _ |
| SD_RX16 | Receive data (negative) | AF33 | I | XV_{DD} | — |
| SD_RX15 | Receive data (negative) | AC35 | I | XV _{DD} | — |
| SD_RX14 | Receive data (negative) | AA35 | I | XV _{DD} | _ |
| SD_RX13 | Receive data (negative) | Y33 | I | XV _{DD} | _ |
| SD_RX12 | Receive data (negative) | W35 | I | XV _{DD} | — |
| SD_RX11 | Receive data (negative) | T33 | I | XV _{DD} | _ |
| SD_RX10 | Receive data (negative) | P35 | I | XV_{DD} | — |
| SD_RX09 | Receive data (negative) | M35 | I | XV _{DD} | — |
| SD_RX08 | Receive data (negative) | L33 | I | XV _{DD} | - |
| SD_RX07 | Receive data (negative) | K35 | I | XV _{DD} | - |
| SD_RX06 | Receive data (negative) | H35 | I | XV _{DD} | - |
| SD_RX05 | Receive data (negative) | F35 | I | XV _{DD} | - |
| SD_RX04 | Receive data (negative) | C36 | I | XV _{DD} | - |
| SD_RX03 | Receive data (negative) | B31 | I | XV _{DD} | _ |
| SD_RX02 | Receive data (negative) | D30 | I | XV _{DD} | _ |
| SD_RX01 | Receive data (negative) | B29 | I | XV_{DD} | — |
| SD_RX00 | Receive data (negative) | D28 | I | XV _{DD} | - |
| SD_REF_CLK1 | SerDes bank 1 PLL reference clock | A35 | I | XV _{DD} | _ |
| SD_REF_CLK1 | SerDes bank 1 PLL reference clock complement | B35 | I | XV_{DD} | - |
| SD_REF_CLK2 | SerDes bank 2 PLL reference clock | V34 | I | XV_{DD} | - |
| SD_REF_CLK2 | SerDes bank 2 PLL reference clock complement | V33 | I | XV _{DD} | _ |
| SD_REF_CLK3 | SerDes bank 3 PLL reference clock | AC32 | I | XV_{DD} | — |
| SD_REF_CLK3 | SerDes bank 3 PLL reference clock complement | AC31 | I | XV_{DD} | — |
| | General-Purpose Input/Output | · | ·1 | | |
| GPIO0 | General purpose input/output | AL21 | I/O | OV _{DD} | - |
| GPIO1 | General purpose input/output | AK22 | I/O | OV _{DD} | - |
| GPIO2 | General purpose input/output | AM20 | I/O | OV _{DD} | — |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------------------------|------------------------------|-----------------------|-------------|------------------|-------|
| GPIO3 | General purpose input/output | AN20 | I/O | OV _{DD} | _ |
| GPIO4/USB1_DRVVBUS | General purpose input/output | AH21 | I/O | OV _{DD} | _ |
| GPIO5/USB1_PWRFAULT | General purpose input/output | AJ21 | I/O | OV _{DD} | — |
| GPIO6/USB2_DRVVBUS | General purpose input/output | AK21 | I/O | OV _{DD} | — |
| GPIO7/USB2_PWRFAULT | General purpose input/output | AG20 | I/O | OV _{DD} | _ |
| GPIO8/UART1_SOUT | General purpose input/output | AL22 | I/O | OV _{DD} | — |
| GPIO9/UART2_SOUT | General purpose input/output | AJ22 | I/O | OV _{DD} | — |
| GPIO10/UART1_SIN | General purpose input/output | AR23 | I/O | OV _{DD} | — |
| GPIO11/UART2_SIN | General purpose input/output | AN23 | I/O | OV _{DD} | — |
| GPIO12/UART1_RTS/UART3_SOUT | General purpose input/output | AM22 | I/O | OV _{DD} | — |
| GPIO13/UART2_RTS/UART4_SOUT | General purpose input/output | AK23 | I/O | OV _{DD} | — |
| GPIO14/UART1_CTS/UART3_SIN | General purpose input/output | AP22 | I/O | OV_{DD} | — |
| GPIO15/UART2_CTS/UART4_SIN | General purpose input/output | AH23 | I/O | OV _{DD} | — |
| GPIO16/IIC3_SCL/SDHC_CD | General purpose input/output | AK13 | I/O | OV _{DD} | 27 |
| GPIO17/IIC3_SDA/SDHC_WP | General purpose input/output | AM14 | I/O | OV _{DD} | 27 |
| GPIO18/DMA1_DREQ0 | General purpose input/output | AP21 | I/O | OV _{DD} | — |
| GPIO19/DMA1_DACK0 | General purpose input/output | AL19 | I/O | OV _{DD} | — |
| GPIO20/DMA2_DREQ0/ALT_MDVAL | General purpose input/output | AJ20 | I/O | OV _{DD} | — |
| GPIO21/IRQ03 | General purpose input/output | AJ15 | I/O | OV _{DD} | — |
| GPIO22/IRQ04 | General purpose input/output | AH17 | I/O | OV _{DD} | — |
| GPIO23/IRQ05 | General purpose input/output | AJ13 | I/O | OV_{DD} | — |
| GPIO24/IRQ06 | General purpose input/output | AG17 | I/O | OV _{DD} | — |
| GPIO25/IRQ07 | General purpose input/output | AM13 | I/O | OV _{DD} | — |
| GPIO26/IRQ08 | General purpose input/output | AG13 | I/O | OV_{DD} | — |
| GPIO27/IRQ09 | General purpose input/output | AK11 | I/O | OV _{DD} | — |
| GPIO28/IRQ10 | General purpose input/output | AH14 | I/O | OV_{DD} | — |
| GPIO29/IRQ11 | General purpose input/output | AL12 | I/O | OV_{DD} | — |
| GPIO30/TSEC_1588_ALARM_OUT2 | General purpose input/output | AK35 | I/O | LV _{DD} | 25 |
| GPIO31/TSEC_1588_PULSE_OUT2 | General purpose input/output | AJ34 | I/O | LV _{DD} | 25 |
| | System Control | | | | 1 |
| PORESET | Power on reset | AP17 | I | OV _{DD} | _ |
| HRESET | Hard reset | AR17 | I/O | OV _{DD} | 1, 2 |
| RESET_REQ | Reset request | AT16 | 0 | OV _{DD} | 35 |
| CKSTP_OUT | Checkstop out | AM19 | 0 | OV _{DD} | 1, 2 |

| Table 1. | Pins | List by | v Bus | (continued) |
|----------|--------|---------|-------|-------------|
| | 1 1110 | LISCO | y Duo | (continued) |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|------------------------------|-----------------------------|-----------------------|-------------|------------------|--------|
| | Debug | | | | _ |
| EVTO | Event 0 | AJ17 | I/O | OV _{DD} | 20 |
| EVT1 | Event 1 | AK17 | I/O | OV _{DD} | — |
| EVT2 | Event 2 | AN16 | I/O | OV _{DD} | — |
| EVT3 | Event 3 | AK16 | I/O | OV _{DD} | — |
| EVT4 | Event 4 | AM16 | I/O | OV _{DD} | — |
| EVT5/IIC4_SCL | Event 5 | AG14 | I/O | OV _{DD} | — |
| EVT6/IIC4_SDA | Event 6 | AL15 | I/O | OV _{DD} | — |
| EVT7/DMA2_DACK0/ALT_MSRCID0 | Event 7 | AG19 | I/O | OV _{DD} | — |
| EVT8/DMA2_DDONE0/ALT_MSRCID1 | Event 8 | AP20 | I/O | OV _{DD} | — |
| EVT9/IRQ_OUT | Event 9 | AK14 | I/O | OV _{DD} | — |
| MDVAL | Debug data valid | AR15 | 0 | OV _{DD} | — |
| MSRCID0 | Debug source ID 0 | AH20 | 0 | OV _{DD} | 4, 35 |
| MSRCID1 | Debug source ID 1 | AJ19 | 0 | OV _{DD} | — |
| MSRCID2 | Debug source ID 2 | AH18 | 0 | OV _{DD} | — |
| ALT_MDVAL/DMA2_DREQ0/GPIO20 | Alternate debug data valid | AJ20 | 0 | OV _{DD} | 26 |
| ALT_MSRCID0/DMA2_DACK0/EVT7 | Alternate debug source ID 0 | AG19 | 0 | OV _{DD} | 26 |
| ALT_MSRCID1/DMA2_DDONE0/EVT8 | Alternate debug source ID 1 | AP20 | 0 | OV _{DD} | 26 |
| CLK_OUT | Clock out | AK20 | 0 | OV_{DD} | 6 |
| | Clock | | | | |
| RTC | Real time clock | AN24 | I | OV _{DD} | — |
| SYSCLK | System clock | AT23 | I | OV _{DD} | — |
| | JTAG | | | | _ |
| ТСК | Test clock | AR22 | I | OV _{DD} | — |
| TDI | Test data in | AN17 | I | OV _{DD} | 7 |
| TDO | Test data out | AP15 | 0 | OV _{DD} | 6 |
| TMS | Test mode select | AR20 | I | OV_{DD} | 7 |
| TRST | Test reset | AR19 | I | OV_{DD} | 7 |
| | DFT | | 1 | | |
| SCAN_MODE | Scan mode | AL17 | I | OV _{DD} | 39 |
| TEST_SEL | Test mode select | AT21 | I | OV _{DD} | 12, 28 |
| | Power Management | I | | | |
| ASLEEP | Asleep | AR21 | 0 | OV _{DD} | 35 |
| | | 1 | | | 1 |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|----------|------------------------------|-----------------------|-------------|------------------|-------|
| | Input /Output Voltage Select | | | | |
| IO_VSEL0 | I/O Voltage select | AL18 | I | OV _{DD} | 30 |
| IO_VSEL1 | I/O Voltage select | AP18 | I | OV _{DD} | 30 |
| IO_VSEL2 | I/O Voltage select | AK18 | I | OV _{DD} | 30 |
| IO_VSEL3 | I/O Voltage select | AM18 | I | OV _{DD} | 30 |
| IO_VSEL4 | I/O Voltage select | AH19 | I | OV _{DD} | 30 |
| | Power and Ground Signals | • | | | |
| GND | Ground | A18 | — | | _ |
| GND | Ground | A22 | — | | - |
| GND | Ground | A26 | — | _ | - |
| GND | Ground | B5 | — | _ | |
| GND | Ground | B11 | — | _ | — |
| GND | Ground | B18 | — | _ | |
| GND | Ground | B20 | — | _ | |
| GND | Ground | B22 | — | _ | — |
| GND | Ground | C3 | — | _ | |
| GND | Ground | C9 | — | _ | _ |
| GND | Ground | C15 | — | _ | - |
| GND | Ground | D7 | — | _ | _ |
| GND | Ground | D13 | — | — | — |
| GND | Ground | E5 | — | — | — |
| GND | Ground | E11 | — | — | — |
| GND | Ground | E17 | — | — | - |
| GND | Ground | E19 | — | — | - |
| GND | Ground | F3 | — | — | - |
| GND | Ground | F9 | — | — | — |
| GND | Ground | F15 | — | _ | — |
| GND | Ground | F23 | — | — | — |
| GND | Ground | F27 | — | _ | - |
| GND | Ground | G7 | - | — | - |
| GND | Ground | G13 | — | — | — |
| GND | Ground | G17 | - | — | - |
| GND | Ground | G21 | — | — | - |
| GND | Ground | H5 | - | — | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|----------|
| GND | Ground | H11 | | _ | |
| GND | Ground | J3 | | _ | _ |
| GND | Ground | J9 | | _ | |
| GND | Ground | J21 | | _ | |
| GND | Ground | J23 | | _ | |
| GND | Ground | J27 | | _ | _ |
| GND | Ground | K7 | | _ | |
| GND | Ground | K19 | | _ | |
| GND | Ground | K25 | | _ | _ |
| GND | Ground | L5 | — | _ | _ |
| GND | Ground | L12 | — | _ | _ |
| GND | Ground | L14 | — | _ | _ |
| GND | Ground | L16 | — | | _ |
| GND | Ground | L18 | — | _ | _ |
| GND | Ground | L20 | — | _ | _ |
| GND | Ground | L22 | — | _ | _ |
| GND | Ground | L24 | | _ | _ |
| GND | Ground | МЗ | — | _ | _ |
| GND | Ground | M9 | — | _ | _ |
| GND | Ground | M11 | | _ | _ |
| GND | Ground | M13 | — | _ | _ |
| GND | Ground | M15 | | _ | |
| GND | Ground | M17 | — | _ | _ |
| GND | Ground | M19 | | _ | |
| GND | Ground | M21 | | _ | |
| GND | Ground | M23 | — | _ | _ |
| GND | Ground | M25 | — | _ | _ |
| GND | Ground | M27 | — | _ | _ |
| GND | Ground | N7 | — | | - 1 |
| GND | Ground | N12 | — | | — |
| GND | Ground | N14 | — | | - |
| GND | Ground | N16 | — | | - 1 |
| GND | Ground | N18 | | | 1 — |
| GND | Ground | N20 | | _ | <u> </u> |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
| GND | Ground | N22 | — | _ | — |
| GND | Ground | N24 | — | — | — |
| GND | Ground | N26 | — | _ | — |
| GND | Ground | P5 | — | — | — |
| GND | Ground | P11 | — | _ | — |
| GND | Ground | P13 | — | _ | — |
| GND | Ground | P15 | — | — | — |
| GND | Ground | P17 | — | _ | — |
| GND | Ground | P19 | — | _ | — |
| GND | Ground | P21 | — | — | — |
| GND | Ground | P23 | — | — | — |
| GND | Ground | P25 | — | — | — |
| GND | Ground | P27 | — | — | — |
| GND | Ground | R3 | — | — | — |
| GND | Ground | R9 | — | _ | — |
| GND | Ground | R12 | — | — | — |
| GND | Ground | R14 | — | _ | — |
| GND | Ground | R16 | — | _ | — |
| GND | Ground | R18 | — | — | — |
| GND | Ground | R20 | — | _ | — |
| GND | Ground | R22 | — | _ | — |
| GND | Ground | R24 | — | — | — |
| GND | Ground | R26 | — | _ | — |
| GND | Ground | T7 | — | _ | — |
| GND | Ground | T11 | — | — | — |
| GND | Ground | T13 | — | _ | — |
| GND | Ground | T15 | — | _ | — |
| GND | Ground | T17 | — | | |
| GND | Ground | T19 | — | _ | — |
| GND | Ground | T21 | - | — | — |
| GND | Ground | T23 | — | _ | — |
| GND | Ground | T25 | — | — | — |
| GND | Ground | T27 | — | — | — |
| GND | Ground | U3 | — | _ | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
| GND | Ground | U5 | | _ | |
| GND | Ground | U12 | — | _ | _ |
| GND | Ground | U14 | — | _ | _ |
| GND | Ground | U16 | — | _ | _ |
| GND | Ground | U18 | | _ | |
| GND | Ground | U20 | | _ | _ |
| GND | Ground | U22 | — | _ | |
| GND | Ground | U24 | | _ | |
| GND | Ground | U26 | | _ | _ |
| GND | Ground | V10 | | _ | _ |
| GND | Ground | V11 | | _ | _ |
| GND | Ground | V13 | | _ | _ |
| GND | Ground | V15 | — | _ | |
| GND | Ground | V17 | | _ | _ |
| GND | Ground | V19 | | _ | _ |
| GND | Ground | V21 | | _ | _ |
| GND | Ground | V23 | | _ | _ |
| GND | Ground | V25 | | _ | _ |
| GND | Ground | V27 | | _ | |
| GND | Ground | W7 | | _ | _ |
| GND | Ground | W12 | — | — | _ |
| GND | Ground | W14 | | _ | _ |
| GND | Ground | W16 | | _ | _ |
| GND | Ground | W18 | — | — | _ |
| GND | Ground | W20 | | _ | _ |
| GND | Ground | W22 | | _ | _ |
| GND | Ground | W24 | — | — | _ |
| GND | Ground | W26 | — | — | — |
| GND | Ground | Y3 | — | — | _ |
| GND | Ground | Y5 | — | _ | — |
| GND | Ground | Y11 | | _ | _ |
| GND | Ground | Y13 | — | | - |
| GND | Ground | Y15 | — | _ | _ |
| GND | Ground | Y17 | _ | _ | _ |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
| GND | Ground | Y19 | — | _ | — |
| GND | Ground | Y21 | — | — | — |
| GND | Ground | Y23 | — | _ | — |
| GND | Ground | Y25 | — | — | |
| GND | Ground | Y27 | — | _ | _ |
| GND | Ground | AA9 | — | _ | — |
| GND | Ground | AA12 | — | — | — |
| GND | Ground | AA14 | — | — | — |
| GND | Ground | AA16 | — | — | — |
| GND | Ground | AA18 | — | — | — |
| GND | Ground | AA20 | — | — | — |
| GND | Ground | AA22 | — | — | — |
| GND | Ground | AA24 | — | _ | — |
| GND | Ground | AA26 | — | — | — |
| GND | Ground | AB7 | — | — | — |
| GND | Ground | AB11 | — | _ | — |
| GND | Ground | AB13 | — | — | — |
| GND | Ground | AB15 | — | _ | — |
| GND | Ground | AB17 | — | — | — |
| GND | Ground | AB19 | — | — | — |
| GND | Ground | AB21 | — | _ | — |
| GND | Ground | AB23 | — | — | — |
| GND | Ground | AB25 | — | — | — |
| GND | Ground | AB27 | — | — | — |
| GND | Ground | AC5 | — | — | — |
| GND | Ground | AC12 | — | — | — |
| GND | Ground | AC14 | — | — | — |
| GND | Ground | AC16 | — | — | — |
| GND | Ground | AC18 | — | — | — |
| GND | Ground | AC20 | — | _ | _ |
| GND | Ground | AC22 | — | — | - |
| GND | Ground | AC24 | — | — | - |
| GND | Ground | AC26 | — | — | - |
| GND | Ground | AD3 | — | _ | _ |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
| GND | Ground | AD9 | — | _ | - |
| GND | Ground | AD11 | — | — | - |
| GND | Ground | AD13 | — | — | - |
| GND | Ground | AD15 | — | — | _ |
| GND | Ground | AD17 | — | _ | - |
| GND | Ground | AD19 | — | _ | — |
| GND | Ground | AD21 | — | — | _ |
| GND | Ground | AD23 | — | — | - |
| GND | Ground | AD25 | — | — | — |
| GND | Ground | AD27 | — | — | — |
| GND | Ground | AE7 | — | _ | _ |
| GND | Ground | AE12 | — | — | — |
| GND | Ground | AE14 | — | _ | - |
| GND | Ground | AE16 | — | _ | _ |
| GND | Ground | AE18 | — | _ | - |
| GND | Ground | AE20 | — | _ | — |
| GND | Ground | AE22 | — | _ | _ |
| GND | Ground | AE24 | — | _ | - |
| GND | Ground | AE26 | — | _ | - |
| GND | Ground | AE27 | — | _ | _ |
| GND | Ground | AF5 | — | — | — |
| GND | Ground | AF13 | — | _ | - |
| GND | Ground | AF15 | — | _ | - |
| GND | Ground | AF17 | — | — | — |
| GND | Ground | AF19 | — | — | — |
| GND | Ground | AF21 | — | _ | - |
| GND | Ground | AF23 | — | — | — |
| GND | Ground | AF25 | — | — | — |
| GND | Ground | AG3 | — | — | — |
| GND | Ground | AG9 | — | _ | - |
| GND | Ground | AG18 | — | _ | - |
| GND | Ground | AH7 | — | _ | - |
| GND | Ground | AH13 | — | _ | - |
| GND | Ground | AH22 | <u> </u> | | |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
| GND | Ground | AH34 | — | _ | _ |
| GND | Ground | AJ5 | — | — | — |
| GND | Ground | AJ11 | — | _ | — |
| GND | Ground | AJ32 | — | — | — |
| GND | Ground | AK3 | — | _ | — |
| GND | Ground | AK9 | — | _ | — |
| GND | Ground | AK15 | — | — | — |
| GND | Ground | AK19 | — | _ | — |
| GND | Ground | AK28 | — | _ | — |
| GND | Ground | AL7 | — | — | — |
| GND | Ground | AL13 | — | — | — |
| GND | Ground | AL29 | — | — | — |
| GND | Ground | AL34 | — | _ | — |
| GND | Ground | AM5 | — | _ | — |
| GND | Ground | AM11 | — | — | — |
| GND | Ground | AM17 | — | _ | — |
| GND | Ground | AM21 | — | _ | — |
| GND | Ground | AM32 | — | — | — |
| GND | Ground | AN3 | — | — | — |
| GND | Ground | AN9 | — | — | — |
| GND | Ground | AN15 | — | — | — |
| GND | Ground | AN30 | — | — | — |
| GND | Ground | AP7 | — | — | — |
| GND | Ground | AP13 | — | _ | — |
| GND | Ground | AP19 | — | — | — |
| GND | Ground | AP23 | — | _ | — |
| GND | Ground | AP34 | — | _ | _ |
| GND | Ground | AR5 | — | — | — |
| GND | Ground | AR11 | — | _ | _ |
| GND | Ground | AR16 | - | _ | - |
| GND | Ground | AR18 | — | | — |
| GND | Ground | AR32 | — | _ | - |
| GND | Ground | AT22 | — | | — |
| GND | Ground | AT36 | — | _ | — |

| Table 1. | Pins | List I | bv Bus | (continued) |
|----------|------|--------|--------|-------------|
| 14010 11 | | | ., | (|

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|------------------------|-----------------------|-------------|-----------------|-------|
| XGND | SerDes transceiver GND | D33 | — | | — |
| XGND | SerDes transceiver GND | E28 | _ | _ | _ |
| XGND | SerDes transceiver GND | E30 | — | _ | - |
| XGND | SerDes transceiver GND | G29 | — | _ | - |
| XGND | SerDes transceiver GND | G31 | — | — | - |
| XGND | SerDes transceiver GND | F32 | — | _ | — |
| XGND | SerDes transceiver GND | H29 | — | — | - |
| XGND | SerDes transceiver GND | H32 | — | _ | — |
| XGND | SerDes transceiver GND | H34 | — | _ | — |
| XGND | SerDes transceiver GND | J29 | — | — | - |
| XGND | SerDes transceiver GND | J31 | — | — | - |
| XGND | SerDes transceiver GND | K28 | — | _ | — |
| XGND | SerDes transceiver GND | K29 | — | — | - |
| XGND | SerDes transceiver GND | L29 | — | _ | - |
| XGND | SerDes transceiver GND | L32 | — | _ | |
| XGND | SerDes transceiver GND | M30 | — | — | — |
| XGND | SerDes transceiver GND | N29 | — | _ | - |
| XGND | SerDes transceiver GND | N30 | — | _ | |
| XGND | SerDes transceiver GND | N32 | — | — | - |
| XGND | SerDes transceiver GND | P29 | — | _ | |
| XGND | SerDes transceiver GND | P34 | — | _ | - |
| XGND | SerDes transceiver GND | R30 | _ | | |
| XGND | SerDes transceiver GND | R32 | — | _ | - |
| XGND | SerDes transceiver GND | U29 | _ | _ | |
| XGND | SerDes transceiver GND | U31 | — | _ | |
| XGND | SerDes transceiver GND | V29 | _ | _ | |
| XGND | SerDes transceiver GND | V31 | _ | _ | |
| XGND | SerDes transceiver GND | W30 | — | — | — |
| XGND | SerDes transceiver GND | Y32 | — | _ | |
| XGND | SerDes transceiver GND | AA30 | — | _ | - |
| XGND | SerDes transceiver GND | AB32 | — | — | - |
| XGND | SerDes transceiver GND | AC30 | — | — | - |
| XGND | SerDes transceiver GND | AC34 | — | — | - |
| XGND | SerDes transceiver GND | AD30 | — | — | — |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|------------------------|-----------------------|-------------|-----------------|----------|
| XGND | SerDes transceiver GND | AD31 | — | _ | — |
| XGND | SerDes transceiver GND | AF32 | — | _ | — |
| XGND | SerDes transceiver GND | AH31 | — | — | — |
| XGND | SerDes transceiver GND | AG30 | — | _ | — |
| SGND | SerDes core logic GND | A28 | — | — | — |
| SGND | SerDes core logic GND | A32 | — | — | — |
| SGND | SerDes core logic GND | A36 | — | _ | — |
| SGND | SerDes core logic GND | B30 | — | _ | — |
| SGND | SerDes core logic GND | B34 | — | _ | — |
| SGND | SerDes core logic GND | C29 | — | _ | |
| SGND | SerDes core logic GND | C33 | — | _ | |
| SGND | SerDes core logic GND | D31 | — | _ | |
| SGND | SerDes core logic GND | D35 | — | _ | |
| SGND | SerDes core logic GND | E35 | — | _ | |
| SGND | SerDes core logic GND | G34 | — | _ | |
| SGND | SerDes core logic GND | G36 | — | | |
| SGND | SerDes core logic GND | J35 | — | _ | |
| SGND | SerDes core logic GND | K33 | — | _ | |
| SGND | SerDes core logic GND | L36 | — | | |
| SGND | SerDes core logic GND | M34 | — | _ | |
| SGND | SerDes core logic GND | N35 | — | _ | |
| SGND | SerDes core logic GND | R33 | — | _ | |
| SGND | SerDes core logic GND | R36 | — | _ | |
| SGND | SerDes core logic GND | T35 | — | _ | |
| SGND | SerDes core logic GND | U34 | — | _ | |
| SGND | SerDes core logic GND | V36 | — | _ | |
| SGND | SerDes core logic GND | W33 | — | _ | |
| SGND | SerDes core logic GND | Y35 | — | _ | |
| SGND | SerDes core logic GND | AA34 | — | _ | |
| SGND | SerDes core logic GND | AB36 | — | _ | |
| SGND | SerDes core logic GND | AD35 | — | _ | |
| SGND | SerDes core logic GND | AE34 | _ | | - |
| SGND | SerDes core logic GND | AF36 | _ | | <u> </u> |
| SGND | SerDes core logic GND | AG33 | _ | | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|----------------|-------------------------------------|-----------------------|-------------|-------------------------|-------|
| SGND | SerDes core logic GND | AH33 | — | | _ |
| SGND | SerDes core logic GND | AH35 | — | — | — |
| AGND_SRDS1 | SerDes PLL1 GND | B33 | — | — | — |
| AGND_SRDS2 | SerDes PLL2 GND | T36 | — | _ | — |
| AGND_SRDS3 | SerDes PLL3 GND | AE36 | — | _ | — |
| SENSEGND_CA_PL | Core group A and Platform GND sense | K17 | — | _ | 8 |
| SENSEGND_CB | Core group B GND sense | AG16 | — | _ | 8 |
| OVDD | General I/O supply | AG21 | — | OV _{DD} | |
| OVDD | General I/O supply | AJ12 | — | OV _{DD} | |
| OVDD | General I/O supply | AJ14 | — | OV _{DD} | |
| OVDD | General I/O supply | AJ18 | — | OV _{DD} | |
| OVDD | General I/O supply | AJ23 | — | OV _{DD} | |
| OVDD | General I/O supply | AL16 | — | OV _{DD} | |
| OVDD | General I/O supply | AL20 | — | OV _{DD} | |
| OVDD | General I/O supply | AN18 | — | OV _{DD} | |
| OVDD | General I/O supply | AN22 | — | OV _{DD} | |
| OVDD | General I/O supply | AP16 | — | OV _{DD} | |
| OVDD | General I/O supply | AR24 | — | OV _{DD} | — |
| OVDD | General I/O supply | AT15 | — | OV _{DD} | — |
| CVDD | eSPI and eSDHC supply | AG24 | — | CV _{DD} | — |
| CVDD | eSPI and& eSDHC supply | AJ29 | — | CV _{DD} | — |
| CVDD | eSPI and& eSDHC supply | AP29 | — | CV _{DD} | — |
| GVDD | DDR supply | B2 | — | GV _{DD} | — |
| GVDD | DDR supply | B8 | — | GV _{DD} | — |
| GVDD | DDR supply | B14 | — | GV _{DD} | — |
| GVDD | DDR supply | C18 | — | GV _{DD} | — |
| GVDD | DDR supply | C12 | — | GV _{DD} | — |
| GVDD | DDR supply | C6 | — | GV _{DD} | — |
| GVDD | DDR supply | D4 | — | GV _{DD} | — |
| GVDD | DDR supply | D10 | — | GV_{DD} | — |
| GVDD | DDR supply | D16 | — | GV _{DD} | - |
| GVDD | DDR supply | E14 | — | GV _{DD} | _ |
| GVDD | DDR supply | E8 | — | GV _{DD} | — |
| GVDD | DDR supply | E2 | — | GV _{DD} | — |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|---------------------------|-------|
| GVDD | DDR supply | F6 | — | GV _{DD} | - |
| GVDD | DDR supply | F12 | — | GV _{DD} | — |
| GVDD | DDR supply | G4 | — | GV _{DD} | — |
| GVDD | DDR supply | G10 | — | GV _{DD} | — |
| GVDD | DDR supply | G16 | — | GV _{DD} | — |
| GVDD | DDR supply | H14 | — | GV _{DD} | — |
| GVDD | DDR supply | H8 | — | GV _{DD} | — |
| GVDD | DDR supply | H2 | — | GV _{DD} | _ |
| GVDD | DDR supply | J6 | — | GV _{DD} | _ |
| GVDD | DDR supply | J12 | — | GV _{DD} | — |
| GVDD | DDR supply | K10 | — | GV _{DD} | _ |
| GVDD | DDR supply | K4 | — | GV _{DD} | — |
| GVDD | DDR supply | L2 | — | GV _{DD} | _ |
| GVDD | DDR supply | L8 | — | GV _{DD} | _ |
| GVDD | DDR supply | M6 | — | GV _{DD} | — |
| GVDD | DDR supply | N4 | — | GV _{DD} | — |
| GVDD | DDR supply | N10 | — | GV _{DD} | — |
| GVDD | DDR supply | P8 | — | GV_{DD} | — |
| GVDD | DDR supply | P2 | — | GV_{DD} | — |
| GVDD | DDR supply | R6 | — | GV_{DD} | — |
| GVDD | DDR supply | T10 | — | GV_{DD} | — |
| GVDD | DDR supply | T4 | — | GV_{DD} | — |
| GVDD | DDR supply | U2 | — | GV _{DD} | — |
| GVDD | DDR supply | U8 | — | GV_{DD} | — |
| GVDD | DDR supply | V7 | — | GV_{DD} | — |
| GVDD | DDR supply | W10 | — | GV_{DD} | — |
| GVDD | DDR supply | Y2 | — | GV_{DD} | — |
| GVDD | DDR supply | Y8 | — | GV_{DD} | — |
| GVDD | DDR supply | AA6 | — | GV_DD | _ |
| GVDD | DDR supply | AB4 | — | GV_DD | _ |
| GVDD | DDR supply | AB10 | — | GV_DD | - |
| GVDD | DDR supply | AC2 | — | GV _{DD} | — |
| GVDD | DDR supply | AC8 | — | GV_DD | - |
| GVDD | DDR supply | AD6 | — | GV _{DD} | — |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------------|-----------------------|-------------|-----------------------------|----------|
| GVDD | DDR supply | AE10 | — | GV _{DD} | — |
| GVDD | DDR supply | AE4 | — | GV_{DD} | _ |
| GVDD | DDR supply | AF2 | — | GV_{DD} | — |
| GVDD | DDR supply | AF8 | — | $\mathrm{GV}_{\mathrm{DD}}$ | - |
| GVDD | DDR supply | AG6 | — | GV_{DD} | — |
| GVDD | DDR supply | AH10 | — | GV_{DD} | — |
| GVDD | DDR supply | AH4 | — | GV_{DD} | — |
| GVDD | DDR supply | AJ2 | — | GV_{DD} | _ |
| GVDD | DDR supply | AJ8 | — | GV_{DD} | _ |
| GVDD | DDR supply | AK10 | — | GV _{DD} | — |
| GVDD | DDR supply | AK6 | _ | GV _{DD} | _ |
| GVDD | DDR supply | AL4 | _ | GV _{DD} | _ |
| GVDD | DDR supply | AL10 | | GV _{DD} | _ |
| GVDD | DDR supply | AM2 | — | GV _{DD} | — |
| GVDD | DDR supply | AM8 | — | GV _{DD} | — |
| GVDD | DDR supply | AN12 | — | GV _{DD} | — |
| GVDD | DDR supply | AN6 | — | GV _{DD} | — |
| GVDD | DDR supply | AP10 | — | GV _{DD} | _ |
| GVDD | DDR supply | AP4 | — | GV _{DD} | _ |
| GVDD | DDR supply | AR2 | — | GV _{DD} | _ |
| GVDD | DDR supply | AR8 | — | GV _{DD} | _ |
| GVDD | DDR supply | AR14 | — | GV _{DD} | — |
| BVDD | Local bus supply | B24 | — | BV _{DD} | <u> </u> |
| BVDD | Local bus supply | E24 | — | BV _{DD} | _ |
| BVDD | Local bus supply | E22 | | BV _{DD} | _ |
| BVDD | Local bus supply | F20 | — | BV _{DD} | _ |
| BVDD | Local bus supply | F26 | — | BV _{DD} | _ |
| BVDD | Local bus supply | H20 | — | BV _{DD} | — |
| BVDD | Local bus supply | H18 | _ | BV _{DD} | <u> </u> |
| BVDD | Local bus supply | K22 | — | BV _{DD} | <u> </u> |
| BVDD | Local bus supply | K24 | — | BV _{DD} | - |
| SVDD | SerDes core logic supply | A30 | — | SV _{DD} | <u> </u> |
| SVDD | SerDes core logic supply | A34 | — | SV _{DD} | <u> </u> |
| SVDD | SerDes core logic supply | B28 | _ | SV _{DD} | 1_ |

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|---------------------------|-----------------------|-------------|------------------|-------|
| SVDD | SerDes core logic supply | B32 | — | SV _{DD} | - |
| SVDD | SerDes core logic supply | B36 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | C31 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | C34 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | C35 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | D29 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | E36 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | F34 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | G35 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | J36 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | K34 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | L35 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | M33 | — | SV _{DD} | |
| SVDD | SerDes core logic supply | N36 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | R34 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | R35 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | U33 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | V35 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | W34 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | Y36 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | AA33 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | AB35 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | AD36 | — | SV _{DD} | _ |
| SVDD | SerDes core logic supply | AE33 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | AF35 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | AG34 | — | SV _{DD} | — |
| SVDD | SerDes core logic supply | AH36 | — | SV _{DD} | — |
| XVDD | SerDes transceiver supply | E32 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | E33 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | F28 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | F30 | — | XV _{DD} | - |
| XVDD | SerDes transceiver supply | G32 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | H31 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | H33 | — | XV_{DD} | — |

| Signal | Signal Signal Description | | Pin Type | Power Supply | Notes |
|--------|------------------------------------|---------|-------------|----------------------|-------|
| XVDD | SerDes transceiver supply | J28 | — | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | J30 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | J32 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | K30 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | L30 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | L31 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | M29 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | N31 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | P30 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | P33 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | R29 | _ | XV _{DD} | |
| XVDD | SerDes transceiver supply | R31 | _ | XV _{DD} | |
| XVDD | SerDes transceiver supply | T29 | — | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | T32 | — | XV _{DD} | |
| XVDD | SerDes transceiver supply | , U30 · | | XV _{DD} | |
| XVDD | SerDes transceiver supply | V30 | | XV _{DD} | |
| XVDD | SerDes transceiver supply | V32 | _ | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | W29 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | Y31 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | AA29 | _ | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | AB30 | _ | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | AB31 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | AC33 | _ | XV _{DD} | _ |
| XVDD | SerDes transceiver supply | AD32 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | AE30 | — | XV _{DD} | — |
| XVDD | SerDes transceiver supply | AF31 | — | XV_{DD} | — |
| XVDD | SerDes transceiver supply | AH32 | — | XV_{DD} | — |
| LVDD | Ethernet controller 1 and 2 supply | AK33 | — | LV _{DD} | — |
| LVDD | Ethernet controller 1 and 2 supply | AP31 | — | LV _{DD} — | |
| LVDD | Ethernet controller 1 and 2 supply | AL31 | — | LV _{DD} — | |
| LVDD | Ethernet controller 1 and 2 supply | AN33 | — | — LV _{DD} | |
| LVDD | Ethernet controller 1 and 2 supply | AJ35 | — | – LV _{DD} – | |
| LVDD | Ethernet controller 1 and 2 supply | AR35 | — | LV _{DD} | - |
| LVDD | Ethernet controller 1 and 2 supply | AM35 | — | LV _{DD} | - |

Pin Assignments and Reset States

Table 1. Pins List by Bus (continued)

| Signal | Signal Signal Description | | Pin Type | Power Supply | Notes |
|-----------|---|---|-------------|-------------------|-------|
| POVDD | Fuse programming override supply | AT17 | — | POV _{DD} | 33 |
| VDD_CA_PL | Core Group A and Platform supply | L11 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L13 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L15 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L17 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L19 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L21 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L23 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | L25 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M12 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M14 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M16 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M18 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M20 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M22 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M24 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | M26 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N11 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N13 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N15 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N17 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N19 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N21 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N23 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N25 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | N27 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | P12 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | P14 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply P16 — VDD_ | | VDD_CA_PL | 42 | |
| VDD_CA_PL | Core Group A and Platform supply P18 — | | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply P20 — VD | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply P22 - VDD_ | | VDD_CA_PL | 42 | |
| VDD_CA_PL | Core Group A and Platform supply | P24 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | P26 | — | VDD_CA_PL | 42 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------|----------------------------------|--|-------------|-----------------|-------|
| VDD_CA_PL | Core Group A and Platform supply | R11 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R13 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R15 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R17 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R19 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R21 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R23 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R25 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | R27 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T12 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T14 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T16 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T18 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T20 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T22 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T24 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | T26 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U11 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U13 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U15 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U17 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U19 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U21 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U23 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U25 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | U27 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | V12 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | V14 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply V16 — VDI | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply V18 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply V20 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply V22 - VD | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | V24 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | V26 | _ | VDD_CA_PL | 42 |

| Signal | Signal Signal Description | | Pin Type | Power Supply | Notes |
|-----------|---|---|-------------|-----------------|-------|
| VDD_CA_PL | Core Group A and Platform supply | W11 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | W13 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | W21 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | W23 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | W25 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | W28 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Y12 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Y14 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Y22 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Y24 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Y26 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AA11 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AA13 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AA23 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AA25 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AA27 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AB12 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AB22 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AB24 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AB26 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC11 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC13 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC21 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC23 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC25 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AC27 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AD12 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AD14 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply AD16 — VDD | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AD18 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | Core Group A and Platform supply AD20 — | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply AD22 - VDE | | VDD_CA_PL | 42 | |
| VDD_CA_PL | Core Group A and Platform supply | AD24 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AD26 | — | VDD_CA_PL | 42 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-----------|-----------------------------------|-----------------------|-------------|--------------------|-------|
| VDD_CA_PL | Core Group A and Platform supply | AE11 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE13 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE15 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE17 | — | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE19 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE21 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE23 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AE25 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF14 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF16 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF18 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF20 | | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF22 | _ | VDD_CA_PL | 42 |
| VDD_CA_PL | Core Group A and Platform supply | AF24 | _ | VDD_CA_PL | 42 |
| VDD_CB | Core Group B supply | W15 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | W17 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | W19 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | Y16 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | Y18 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | Y20 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AA15 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AA17 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AA19 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AA21 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AB14 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AB16 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AB18 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AB20 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AC15 | _ | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AC17 | | V _{DD_CB} | 42 |
| VDD_CB | Core Group B supply | AC19 | _ | V _{DD_CB} | 42 |
| VDD_LP | Low power security monitor supply | | | V _{DD_LP} | 27 |
| AVDD_CC1 | Core cluster PLL1 supply | A20 | — | — | 13 |
| AVDD_CC2 | Core cluster PLL2 supply | AT18 | — | — | 13 |

| | | Package Pin Number | Pin Type | Power Supply | Notes |
|----------------|---|-----------------------|-------------|---------------------|-------|
| AVDD_PLAT | Platform PLL supply | AT20 | — | _ | 13 |
| AVDD_DDR | DDR PLL Supply | A19 | — | — | 13 |
| AVDD_SRDS1 | SerDes PLL1 supply | A33 | — | — | 13 |
| AVDD_SRDS2 | SerDes PLL2 supply | U36 | — | _ | 13 |
| AVDD_SRDS3 | SerDes PLL3 supply | AE35 | — | — | 13 |
| SENSEVDD_CA_PL | Core group A Vdd sense | K16 | — | — | 8 |
| SENSEVDD_CB | Core group B Vdd sense | AG15 | — | — | 8 |
| USB1_AGND | USB1 PHY Transceiver GND | AH24 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AJ24 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AL25 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AM25 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AR25 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AR26 | — | _ | — |
| USB1_AGND | USB1 PHY Transceiver GND AR27 | | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AR28 | — | — | — |
| USB1_AGND | USB1 PHY Transceiver GND | AT25 | — | _ | _ |
| USB1_AGND | USB1 PHY Transceiver GND AT28 | | — | _ | _ |
| USB2_AGND | USB2 PHY Transceiver GND | AH27 | — | — | — |
| USB2_AGND | USB2 PHY Transceiver GND | AL28 | — | _ | _ |
| USB2_AGND | USB2 PHY Transceiver GND | AM28 | — | — | — |
| USB2_AGND | USB2 PHY Transceiver GND | AN25 | — | — | — |
| USB2_AGND | USB2 PHY Transceiver GND | AN26 | — | _ | _ |
| USB2_AGND | USB2 PHY Transceiver GND | AN27 | — | — | — |
| USB2_AGND | USB2 PHY Transceiver GND | AN28 | — | _ | _ |
| USB2_AGND | USB2 PHY Transceiver GND | AP25 | — | _ | — |
| USB2_AGND | USB2 PHY Transceiver GND | AP28 | — | — | — |
| USB1_VDD_3P3 | USB1 PHY Transceiver 3.3V Supply | AL24 | — | — | — |
| USB1_VDD_3P3 | USB1 PHY Transceiver 3.3V Supply | AJ25 | — | _ | _ |
| USB2_VDD_3P3 | USB2 PHY Transceiver 3.3V Supply | AJ26 | — | — | — |
| USB2_VDD_3P3 | USB2 PHY Transceiver 3.3V Supply AJ27 — | | — | — | |
| USB1_VDD_1P0 | USB1 PHY PLL 1.0V Supply | AH25 | — | | |
| USB2_VDD_1P0 | USB2 PHY PLL 1.0V Supply | AH26 | — | — | — |
| | Analog Signals | | I | | |
| MVREF | SSTL_1.5/1.35 Reference Voltage | B19 | Ι | GV _{DD} /2 | — |

Pin Power Package Signal Signal Description Notes Pin Number Supply Туре SD_IMP_CAL_TX AF30 200Ω (±1%) 23 SerDes Tx Impedance Calibration Т to XV_{DD} SD_IMP_CAL_RX SerDes Rx Impedance Calibration B27 I **200**Ω (±1%) 24 to SV_{DD} TEMP_ANODE C21 internal Temperature Diode Anode 9 ____ diode TEMP_CATHODE B21 9 Temperature Diode Cathode internal diode USB1_IBIAS_REXT USB PHY1 Reference Bias Current AM26 36 Generation USB PHY2 Reference Bias Current USB2_IBIAS_REXT AM27 ____ ____ 36 Generation USB1_VDD_1P8_DECAP USB1 PHY 1.8V Output to External AL26 37 ____ Decap USB2_VDD_1P8_DECAP USB2 PHY 1.8V Output to External AL27 37 Decap **No Connection Pins** NC_A27 No Connection A27 ____ 11 NC_B26 No Connection B26 11 NC_C19 No Connection C19 ____ 11 NC_C20 No Connection C20 11 _ ____ NC_C26 No Connection C26 11 _ NC_C27 No Connection C27 11 ____ NC_D18 No Connection D18 11 ____ NC D27 No Connection D27 11 NC E16 No Connection E16 11 NC_E27 No Connection E27 11 NC G27 No Connection G27 11 NC_H12 No Connection H12 ___ 11 NC_H13 No Connection H13 11 NC_H15 No Connection H15 _ 11 NC_H27 No Connection H27 11 NC_J11 No Connection J11 11 ____ NC_J13 No Connection J13 11 NC_J14 No Connection J14 11 NC_K11 No Connection K11 11 NC_K12 No Connection K12 11 _ ____

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-------------|--------------------|-----------------------|-------------|-----------------|-------|
| NC_K13 | No Connection | K13 | — | _ | 11 |
| NC_K14 | No Connection | K14 | — | _ | 11 |
| NC_R28 | No Connection | R28 | — | _ | 11 |
| NC_T28 | No Connection | T28 | — | _ | 11 |
| NC_U28 | No Connection | U28 | — | _ | 11 |
| NC_V28 | No Connection | V28 | — | — | 11 |
| NC_W27_DET | No Connection | W27 | — | | 11 |
| NC_Y28 | No Connection | Y28 | — | — | 11 |
| NC_AA28 | No Connection | AA28 | — | — | 11 |
| NC_AB28 | No Connection | AB28 | — | — | 11 |
| NC_AB29 | No Connection | AB29 | — | — | 11 |
| NC_AC28 | No Connection | AC28 | — | — | 11 |
| NC_AC29 | No Connection | AC29 | — | _ | 11 |
| NC_AD29 | No Connection | AD29 | — | _ | 11 |
| NC_AE29 | No Connection | AE29 | — | — | 11 |
| NC_AF26 | No Connection | AF26 | — | _ | 11 |
| NC_AF27 | No Connection | AF27 | — | _ | 11 |
| NC_AF28 | No Connection | AF28 | — | — | 11 |
| NC_AF29 | No Connection | AF29 | — | _ | 11 |
| NC_AG26 | No Connection | AG26 | — | — | 11 |
| NC_AG27 | No Connection | AG27 | — | — | 11 |
| NC_AG28 | No Connection | AG28 | — | | 11 |
| NC_AG29 | No Connection | AG29 | — | _ | 11 |
| NC_AH30 | No Connection | AH30 | — | — | 11 |
| NC_AM12 | No Connection | AM12 | — | _ | 11 |
| NC_AN13 | No Connection | AN13 | — | _ | 11 |
| NC_AP11 | No Connection | AP11 | — | _ | 11 |
| NC_AP14 | No Connection | AP14 | — | | 11 |
| NC_AT14 | No Connection | AT14 | — | — | 11 |
| | Reserved Pins | | | | |
| Reserve_C32 | — | C32 | — | _ | 11 |
| Reserve_D32 | _ | D32 | — | — | 11 |
| Reserve_U32 | — | U32 | — | | 11 |
| Reserve_U35 | — | U35 | — | — | 11 |

| Table 1. | Pins L | ist by | Bus (| continued) |
|----------|--------|--------|-------|------------|
| | | | | |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------------|--------------------|-----------------------|-------------|-----------------|-------|
| Reserve_AD33 | — | AD33 | — | _ | 11 |
| Reserve_AD34 | _ | AD34 | — | _ | 11 |
| Reserve_AG11 | _ | AG11 | — | GND | 21 |
| Reserve_AG12 | _ | AG12 | — | GND | 21 |
| Reserve_AH11 | _ | AH11 | — | GND | 21 |
| Reserve_AH12 | — | AH12 | — | GND | 21 |
| Reserve_A2 | _ | A2 | — | — | 11 |
| Reserve_A3 | _ | A3 | — | — | 11 |
| Reserve_A4 | _ | A4 | — | _ | 11 |
| Reserve_A5 | _ | A5 | — | — | 11 |
| Reserve_A6 | _ | A6 | — | — | 11 |
| Reserve_A7 | _ | A7 | — | _ | 11 |
| Reserve_A8 | _ | A8 | — | — | 11 |
| Reserve_A9 | _ | A9 | — | — | 11 |
| Reserve_A10 | _ | A10 | — | — | 11 |
| Reserve_A11 | _ | A11 | — | — | 11 |
| Reserve_A12 | _ | A12 | — | — | 11 |
| Reserve_A13 | _ | A13 | _ | _ | 11 |
| Reserve_A21 | _ | A21 | — | — | 11 |
| Reserve_A25 | — | A25 | — | _ | 11 |
| Reserve_B1 | _ | B1 | _ | _ | 11 |
| Reserve_B3 | _ | B3 | — | — | 11 |
| Reserve_B4 | — | B4 | — | _ | 11 |
| Reserve_B6 | — | B6 | — | _ | 11 |
| Reserve_B7 | _ | B7 | — | — | 11 |
| Reserve_B9 | — | B9 | — | _ | 11 |
| Reserve_B10 | _ | B10 | _ | _ | 11 |
| Reserve_B12 | _ | B12 | — | — | 11 |
| Reserve_B13 | _ | B13 | — | — | 11 |
| Reserve_C1 | — | C1 | — | _ | 11 |
| Reserve_C2 | — | C2 | — | _ | 11 |
| Reserve_C4 | _ | C4 | — | — | 11 |
| Reserve_C5 | _ | C5 | — | _ | 11 |
| Reserve_C7 | — | C7 | — | _ | 11 |

Pin Assignments and Reset States

Table 1. Pins List by Bus (continued)

| Signal | Signal Signal Description | | Pin Type | Power Supply | Notes |
|-------------|---------------------------|-----|-------------|-----------------|-------|
| Reserve_C13 | | C13 | — | _ | 11 |
| Reserve_D1 | — | D1 | — | — | 11 |
| Reserve_D2 | — | D2 | — | — | 11 |
| Reserve_D3 | _ | D3 | — | _ | 11 |
| Reserve_D5 | — | D5 | — | — | 11 |
| Reserve_D6 | _ | D6 | — | — | 11 |
| Reserve_E1 | _ | E1 | — | — | 11 |
| Reserve_E3 | _ | E3 | — | | 11 |
| Reserve_E4 | _ | E4 | — | | 11 |
| Reserve_F1 | _ | F1 | — | — | 11 |
| Reserve_F2 | _ | F2 | — | — | 11 |
| Reserve_F4 | _ | F4 | — | | 11 |
| Reserve_F5 | _ | F5 | — | | 11 |
| Reserve_G1 | _ | G1 | — | | 11 |
| Reserve_G2 | _ | G2 | — | | 11 |
| Reserve_G3 | _ | G3 | — | | 11 |
| Reserve_G5 | _ | G5 | _ | | 11 |
| Reserve_G6 | _ | G6 | _ | | 11 |
| Reserve_H1 | _ | H1 | _ | | 11 |
| Reserve_H3 | _ | H3 | _ | | 11 |
| Reserve_H4 | _ | H4 | _ | | 11 |
| Reserve_H6 | _ | H6 | _ | | 11 |
| Reserve_J1 | _ | J1 | _ | | 11 |
| Reserve_J2 | _ | J2 | _ | | 11 |
| Reserve_J4 | _ | J4 | _ | | 11 |
| Reserve_K1 | _ | K1 | _ | | 11 |
| Reserve_K2 | _ | K2 | _ | | 11 |
| Reserve_K3 | _ | КЗ | _ | | 11 |
| Reserve_K27 | _ | K27 | _ | | 11 |
| Reserve_L1 | _ | L1 | _ | | 11 |
| Reserve_L3 | _ | L3 | — | | 11 |
| Reserve_L4 | _ | L4 | — | | 11 |
| Reserve_L27 | _ | L27 | — | _ | 11 |
| Reserve_L28 | — | L28 | — | — | 11 |

| Table 1. I | Pins List | by Bus (| (continued) |
|------------|-----------|----------|-------------|
|------------|-----------|----------|-------------|

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-------------|--------------------|-----------------------|-------------|-----------------|-------|
| Reserve_M1 | _ | M1 | — | _ | 11 |
| Reserve_M2 | — | M2 | — | _ | 11 |
| Reserve_M4 | — | M4 | — | — | 11 |
| Reserve_M5 | — | M5 | — | _ | 11 |
| Reserve_M28 | — | M28 | — | — | 11 |
| Reserve_N1 | — | N1 | — | — | 11 |
| Reserve_N2 | — | N2 | — | — | 11 |
| Reserve_N3 | — | N3 | — | — | 11 |
| Reserve_N5 | — | N5 | — | — | 11 |
| Reserve_N28 | — | N28 | — | — | 11 |
| Reserve_P1 | _ | P1 | — | — | 11 |
| Reserve_P3 | — | P3 | — | — | 11 |
| Reserve_P4 | — | P4 | — | _ | 11 |
| Reserve_P28 | _ | P28 | — | — | 11 |
| Reserve_R1 | — | R1 | — | — | 11 |
| Reserve_R2 | — | R2 | — | _ | 11 |
| Reserve_R4 | — | R4 | — | — | 11 |
| Reserve_R5 | — | R5 | — | — | 11 |
| Reserve_T1 | — | T1 | — | — | 11 |
| Reserve_T2 | — | T2 | — | — | 11 |
| Reserve_T3 | — | Т3 | — | — | 11 |
| Reserve_T5 | — | T5 | — | _ | 11 |
| Reserve_U1 | — | U1 | — | — | 11 |
| Reserve_U4 | — | U4 | — | — | 11 |
| Reserve_V1 | — | V1 | — | — | 11 |
| Reserve_V2 | _ | V2 | — | — | 11 |
| Reserve_V3 | — | V3 | — | — | 11 |
| Reserve_V4 | — | V4 | — | — | 11 |
| Reserve_W1 | — | W1 | — | — | 11 |
| Reserve_W2 | — | W2 | — | _ | 11 |
| Reserve_W3 | _ | W3 | — | _ | 11 |
| Reserve_W4 | _ | W4 | — | _ | 11 |
| Reserve_Y1 | _ | Y1 | — | — | 11 |
| Reserve_Y4 | — | Y4 | — | _ | 11 |

Pin Assignments and Reset States

Table 1. Pins List by Bus (continued)

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------------|--------------------|-----------------------|-------------|-----------------|-------|
| Reserve_Y6 | — | Y6 | — | _ | 11 |
| Reserve_AA1 | — | AA1 | — | _ | 11 |
| Reserve_AA2 | — | AA2 | — | — | 11 |
| Reserve_AA3 | — | AA3 | — | — | 11 |
| Reserve_AA4 | - | AA4 | — | _ | 11 |
| Reserve_AB1 | — | AB1 | — | _ | 11 |
| Reserve_AB2 | - | AB2 | — | — | 11 |
| Reserve_AB3 | - | AB3 | — | _ | 11 |
| Reserve_AC1 | — | AC1 | — | _ | 11 |
| Reserve_AC3 | - | AC3 | — | — | 11 |
| Reserve_AC4 | — | AC4 | — | _ | 11 |
| Reserve_AD1 | — | AD1 | — | _ | 11 |
| Reserve_AD2 | — | AD2 | — | — | 11 |
| Reserve_AE1 | — | AE1 | — | _ | 11 |
| Reserve_AE2 | — | AE2 | — | _ | 11 |
| Reserve_AE3 | - | AE3 | — | — | 11 |
| Reserve_AF1 | - | AF1 | — | — | 11 |
| Reserve_AF3 | — | AF3 | — | _ | 11 |
| Reserve_AF4 | — | AF4 | — | — | 11 |
| Reserve_AF11 | - | AF11 | — | — | 11 |
| Reserve_AF12 | - | AF12 | — | — | 11 |
| Reserve_AG1 | — | AG1 | — | — | 11 |
| Reserve_AG2 | — | AG2 | — | — | 11 |
| Reserve_AG4 | - | AG4 | — | _ | 11 |
| Reserve_AG25 | — | AG25 | — | — | 11 |
| Reserve_AH1 | — | AH1 | — | — | 11 |
| Reserve_AH2 | - | AH2 | — | _ | 11 |
| Reserve_AH3 | — | AH3 | — | — | 11 |
| Reserve_AH29 | — | AH29 | — | — | 11 |
| Reserve_AJ1 | — | AJ1 | — | — | 11 |
| Reserve_AJ3 | — | AJ3 | — | | 11 |
| Reserve_AJ4 | — | AJ4 | | _ | 11 |
| Reserve_AK1 | — | AK1 | — | _ | 11 |
| Reserve_AK2 | — | AK2 | — | _ | 11 |

| Table 1 | Pins | List | by | Bus | (continued) |
|---------|------|------|----|-----|-------------|
|---------|------|------|----|-----|-------------|

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|-------------|--------------------|-----------------------|-------------|-----------------|-------|
| Reserve_AK4 | _ | AK4 | — | | 11 |
| Reserve_AK5 | _ | AK5 | — | — | 11 |
| Reserve_AL1 | — | AL1 | — | _ | 11 |
| Reserve_AL2 | _ | AL2 | — | — | 11 |
| Reserve_AL3 | _ | AL3 | — | _ | 11 |
| Reserve_AL5 | _ | AL5 | — | _ | 11 |
| Reserve_AL6 | _ | AL6 | — | | 11 |
| Reserve_AM1 | _ | AM1 | — | _ | 11 |
| Reserve_AM3 | _ | AM3 | — | _ | 11 |
| Reserve_AM4 | _ | AM4 | — | — | 11 |
| Reserve_AM6 | — | AM6 | — | — | 11 |
| Reserve_AM7 | — | AM7 | — | — | 11 |
| Reserve_AN1 | — | AN1 | — | _ | 11 |
| Reserve_AN2 | — | AN2 | — | — | 11 |
| Reserve_AN4 | _ | AN4 | — | — | 11 |
| Reserve_AN5 | _ | AN5 | — | — | 11 |
| Reserve_AP1 | _ | AP1 | — | — | 11 |
| Reserve_AP2 | _ | AP2 | — | _ | 11 |
| Reserve_AP3 | — | AP3 | — | — | 11 |
| Reserve_AP5 | — | AP5 | — | _ | 11 |
| Reserve_AP6 | — | AP6 | — | — | 11 |
| Reserve_AP8 | — | AP8 | — | — | 11 |
| Reserve_AR1 | _ | AR1 | — | — | 11 |
| Reserve_AR3 | — | AR3 | — | _ | 11 |
| Reserve_AR4 | — | AR4 | — | — | 11 |
| Reserve_AR6 | _ | AR6 | — | — | 11 |
| Reserve_AR7 | — | AR7 | — | — | 11 |
| Reserve_AT1 | _ | AT1 | — | — | 11 |
| Reserve_AT2 | _ | AT2 | — | — | 11 |
| Reserve_AT3 | — | AT3 | — | — | 11 |
| Reserve_AT4 | — | AT4 | — | _ | 11 |
| Reserve_AT5 | — | AT5 | — | _ | 11 |
| Reserve_AT6 | — | AT6 | — | — | 11 |
| Reserve_AT7 | — | AT7 | — | _ | 11 |

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------------|--------------------|-----------------------|-------------|-----------------|-------|
| Reserve_AT8 | _ | AT8 | — | — | 11 |
| Reserve_AT19 | _ | AT19 | — | _ | 11 |

Notes:

- 1. Recommend that a weak pull-up resistor (2–10 K Ω) be placed on this pin to OVDD.
- 2. This pin is an open drain signal.
- 3. This pin is a reset configuration pin. It has a weak internal pull-up P-FET which is enabled only when the processor is in the reset state. This pull-up is designed such that it can be overpowered by an external 4.7-kΩ resistor. However, if the signal is intended to be high after reset and if there is any device on the net that may pull down the value of the net at reset, a pull up or active driver is needed.
- 4. Functionally, this pin is an output, but structurally it is an I/O because it either samples configuration input during reset or because it has other manufacturing test functions. This pin is therefore described as an I/O for boundary scan.
- 5. Recommend that a weak pull-up resistor (2–10 k Ω) be placed on this pin to BV_{DD} to ensure no random chip select assertion due to possible noise, etc.
- 6. This output is actively driven during reset rather than being three-stated during reset.
- 7. These JTAG pins have weak internal pull-up P-FETs that are always enabled.
- 8. These pins are connected to the correspondent power and ground nets internally and may be connected as a differential pair to be used by the voltage regulators with remote sense function. For Rev1.1, the better solution is to use the far sense pins relative to the power supply location, the other pair can be left as no connected. The DC power simulation should be done during the board layout process to approve the selected solution.
- 9. These pins may be connected to a thermal diode monitoring device such as the ADT7461A. If a thermal diode monitoring device is not connected, these pins may be connected to test point or left as a no connect.
- 11. Do not connect.
- 12. These are test signals for factory use only and must be pulled down (1 k Ω -2 k Ω) to GND for normal machine operation.
- 13. Independent supplies derived from board V_{DD CA CB PL} (core clusters, platform, DDR) or SV_{DD} (SerDes).
- 14. Recommend that a pull-up resistor (1 k Ω) be placed on this pin to OV_{DD} if I²C interface is used.
- 15. This pin requires an external 1 kΩ pull-down resistor to prevent PHY from seeing a valid Transmit Enable before it is actively driven.
- 16. For DDR3 and DDR3L, $Dn_MDIC[0]$ is grounded through an $20-\Omega$ (full-strength mode) or $40.2-\Omega$ (half-strength mode) precision 1% resistor and $Dn_MDIC[1]$ is connected to GV_{DD} through an $20-\Omega$ (full-strength mode) or $40.2-\Omega$ (half-strength mode) precision 1% resistor. These pins are used for automatic calibration of the DDR3 and DDR3L IOs.
- 18. These pins must be pulled up to 1.2V through a 180 $\Omega \pm 1\%$ resistor for EM2_MDC and a 330 $\Omega \pm 1\%$ resistor for EM2_MDIO.
- 20. Pin has a weak internal pull-up.
- 21. These pins must be pulled to ground (GND).
- 22. Ethernet MII Management Interface 2 pins function as open drain I/Os. The interface conforms to 1.2 V nominal voltage levels. LV_{DD} must be powered to use this interface.
- 23. This pin requires a 200- Ω pull-up to XV_{DD}.
- 24. This pin requires a 200- Ω pull-up to SV_{DD}.
- 25. This GPIO pin is on LV_{DD} power plane, not OV_{DD}.
- 26. Functionally, this pin is an I/O, but may act as an output only or an input only depending on the pin mux configuration defined by the RCW (Reset Configuration Word).
- 27. See Section 3.6, "Connection Recommendations," for additional details on this signal.

| Signal | Signal Description | Package Pin Number | Pin Type | Power Supply | Notes |
|--------|--------------------|-----------------------|-------------|-----------------|-------|
|--------|--------------------|-----------------------|-------------|-----------------|-------|

28. For reduced core (core 2 and 3 disabled) mode, this signal must be pulled high (100 Ω -1 k Ω) to OVDD.

- 30. Warning, incorrect voltage select settings can lead to irreversible device damage. This pin has an internal 2 k Ω pull-down resistor, to pull it high, a pull-up resistor of less than 1 kΩ to OVDD should be used. See Section 3.2, "Supply Power Default Setting."
- 31. SDHC_DAT[4:7] require CV_{DD} = 3.3 V when muxed extended SDHC data signals are enabled via the RCW[SPI] field.
- 32. The cfg_xvdd_sel (LAD[26]) reset configuration pin must select the correct voltage that is being supplied on the XV_{DD} pin. Incorrect voltage select settings can lead to irreversible damage to the device.
- 33. See Section 2.2, "Power-Up Sequencing and Section 5, "Security Fuse Processor," for additional details on this signal.
- 35. Pin must NOT be pulled down during power-on reset.
- 36. This pin must be connected to GND through a 10 k $\Omega \pm 0.1\%$ resistor with a low temperature coefficient of \leq 25 ppm/°C for bias generation.
- 37. A 1µF to 1.5 µF capacitor connected to GND is required on this signal. A list of recommended capacitors are shown in Section 3.6.4.2, "USBn_V_{DD}_1P8_DECAP Capacitor Options."
- 38. A divider network is required on this signal. See Section 3.6.4, "USB Controller Connections."
- 39. These are test signals for factory use only and must be pulled up (100 Ω -1 k Ω) to OVDD for normal machine operation.
- 40. For systems which boot from Local Bus (GPCM)-controlled NOR flash or (FCM)-controlled NAND flash, a pull up on LGPL4 is required.
- 41. Core Group A and Platform supply (V_{DD CA PL}) and Core Group B supply (V_{DD CB}) were separate supplies in Rev1.0, they are tied together in Rev1.1.

Electrical Characteristics 2

This section provides the AC and DC electrical specifications for the chip. The chip is currently targeted to these specifications, some of which are independent of the I/O cell but are included for a more complete reference. These are not purely I/O buffer design specifications.

2.1 **Overall DC Electrical Characteristics**

This section describes the ratings, conditions, and other electrical characteristics.

2.1.1Absolute Maximum Ratings

This table provides the absolute maximum ratings.

| Table 2. Absolute Operati | | | | |
|---|--------------------------|--------------|------|-------|
| Parameter | Symbol | Max Value | Unit | Notes |
| Cores Group A (core 0–1) and Platform supply voltage (Silicon Rev 1.0) | V _{DD_CA_PL} | -0.3 to 1.1 | V | 9, 10 |
| Cores Group B (core 2–3) supply voltage (Silicon Rev 1.0) | V _{DD_CB} | -0.3 to 1.1 | V | 9, 10 |
| Cores Group A (core 0–1), Core Group B (core 2–3) and Platform supply voltage (Silicon Rev 1.1) | V _{DD_CA_CB_PL} | -0.3 to 1.1 | V | 9, 10 |
| PLL supply voltage (core, platform, DDR) | AV _{DD} | -0.3 to 1.1 | V | — |
| PLL supply voltage (SerDes, filtered from SV _{DD}) | AV _{DD_SRDS} | -0.3 to 1.1 | V | — |
| Fuse programming override supply | POV _{DD} | -0.3 to 1.65 | V | 1 |

Table 2 Absolute Operating Conditions¹

P3041 QorlQ Integrated Processor Hardware Specifications, Rev. 2

| | Parameter | Symbol | Max Value | Unit | Notes |
|----------------------------|--|--------------------------|--|------|-------|
| | MPIC, GPIO, system control and power king, debug, I/O voltage select, and JTAG I/O voltage | OV _{DD} | -0.3 to 3.63 | V | — |
| eSPI, eSHDC | | CV _{DD} | -0.3 to 3.63 -0.3 to 2.75 -0.3 to 1.98 | V | — |
| DDR3 and DDR3L | DRAM I/O voltage | GV _{DD} | -0.3 to 1.65 | V | — |
| Enhanced Local B | us I/O voltage | BV _{DD} | -0.3 to 3.63 -0.3 to 2.75 -0.3 to 1.98 | V | — |
| Core power supply | r for SerDes transceivers | SV _{DD} | -0.3 to 1.1 | V | _ |
| Pad power supply | for SerDes transceivers | XV _{DD} | -0.3 to 1.98 -0.3 to 1.65 | V | — |
| Ethernet I/O, Ether | rnet Management Interface 1 (EMI1), 1588, GPIO | LV _{DD} | -0.3 to 3.63 -0.3 to 2.75 | V | 3 |
| Ethernet Managen | nent Interface 2 (EMI2) | LV _{DD} | -0.3 to 1.32 | V | 8 |
| USB PHY Transce | iver supply voltage | USB_V _{DD} _3P3 | -0.3 to 3.63 | V | — |
| USB PHY PLL sup | pply voltage | USB_V _{DD} _1P0 | -0.3 to 1.1 | V | — |
| Low Power Securit | y Monitor Supply | V _{DD_LP} | -0.3 to 1.1 | V | _ |
| Input voltage ⁷ | DDR3 and DDR3L DRAM signals | MV _{IN} | –0.3 to (GV _{DD} + 0.3) | V | 2, 7 |
| | DDR3 and DDR3L DRAM reference | MV _{REF} n | -0.3 to (GV _{DD} /2+ 0.3) | V | 2, 7 |
| | Ethernet signals (except EMI2) | LV _{IN} | -0.3 to (LV _{DD} + 0.3) | V | 3, 7 |
| | eSPI, eSHDC | CVIN | -0.3 to (CV _{DD} + 0.3) | V | 4, 7 |
| | Enhanced Local Bus signals | BV _{IN} | -0.3 to (BV _{DD} + 0.3) | V | 5, 7 |
| | DUART, I ² C, DMA, MPIC, GPIO, system control and power management, clocking, debug, I/O voltage select, and JTAG I/O voltage | OV _{IN} | -0.3 to (OV _{DD} + 0.3) | V | 6, 7 |
| | SerDes signals | XV _{IN} | -0.4 to (XV _{DD} + 0.3) | V | 7 |
| | USB PHY Transceiver signals | USB_V _{IN} _3P3 | -0.3 to (USB_V _{DD} _3P3 + 0.3) | V | 7 |
| | Ethernet Management Interface 2 (EMI2) signals | | -0.3 to (1.2 + 0.3) | V | 7 |

Table 2. Absolute Operating Conditions¹ (continued)

Table 2. Absolute Operating Conditions¹ (continued)

| Parameter | Symbol | Max Value | Unit | Notes |
|------------------------------------|------------------|------------|------|-------|
| Storage junction temperature range | T _{stg} | –55 to 150 | °C | |

Note:

- 1. Functional operating conditions are given in Table 3. Absolute maximum ratings are stress ratings only; functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.
- 2. **Caution:** MV_{IN} must not exceed GV_{DD} by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 3. Caution: LV_{IN} must not exceed LV_{DD} by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 4. **Caution:** CV_{IN} must not exceed CV_{DD} by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 5. Caution: BV_{IN} must not exceed BV_{DD} by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 6. Caution: OV_{IN} must not exceed OV_{DD} by more than 0.3 V. This limit may be exceeded for a maximum of 20 ms during power-on reset and power-down sequences.
- 7. (C,X,B,G,L,O)V_{IN} may overshoot (for V_{IH}) or undershoot (for V_{IL}) to the voltages and maximum duration shown in Figure 7.
- Ethernet MII Management Interface 2 pins function as open drain I/Os. The interface conforms to 1.2 V nominal voltage levels. LV_{DD} must be powered to use this interface.
- 9. Supply voltage specified at the voltage sense pin. Voltage input pins must be regulated to provide specified voltage at the sense pin.
- 10. Core Group A and Platform supply (V_{DD_CA_PL}) and Core Group B supply (V_{DD_CB}) were separate supplies in Rev1.0, they are tied together in Rev1.1.

2.1.2 Recommended Operating Conditions

This table provides the recommended operating conditions for this device. Note that proper device operation outside these conditions is not guaranteed.

| Parameter | Symbol | Recommended Value | Unit | Notes |
|--|--------------------------|--|------|-------|
| Cores Group A (core 0–1) and Platform supply voltage (Silicon Rev 1.0) | V _{DD_CA_PL} | 1.0 ± 40 mV (CPU speed > 1333 MHz) 1.0 ± 50 mV (CPU speed ≤ 1333 MHz) | V | 5, 6 |
| Cores Group B (core 2–3) supply voltage (Silicon Rev 1.0) | V _{DD_CB} | 1.0 ± 40 mV (CPU speed > 1333 MHz) 1.0 ± 50 mV (CPU speed ≤ 1333 MHz) | V | 5, 6 |
| Cores Group A (core 0–1), Core Group B (core 2–3) and Platform supply voltage (Silicon Rev 1.1) | V _{DD_CA_CB_PL} | 1.0 ± 40 mV (CPU speed > 1333 MHz) 1.0 ± 50 mV (CPU speed ≤ 1333 MHz) | V | 5, 6 |
| PLL supply voltage (core, platform, DDR) | AV _{DD} | 1.0 ± 40 mV (CPU speed > 1333 MHz) 1.0 ± 50 mV (CPU speed ≤ 1333 MHz) | V | _ |
| PLL supply voltage (SerDes) | AV _{DD_SRDS} | 1.0 ± 50 mV | V | — |
| Fuse programming override supply | POV _{DD} | 1.5 ± 75 mV | V | 1 |

Table 3. Recommended Operating Conditions

| | Parameter | | Recommended Value | Unit | Notes |
|--------------------------|---|--------------------------|---|------|-------|
| | MA, MPIC, GPIO, system control and power locking, debug, I/O voltage select, and JTAG | OV _{DD} | 3.3 ± 165 mV | V | _ |
| eSPI, eSDHC | | CV _{DD} | 3.3 ± 165 mV 2.5 ± 125 mV 1.8 ± 90 mV | V | - |
| DDR DRAM I/C |) voltage DDR3 DDR3L | GV _{DD} | 1.5 ± 75 mV 1.35 ± 67 mV | V | - |
| Enhanced Loca | I Bus I/O voltage | BV _{DD} | 3.3 ± 165 mV 2.5 ± 125 mV 1.8 ± 90 mV | V | - |
| Core power sup | oply for SerDes transceivers | SV _{DD} | 1.0 ± 50 mV | V | — |
| Pad power sup | bly for SerDes transceivers | XV _{DD} | 1.8 ± 90 mV 1.5 ± 75 mV | V | - |
| Ethernet I/O, Et GPIO | hernet Management Interface 1 (EMI1),1588, | LV _{DD} | 3.3 ± 165 mV 2.5 ± 125 mV | V | 2 |
| USB PHY trans | ceiver supply voltage | USB_V _{DD} _3P3 | 3.3 ± 165 mV | V | — |
| USB PHY PLL | supply voltage | USB_V _{DD} _1P0 | 1.0 ± 50 mV | V | — |
| Low Power Sec | urity Monitor Supply | V _{DD_LP} | 1.0 ± 50 mV | V | — |
| Input voltage | DDR3 and DDR3L DRAM signals | MV _{IN} | GND to GV _{DD} | V | — |
| | DDR3 and DDR3L DRAM reference | MV _{REF} | $GV_{DD}/2 \pm 1\%$ | V | — |
| | Ethernet signals (except EMI2) | LV _{IN} | GND to LV _{DD} | V | — |
| | eSPI, eSHDC | CV _{IN} | GND to CV _{DD} | V | — |
| | Enhanced Local Bus signals | BV _{IN} | GND to BV _{DD} | V | — |
| | DUART, I ² C, DMA, MPIC, GPIO, system control and power management, clocking, debug, I/O voltage select, and JTAG I/O voltage | OV _{IN} | GND to OV _{DD} | V | _ |
| | SerDes signals | XV _{IN} | GND to XV _{DD} | V | — |
| | USB PHY transceiver signals | USB_V _{IN} _3P3 | GND to USB_V _{DD} _3P3 | V | — |
| | Ethernet Management Interface 2 (EMI2) signals | — | GND to 1.2 V | V | 4 |

Table 3. Recommended Operating Conditions (continued)

| | Parameter | Symbol | Recommended Value | Unit | Notes |
|--------------------------|------------------------------|------------------------------------|---|------|-------|
| Operating Temperature | Normal Operation | T _A , T _J | T _A = 0 (min) to T _J = 105 (max) | °C | — |
| range | Extended Operation | T _A , T _J | T _A = -40 (min) to T _J = 105 (max) | °C | — |
| | Secure Boot Fuse Programming | T _A , T _J | T _A = 0(min) to T _J = 70 (max) | °C | 1 |

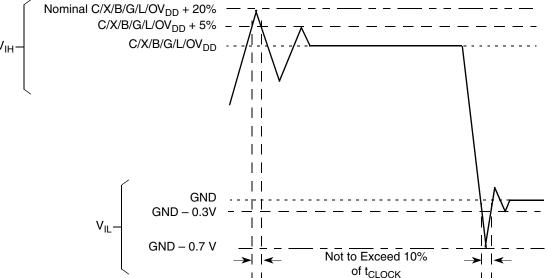
Table 3. Recommended Operating Conditions (continued)

Note:

1. POV_{DD} must be supplied 1.5 V and the chip must operate in the specified fuse programming temperature range only during secure boot fuse programming. For all other operating conditions, POV_{DD} must be tied to GND, subject to the power sequencing constraints shown in Section 2.2, "Power-Up Sequencing."

- 2. Selecting RGMII limits LV_{DD} to 2.5 V.
- 3. Unless otherwise stated in an interface's DC specifications, the maximum allowed input capacitance in this table is a general recommendation for signals.
- 4. Ethernet MII Management Interface 2 pins function as open drain I/Os. The interface conforms to 1.2 V nominal voltage levels. LV_{DD} must be powered to use this interface.
- 5. Supply voltage specified at the voltage sense pin. Voltage input pins must be regulated to provide specified voltage at the sense pin.
- 6. Core Group A and Platform supply (V_{DD_CA_PL}) and Core Group B supply (V_{DD_CB}) were separate supplies in Rev1.0, they are tied together in Rev1.1.

This figure shows the undershoot and overshoot voltages at the interfaces of the chip.



Note:

 $t_{\text{CLOCK}} \text{ refers to the clock period associated with the respective interface:} \\ For I2C, t_{\text{CLOCK}} \text{ refers to SYSCLK}. \\ For DDR GV_{DD}, t_{\text{CLOCK}} \text{ refers to Dn_MCK}. \\ For eSPI CV_{DD}, t_{\text{CLOCK}} \text{ refers to SPI_CLK}. \\ For eLBC BV_{DD}, t_{\text{CLOCK}} \text{ refers to LCLK}. \\ For SerDes XV_{DD}, t_{\text{CLOCK}} \text{ refers to SD_REF_CLK}. \\ For dTSEC LV_{DD}, t_{\text{CLOCK}} \text{ refers to EC_GTX_CLK125}. \\ For JTAG OV_{DD}, t_{\text{CLOCK}} \text{ refers to TCK}. \\$

Figure 7. Overshoot/Undershoot Voltage for BV_{DD}/GV_{DD}/UV_{DD}/OV_{DD}

The core and platform voltages must always be provided at nominal 1.0 V. See Table 3 for the actual recommended core voltage conditions. Voltage to the processor interface I/Os is provided through separate sets of supply pins and must be provided at the voltages shown in Table 3. The input voltage threshold scales with respect to the associated I/O supply voltage. CV_{DD} , BV_{DD} , OV_{DD} , and LV_{DD} -based receivers are simple CMOS I/O circuits and satisfy appropriate LVCMOS type specifications. The DDR SDRAM interface uses differential receivers referenced by the externally supplied $MV_{REF}n$ signal (nominally set to $GV_{DD}/2$) as is appropriate for the SSTL_1.5/SSTL_1.35 electrical signaling standard. The DDR DQS receivers cannot be operated in single-ended fashion. The complement signal must be properly driven and cannot be grounded.

2.1.3 Output Driver Characteristics

This table provides information about the characteristics of the output driver strengths. The values are preliminary estimates.

| Driver Type | Output Impedance (Ω) | (Nominal) Supply Voltage | Notes | |
|---------------------------------------|--|--|-------|--|
| Local Bus interface utilities signals | 45 45 45 | BV _{DD} = 3.3 V BV _{DD} = 2.5 V BV _{DD} = 1.8 V | _ | |
| DDR3 signal | 20 (full-strength mode) 40 (half-strength mode) | GV _{DD} = 1.5 V | 1 | |
| DDR3L signal | 20 (full-strength mode) 40 (half-strength mode) | GV _{DD} = 1.35 V | 1 | |
| eTSEC/10/100 signals | 45 45 | LV _{DD} = 3.3 V LV _{DD} = 2.5 V | _ | |
| DUART, system control, JTAG | 45 | OV _{DD} = 3.3 V | — | |
| I ² C | 45 | OV _{DD} = 3.3 V | — | |
| eSPI | 45 45 45 | CV _{DD} = 3.3 V CV _{DD} = 2.5 V CV _{DD} = 1.8 V | _ | |

| Table | 4. | Output | Drive | Capability |
|-------|----|--------|-------|------------|
| | | | | Japanny |

Note:

1. The drive strength of the DDR3 or DDR3L interface in half-strength mode is at $T_i = 105$ °C and at GV_{DD} (min).

2.2 Power-Up Sequencing

The chip requires that its power rails be applied in a specific sequence in order to ensure proper device operation. For power up, these requirements are as follows:

- 1. Bring up OV_{DD} , LV_{DD} , BV_{DD} , CV_{DD} , and USB_VDD_3P3 . Drive $POV_{DD} = GND$.
 - **PORESET** input must be driven asserted and held during this step.
 - IO_VSEL inputs must be driven during this step and held stable during normal operation.
 - USB_V_{DD}_3P3 rise time (10% to 90%) has a minimum of 350 μ s.
- 2. Bring up V_{DD_CA_CB_PL}, SV_{DD}, AV_{DD} (cores, platform, DDR, SerDes), and USB_V_{DD}_1P0. V_{DD_CA_CB_PL} and USB_VDD_1P0 must be ramped up simultaneously.
- 3. Bring up GV_{DD} (DDR), XV_{DD} .
- 4. Negate PORESET input as long as the required assertion/hold time has been met per Table 17.
- 5. For secure boot fuse programming, use the following steps:
 - a) After negation of $\overline{\text{PORESET}}$, drive $\text{POV}_{\text{DD}} = 1.5 \text{ V}$ after a required minimum delay per Table 5.

b) After fuse programming is completed, it is required to return $POV_{DD} = GND$ before the system is power cycled (PORESET assertion) or powered down ($V_{DD_CA_CB_PL}$ ramp down) per the required timing specified in Table 5. See Section 5, "Security Fuse Processor," for additional details.

WARNING

Only two secure boot fuse programming events are permitted per lifetime of a device.

No activity other than that required for secure boot fuse programming is permitted while POV_{DD} driven to any voltage above GND, including the reading of the fuse block. The reading of the fuse block may only occur while $POV_{DD} = GND$.

While VDD is ramping, current may be supplied from VDD through the P3041 to GVDD. Nevertheless, GVDD from an external supply should follow the sequencing described above.

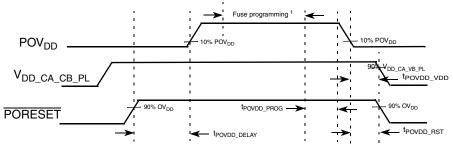
WARNING

Only 100,000 POR cycles are permitted per lifetime of a device.

All supplies must be at their stable values within 75 ms.

Items on the same line have no ordering requirement with respect to one another. Items on separate lines must be ordered sequentially such that voltage rails on a previous step must reach 90% of their value before the voltage rails on the current step reach 10% of theirs.

This figure provides the POV_{DD} timing diagram.



NOTE: POV_{DD} must be stable at 1.5 V prior to initiating fuse programming.

Figure 8. POV_{DD} Timing Diagram

This table provides information on the power-down and power-up sequence parameters for POV_{DD}.

Table 5. POV_{DD} Timing ⁵

| Driver Type | Min | Мах | Unit | Notes |
|--------------------------|-----|-----|---------|-------|
| t _{POVDD_DELAY} | 100 | — | SYSCLKs | 1 |

Table 5. POV_{DD} Timing ⁵

| Driver Type | Min | Мах | Unit | Notes |
|-------------|-----|-----|------|-------|
| tpovdd_prog | 0 | — | μs | 2 |
| tpovdd_vdd | 0 | — | μs | 3 |
| tpovdd_rst | 0 | — | μs | 4 |

Note:

- 1. Delay required from the negation of PORESET to driving POV_{DD} ramp up. Delay measured from PORESET negation at 90% OV_{DD} to 10% POV_{DD} ramp up.
- 2. Delay required from fuse programming finished to POV_{DD} ramp down start. Fuse programming must complete while POV_{DD} is stable at 1.5 V. No activity other than that required for secure boot fuse programming is permitted while POV_{DD} driven to any voltage above GND, including the reading of the fuse block. The reading of the fuse block may only occur while $POV_{DD} = GND$. After fuse programming is completed, it is required to return $POV_{DD} = GND$.
- 3. Delay required from POV_{DD} ramp down complete to V_{DD_CA_CB_PL} ramp down start. POV_{DD} must be grounded to minimum 10% POV_{DD} before V_{DD_CA_CB_PL} is at 90% V_{DD}.
- 4. Delay required from POV_{DD} ramp down complete to PORESET assertion. POV_{DD} must be grounded to minimum 10% POV_{DD} before PORESET assertion reaches 90% OV_{DD}.
- 5. Only two secure boot fuse programming events are permitted per lifetime of a device.

To guarantee MCKE low during power up, the above sequencing for GV_{DD} is required. If there is no concern about any of the DDR signals being in an indeterminate state during power up, the sequencing for GV_{DD} is not required.

WARNING

Incorrect voltage select settings can lead to irreversible device damage. See Section 3.2, "Supply Power Default Setting."

NOTE

From a system standpoint, if any of the I/O power supplies ramp prior to the $V_{DD_CA_CB_PL}$ supplies, the I/Os associated with that I/O supply may drive a logic one or zero during power-up, and extra current may be drawn by the device.

2.3 **Power-Down Requirements**

The power-down cycle must complete such that power supply values are below 0.4 V before a new power-up cycle can be started.

If performing secure boot fuse programming per Section 2.2, "Power-Up Sequencing," it is required that $POV_{DD} = GND$ before the system is power cycled (PORESET assertion) or powered down ($V_{DD_CA_CB_PL}$ ramp down) per the required timing specified in Table 5.

 $V_{DD_CA_CB_PL}$ and USB_VDD_1P0 must be ramped down simultaneously. USB_V_DD_1P8_DECAP should start ramping down only after USB_V_DD_3P3 is below 1.65 V.

2.4 **Power Characteristics**

This table shows the power dissipations of the $V_{DD_CA_CB_PL}$ and SV_{DD} supply for various operating platform clock frequencies versus the core and DDR clock frequencies. Note that these numbers are based on design estimates only and are preliminary. More accurate power numbers are available after the measurement on the silicon is complete.

| Power Mode | Core Freq (MHz) | Plat Freq (MHz) | DDR Data Rate (MT/s) | FM Freq (MHz) | V _{DD_CA_CB_PL} (V) | Junction Temp (°C) | Core and Platform Power ¹ (W) | V _{DD_CA_CB_PL} Power (W) | Power ¹ (W) | V _{DD_CA_CB_PL} Power (W) al cores | SV _{DD} Power (W) | Notes |
|---------------|-----------------------|-----------------------|-------------------------------|---------------------|---------------------------------|--------------------------|---|--|---------------------------|--|----------------------------------|---------|
| | | | | | | | Gui | | 50 | | | |
| Typical | 1500 | 750 | 1333 | 583 | 1.0 | 65 | 13.8 | — | 13.1 | — | — | 2, 3 |
| Thermal | | | | | | 105 | 19.2 | — | 18.7 | — | _ | 5,7 |
| Maximum | | | | | | | 19.9 | 18.1 | 19.0 | 17.1 | 2.0 | 4, 6, 7 |
| Typical | 1333 | 666 | 1333 | 541 | 1.0 | 65 | 12.2 | _ | 11.7 | — | | 2, 3 |
| Thermal | | | | | | 105 | 16.9 | _ | 16.4 | — | _ | 5, 7 |
| Maximum | | | | | | | 17.5 | 15.7 | 16.7 | 14.8 | 2.0 | 4, 6, 7 |
| Typical | 1200 | 600 | 1200 | 500 | 1.0 | 65 | 10.9 | — | 10.4 | — | _ | 2, 3 |
| Thermal | | | | | | 105 | 14.8 | _ | 14.4 | — | _ | 5, 7 |
| Maximum | | | | | | | 15.4 | 13.5 | 14.6 | 12.8 | 2.0 | 4, 6, 7 |

Table 6. Power Dissipation

Note:

1. Combined power of V_{DD_CA_CB_PL}, SVDD with one DDR controller and all SerDes banks active. Does not include I/O power.

2. Typical power assumes Dhrystone running with activity factor of 70% on all four cores, 80% on two cores and executing DMA on the platform with 90% activity factor.

- 3. Typical power based on nominal processed device.
- 4. Maximum power assumes Dhrystone running with activity factor at 100% on all cores and executing DMA on the platform with 100% activity factor.
- 5. Thermal power assumes Dhrystone running with activity factor of 70% on all four cores, 80% on two cores and executing DMA on the platform. with 90% activity factor.
- 6. Maximum power provided for power supply design sizing.
- 7. Thermal and maximum power are based on worst case processed device.

This table shows the all I/O power supply estimated values.

| Interface | Parameter | Symbol | Typical | Maximum | Unit | Notes |
|--------------------------------|---------------------|-------------|---------|---------|------|---------|
| DDR3 64 Bits Per Controller | 667 MT/s data rate | GVdd (1.5V) | 0.705 | 1.764 | W | 1,2,5,6 |
| | 800 MT/s data rate | | 0.714 | 1.785 | | |
| | 1066 MT/s data rate | | 0.731 | 1.827 | | |
| | 1200 MT/s data rate | | 0.739 | 1.848 | | |
| | 1333 MT/s data rate | | 0.747 | 1.869 | | |

Electrical Characteristics

| HSSI: PCI-e, SGMII, SATA, SRIO, Aurora, Debug, XAUI | x1, 1.25 G-baud | XVdd (1.5V) | 0.078 | 0.087 | W | 1,7 |
|--|------------------------------|-------------|-------|-------|---|---------|
| | x2, 1.25 G-baud | | 0.119 | 0.134 | | |
| | x4, 1.25 G-baud | | 0.202 | 0.226 | | |
| | x8, 1.25 G-baud | | 0.367 | 0.411 | | |
| | x1, 2.5/3.0/3.125/5.0 G-baud | | 0.088 | 0.099 | | |
| | x2, 2.5/3.0/3.125/5.0 G-baud | | 0.139 | 0.156 | | |
| | x4, 2.5/3.0/3.125/5.0 G-baud | | 0.241 | 0.270 | | |
| | x8, 2.5/3.0/3.125/5.0 G-baud | | 0.447 | 0.501 | | |
| dTSEC (per controller) | RGMII | LVdd (2.5V) | 0.075 | 0.100 | w | 1,3,6 |
| IEEE 1588 | — | LVdd (2.5V) | 0.004 | 0.005 | W | 1,3,6 |
| eLBC | 32-bit, 100Mhz | BVdd (1.8V) | 0.048 | 0.120 | W | 1,3,6 |
| | | BVdd (2.5V) | 0.072 | 0.193 | | |
| | | BVdd (3.3V) | 0.120 | 0.277 | | |
| | 16-bit, 100Mhz | BVdd (1.8V) | 0.021 | 0.030 | W | 1,3,6 |
| | | BVdd (2.5V) | 0.036 | 0.046 | | |
| | | BVdd (3.3V) | 0.057 | 0.076 | | |
| eSDHC | _ | Ovdd (3.3V) | 0.014 | 0.150 | W | 1,3,6 |
| eSPI | _ | CVdd (1.8V) | 0.004 | 0.005 | W | 1,3,6 |
| | | CVdd (2.5V) | 0.006 | 0.008 | | |
| | | CVdd (3.3V) | 0.010 | 0.013 | | |
| USB | — | USB_Vdd_3P3 | 0.012 | 0.015 | W | 1,3,6 |
| I2C | — | OVdd (3.3V) | 0.002 | 0.003 | W | 1,3,6 |
| DUART | — | OVdd (3.3V) | 0.006 | 0.008 | W | 1,3,6 |
| GPIO | x8 | OVdd (1.8V) | 0.005 | 0.006 | W | 1,3,4,6 |
| | | OVdd (2.5V) | 0.007 | 0.009 | | |
| | | OVdd (3.3V) | 0.009 | 0.011 | | |

Table 7. P3041 I/O Power Supply Estimated Values (continued)

Table 7. P3041 I/O Power Supply Estimated Values (continued)

| Others (Reset, System | _ | OVdd (3.3V) | 0.003 | 0.015 | W | 1,3,4,6 |
|-----------------------|---|-------------|-------|-------|---|---------|
| Clock, JTAG & Misc.) | | | | | | |

Note:

- 1. The typical values are estimates and based on simulations at 65 °C.
- 2. Typical DDR power numbers are based on one 2-rank DIMM with 40% utilization.
- 3. Assuming 15 pF total capacitance load
- 4. GPIO's are supported on 1.8V, 2.5V and 3.3V rails, as specified in the hardware specification.
- 5. Maximum DDR power numbers are based on one 2-rank DIMM with 100% utilization.
- 6. The maximum values are estimated and they are based on simulations at 105 °C. The values are not intended to be used as the maximum guranteed current.
- 7. The total power numbers of XVDD is dependent on customer application use case. This table lists all the SerDes configuration combination possible for the device. To get the XVDD power numbers, the user should add the combined lanes to match to the total SerDes lanes used, not simply multiply the power numbers by the number of lanes.

This table shows the estimated power dissipation on the AV_{DD} and AV_{DD_SRDS} supplies for the PLLs at allowable voltage levels.

| AV _{DD} s | Typical | Maximum | Unit | Notes |
|--------------------------|---------|---------|------|-------|
| AV _{DD_DDR} | 5 | 15 | mW | 1 |
| AV _{DD_CC1} | | | | |
| AV _{DD_CC2} | | | | |
| AV _{DD_PLAT} | | | | |
| AV _{DD_SRDS1} | - | 36 | mW | 2 |
| AV _{DD_SRDS2} | | | | |
| AV _{DD_SRDS3} | | | | |
| USB_V _{DD} _1P0 | _ | 10 | mW | 3 |

Table 8. AV_{DD} Power Dissipation

Note:

1. V_{DD CA CB PL} = 1.0 V, $T_A = 80^{\circ}C$, $T_J = 105^{\circ}C$

2. SV_{DD} = 1.0 V, T_A = 80°C, T_J = 105°C

3. USB_V_{DD}_1P0 = 1.0V, T_A = 80°C, T_J = 105°C

This table shows the estimated power dissipation on the POV_{DD} supply for the P3041, at allowable voltage levels.

Table 9. POV_{DD} Power Dissipation

| Supply | Maximum | Unit | Notes |
|-------------------|---------|------|-------|
| POV _{DD} | 450 | mW | 1 |

Note:

1. To ensure device reliability, fuse programming must be performed within the recommended fuse programming temperature range per Table 3.

This table shows the estimated power dissipation on the V_{DD LP} supply for the P3041, at allowable voltage levels.

Table 10. V_{DD LP} Power Dissipation

| Supply | Maximum | Unit | Notes |
|-------------------------------------|---------|------|-------|
| V _{DD_LP} (P3041 on, 105C) | 1.5 | mW | 1 |
| V _{DD_LP} (P3041 off, 70C) | 195 | uW | 2 |
| V _{DD_LP} (P3041 off, 40C) | 132 | uW | 2 |

Note:

1. $V_{DD LP} = 1.0 V$, $T_J = 105^{\circ}C$.

2. When P3041 is off, V_{DD_LP} may be supplied by battery power to retain the Zeroizable Master Key and other Trust Architecture state. Board should implement a PMIC which switches V_{DD_LP} to battery when SOC powered down. See P3041 Reference Manual Trust Architecture chapter for more information.

This table shows the thermal characteristics for the chip.

| Table 11. Package | Thermal | Characteristics ⁶ |
|-------------------|---------|------------------------------|
|-------------------|---------|------------------------------|

| Rating | Board | Symbol | Value | Unit | Notes |
|---|-------------------------|--------------------|-------|------|-------|
| Junction to ambient, natural convection | Single-layer board (1s) | R_{\ThetaJA} | 14 | °C/W | 1, 2 |
| Junction to ambient, natural convection | Four-layer board (2s2p) | R_{\ThetaJA} | 11 | °C/W | 1, 3 |
| Junction to ambient (at 200 ft/min) | Single-layer board (1s) | $R_{\Theta JMA}$ | 9 | °C/W | 1, 2 |
| Junction to ambient (at 200 ft/min) | Four-layer board (2s2p) | R_{\ThetaJMA} | 7 | °C/W | 1, 2 |
| Junction to board | — | $R_{\Theta JB}$ | 3 | °C/W | 3 |
| Junction to case top | — | $R_{\Theta JCtop}$ | .53 | °C/W | 4 |
| Junction to lid top | — | $R_{\Theta JClid}$ | .16 | °C/W | 5 |

Note:

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per JEDEC JESD51-3 and JESD51-6 with the board (JESD51-9) horizontal.
- 3. Thermal resistance between the die and the printed-circuit board per JEDEC JESD51–8. Board temperature is measured on the top surface of the board near the package.
- 4. Junction-to-case-top at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.
- 5.Junction-to-lid-top thermal resistance determined using the using MIL-STD 883 Method 1012.1. However, instead of the cold plate, the lid top temperature is used here for the reference case temperature. Reported value does not include the thermal resistance of the interface layer between the package and cold plate.

6. Reference Section 3.8, "Thermal Management Information," for additional details.

2.5 Input Clocks

This section describes the system clock timing specifications, spread spectrum sources, real-time clock timing, dTSEC Gigabit Ethernet reference clock timing, and other clock sources.

2.5.1 System Clock (SYSCLK) Timing Specifications

This table provides the system clock (SYSCLK) DC specifications.

Table 12. SYSCLK DC Electrical Characteristics ($OV_{DD} = 3.3 V$)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Unit | Notes |
|---|-----------------|-----|---------|-----|------|-------|
| Input high voltage | V _{IH} | 2.0 | — | _ | V | 1 |
| Input low voltage | V _{IL} | — | — | 0.8 | V | 1 |
| Input capacitance | C _{IN} | — | _ | 15 | pf | _ |
| Input current (OV_{IN} = 0 V or OV_{IN} = OV_{DD}) | I _{IN} | — | — | ±50 | μA | 2 |

Note:

1. Note that the min V_{IL} and max V_{IH} values are based on the respective min and max OV_{IN} values found in Table 3.

2. The symbol OV_{IN}, in this case, represents the OV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the system clock (SYSCLK) AC timing specifications.

Table 13. SYSCLK AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter/Condition | Symbol | Min | Тур | Мах | Unit | Notes |
|--|---------------------------------------|-----|-----|------|------|-------|
| SYSCLK frequency | f _{SYSCLK} | 67 | — | 133 | MHz | 1, 2 |
| SYSCLK cycle time | t _{SYSCLK} | 7.5 | _ | 15 | ns | 1, 2 |
| SYSCLK duty cycle | t _{KHK} /t _{SYSCLK} | 40 | — | 60 | % | 2 |
| SYSCLK slew rate | | 1 | _ | 4 | V/ns | 3 |
| SYSCLK peak period jitter | _ | — | — | ±150 | ps | — |
| SYSCLK jitter phase noise at – 56dBc | _ | — | — | 500 | KHz | 4 |
| AC Input Swing Limits at 3.3 V OV_{DD} | ΔV_{AC} | 1.9 | — | — | V | — |

Notes:

1. Caution: The relevant clock ratio settings must be chosen such that the resulting SYSCLK frequencies do not exceed their respective maximum or minimum operating frequencies.

2. Measured at the rising edge and/or the falling edge at $OV_{DD}/2$.

3. Slew rate as measured from \pm 0.3 ΔV_{AC} at center of peak-to-peak voltage at clock input.

4. Phase noise is calculated as FFT of TIE jitter.

2.5.2 Spread Spectrum Sources

Spread spectrum clock sources are an increasingly popular way to control electromagnetic interference emissions (EMI) by spreading the emitted noise to a wider spectrum and reducing the peak noise magnitude in order to meet industry and government requirements. These clock sources intentionally add long-term jitter to diffuse the EMI spectral content. The jitter specification given in this table considers short-term (cycle-to-cycle) jitter only. The clock generator's cycle-to-cycle output

jitter should meet the chip's input cycle-to-cycle jitter requirement. Frequency modulation and spread are separate concerns; the chip is compatible with spread spectrum sources if the recommendations listed in this table are observed.

Table 14. Spread Spectrum Clock Source Recommendations

For recommended operating conditions, see Table 3.

| Parameter | Min | Мах | Unit | Notes |
|----------------------|-----|-----|------|-------|
| Frequency modulation | — | 60 | kHz | — |
| Frequency spread | — | 1.0 | % | 1, 2 |

Notes:

1. SYSCLK frequencies that result from frequency spreading and the resulting core frequency must meet the minimum and maximum specifications given in Table 13.

2. Maximum spread spectrum frequency may not result in exceeding any maximum operating frequency of the device.

CAUTION

The processor's minimum and maximum SYSCLK and core/platform/DDR frequencies must not be exceeded regardless of the type of clock source. Therefore, systems in which the processor is operated at its maximum rated core/platform/DDR frequency should avoid violating the stated limits by using down-spreading only.

2.5.3 Real Time Clock Timing

The real time clock timing (RTC) input is sampled by the platform clock. The output of the sampling latch is then used as an input to the counters of the MPIC and the time base unit of the e500mc; there is no need for jitter specification. The minimum pulse width of the RTC signal must be greater than $16 \times$ the period of the platform clock. That is, minimum clock high time is $8 \times$ (platform clock), and minimum clock low time is $8 \times$ (platform clock). There is no minimum RTC frequency; RTC may be grounded if not needed.

2.5.4 dTSEC Gigabit Ethernet Reference Clock Timing

This table provides the dTSEC gigabit reference clocks DC electrical characteristics.

Table 15. EC_GTX_CLK125 DC Timing Specifications

| Parameter | Symbol | Min | Max | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| High-level input voltage | V _{IH} | 2 | _ | V | 1 |
| Low-level input voltage | V _{IL} | — | 0.7 | V | 1 |
| Input current ($LV_{IN} = 0$ V or $LV_{IN} = LV_{DD}$) | I _{IN} | — | ±40 | μΑ | 2 |

Note:

1. The max V_{IH}, and min V_{IL} values are based on the respective min and max LVIN values found in Table 3.

2. The symbol LV_{IN}, in this case, represents the LV_{IN} symbol referenced in Table 3.

This table provides the dTSEC gigabit reference clocks AC timing specifications.

| Parameter/Condition | Symbol | Min | Typical | Мах | Unit | Notes |
|--|--|-----|---------|-------------|------|-------|
| EC_GTX_CLK125 frequency | t _{G125} | _ | 125 | _ | MHz | _ |
| EC_GTX_CLK125 cycle time | t _{G125} | — | 8 | — | ns | _ |
| EC_GTX_CLK125 rise and fall time $\label{eq:LVDD} \begin{array}{l} \text{LV}_{\text{DD}} = 2.5 \text{ V} \\ \text{LV}_{\text{DD}} = 3.3 \text{ V} \end{array}$ | t _{G125R} /t _{G125F} | _ | _ | 0.75 1.0 | ns | 1 |
| EC_GTX_CLK125 duty cycle 1000Base-T for RGMII | t _{G125H} /t _{G125} | 47 | — | 53 | % | 2 |
| EC_GTX_CLK125 jitter | — | — | — | ± 150 | ps | 2 |

Table 16. EC_GTX_CLK125 AC Timing Specifications

Notes:

1. Rise and fall times for EC_GTX_CLK125 are measured from 20% to 80% (rise time) and 80% to 20% (fall time) of LV_{DD}.

EC_GTX_CLK125 is used to generate the GTX clock for the dTSEC transmitter with 2% degradation. EC_GTX_CLK125 duty cycle can be loosened from 47%/53% as long as the PHY device can tolerate the duty cycle generated by the dTSEC GTX_CLK. See Section 2.11.2.2, "RGMII AC Timing Specifications," for duty cycle for 10Base-T and 100Base-T reference clock.

2.5.5 Other Input Clocks

A description of the overall clocking of this device is available in the *P3041 QorIQ Integrated Multicore Communication Processor Family Reference Manual* in the form of a clock subsystem block diagram. For information on the input clock requirements of functional blocks of the device—such as SerDes, Ethernet Management, eSDHC, local bus—see the specific interface section.

2.6 **RESET** Initialization

This section describes the AC electrical specifications for the RESET initialization timing requirements. This table provides the RESET initialization AC timing specifications.

| Parameter | Min | Мах | Unit ¹ | Notes |
|---|-----|-----|-------------------|-------|
| Required assertion time of PORESET | 1 | — | ms | 3 |
| Required input assertion time of HRESET | 32 | — | SYSCLKs | 1, 2 |

| Parameter | Min | Мах | Unit ¹ | Notes |
|---|-----|-----|-------------------|-------|
| Input setup time for POR configurations with respect to the negation of PORESET | 4 | _ | SYSCLKs | 1 |
| Input hold time for all POR configurations with respect to negation of PORESET | 2 | _ | SYSCLKs | 1 |
| Maximum valid-to-high impedance time for actively driven POR configurations with respect to negation of PORESET | _ | 5 | SYSCLKs | 1 |

Table 17. RESET Initialization AC Timing Specifications (continued)

Note:

- 1. SYSCLK is the primary clock input for the chip.
- 2. The device asserts HRESET as an output when PORESET is asserted to initiate the power-on reset process. The device releases HRESET sometime after PORESET is negated. The exact sequencing of HRESET negation is documented in Section 4.4.1 "Power-On Reset Sequence," of the P3041 QorIQ Integrated Multicore Communication Processor Family Reference Manual.
- 3. PORESET must be driven asserted before the core and platform power supplies are powered up. See Section 2.2, "Power-Up Sequencing."

This table provides the PLL lock times.

Table 18. PLL Lock Times

| Parameter | Min | Мах | Unit | Notes |
|----------------|-----|-----|------|-------|
| PLL lock times | — | 100 | μs | — |

2.7 Power-On Ramp Rate

This section describes the AC electrical specifications for the power-on ramp rate requirements. Controlling the maximum power-on ramp rate is required to avoid falsely triggering the ESD circuitry. This table provides the power supply ramp rate specifications.

Table 19. Power Supply Ramp Rate

| Parameter | Min | Max | Unit | Notes |
|--|-----|-------|------|-------|
| Required ramp rate for all voltage supplies (including $OV_{DD}/CV_{DD}/GV_{DD}/BV_{DD}/SV_{DD}/XV_{DD}/LV_{DD}$ all V_{DD} supplies, MVREF and all AV_{DD} supplies.) | | 36000 | V/s | 1, 2 |

Note:

1. Ramp rate is specified as a linear ramp from 10 to 90%. If non-linear (for example, exponential), the maximum rate of change from 200 to 500 mV is the most critical as this range might falsely trigger the ESD circuitry.

2. Over full recommended operating temperature range (see Table 3).

2.8 DDR3 and DDR3L SDRAM Controller

This section describes the DC and AC electrical specifications for the DDR3 and DDR3L SDRAM controller interface. Note that the required $GV_{DD}(typ)$ voltage is 1.5 V when interfacing to DDR3 SDRAM and the $GV_{DD}(typ)$ voltage is 1.35 V when interfacing to DDR3 SDRAM and the $GV_{DD}(typ)$ voltage is 1.35 V when interfacing to DDR3L SDRAM.

2.8.1 DDR3 and DDR3L SDRAM Interface DC Electrical Characteristics

This table provides the recommended operating conditions for the DDR SDRAM controller when interfacing to DDR3 SDRAM.

Table 20. DDR3 SDRAM Interface DC Electrical Characteristics $(GV_{DD} = 1.5 V)^{1}$

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Note |
|-----------------------|---------------------|------------------------------------|------------------------------------|------|---------|
| I/O reference voltage | MV _{REF} n | $0.49 	imes GV_{DD}$ | $0.51 	imes GV_{DD}$ | V | 2, 3, 4 |
| Input high voltage | V _{IH} | MV _{REF} <i>n</i> + 0.100 | GV _{DD} | V | 5 |
| Input low voltage | V _{IL} | GND | MV _{REF} <i>n</i> – 0.100 | V | 5 |
| I/O leakage current | I _{OZ} | -50 | 50 | μA | 6 |

Notes:

1. GV_{DD} is expected to be within 50 mV of the DRAM's voltage supply at all times. The DRAM's and memory controller's voltage supply may or may not be from the same source.

2. $MV_{REF}n$ is expected to be equal to $0.5 \times GV_{DD}$ and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on $MV_{REF}n$ may not exceed the $MV_{REF}n$ DC level by more than ±1% of the DC value (that is, ±15 mV).

3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made, and it is expected to be equal to $MV_{REF}n$ with a min value of $MV_{REF}n - 0.04$ and a max value of $MV_{REF}n + 0.04$. V_{TT} should track variations in the DC level of $MV_{REF}n$.

- 4. The voltage regulator for MV_{REF}*n* must meet the specifications stated in Table 23.
- 5. Input capacitance load for DQ, DQS, and DQS are available in the IBIS models.
- 6. Output leakage is measured with all outputs disabled, 0 V \leq V_{OUT} \leq GV_{DD}.

This table provides the recommended operating conditions for the DDR SDRAM controller when interfacing to DDR3L SDRAM.

Table 21. DDR3L SDRAM Interface DC Electrical Characteristics $(GV_{DD} = 1.35 V)^{1}$

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Note |
|-----------------------|---------------------|-----------------------------|-----------------------------|------|---------|
| I/O reference voltage | MV _{REF} n | $0.49 	imes GV_{DD}$ | $0.51 	imes GV_{DD}$ | V | 2, 3, 4 |
| Input high voltage | V _{IH} | MV _{REF} n + 0.090 | GV _{DD} | V | 5 |
| Input low voltage | V _{IL} | GND | MV _{REF} n – 0.090 | V | 5 |

Table 21. DDR3L SDRAM Interface DC Electrical Characteristics (GV_{DD} = 1.35 V)¹ (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Note |
|--|-----------------|------|-------|------|------|
| I/O leakage current | I _{OZ} | -50 | 50 | μA | 6 |
| Output high current (V _{OUT} = 0.641 V) | I _{ОН} | — | -23.3 | mA | 7, 8 |
| Output low current (V _{OUT} = 0.641 V) | I _{OL} | 23.3 | | mA | 7, 8 |

Notes:

1. GV_{DD} is expected to be within 50 mV of the DRAM's voltage supply at all times. The DRAM's and memory controller's voltage supply may or may not be from the same source.

- MV_{REF}n is expected to be equal to 0.5 × GV_{DD} and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF}n may not exceed the MV_{REF}n DC level by more than ±1% of the DC value (that is, ±13.5mV).
- V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made, and it is expected to be equal to MV_{REF}n with a min value of MV_{REF}n – 0.04 and a max value of MV_{REF}n + 0.04. V_{TT} should track variations in the DC level of MV_{REF}n.
- 4. The voltage regulator for MV_{REF}*n* must meet the specifications stated in Table 23.
- 5. Input capacitance load for DQ, DQS, and DQS are available in the IBIS models.
- 6. Output leakage is measured with all outputs disabled, 0 V \leq V_{OUT} \leq GV_{DD}.
- 7. Refer to the IBIS model for the complete output IV curve characteristics.
- 8. I_{OH} and I_{OL} are measured at GV_{DD} = 1.283 V.

This table provides the DDR controller interface capacitance for DDR3 and DDR3L.

Table 22. DDR3 and DDR3L SDRAM Capacitance

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|---|------------------|-----|-----|------|-------|
| Input/output capacitance: DQ, DQS, DQS | C _{IO} | 6 | 8 | pF | 1, 2 |
| Delta input/output capacitance: DQ, DQS, DQS | C _{DIO} | _ | 0.5 | pF | 1, 2 |

Note:

- 1. This parameter is sampled. GV_{DD} = 1.5 V ± 0.075 V (for DDR3), f = 1 MHz, T_A = 25 °C, V_{OUT} = $GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.150 V.
- 2. This parameter is sampled. $GV_{DD} = 1.35 \text{ V} 0.067 \text{ V} / + 0.100 \text{ V}$ (for DDR3L), f = 1 MHz, T_A = 25 °C, V_{OUT} = $GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.167 V.

This table provides the current draw characteristics for MVREFn.

Table 23. Current Draw Characteristics for MVREFn

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|----------------|-----|-----|------|-------|
| Current draw for DDR3 SDRAM for MVREF <i>n</i> | MVREF <i>n</i> | — | 500 | μA | _ |
| Current draw for DDR3L SDRAM for MVREFn | MVREF <i>n</i> | _ | 500 | μA | — |

2.8.2 DDR3 and DDR3L SDRAM Interface AC Timing Specifications

This section provides the AC timing specifications for the DDR SDRAM controller interface. The DDR controller supports DDR3 and DDR3L memories. Note that the required $GV_{DD}(typ)$ voltage is 1.5 V when interfacing to DDR3 SDRAM and the required $GV_{DD}(typ)$ voltage is 1.35 V when interfacing to DDR3L SDRAM.

2.8.2.1 DDR3 and DDR3L SDRAM Interface Input AC Timing Specifications

This table provides the input AC timing specifications for the DDR controller when interfacing to DDR3 SDRAM.

Table 24. DDR3 SDRAM Interface Input AC Timing Specifications

For recommended operating conditions, see Table 3.

| Par | ameter | Symbol | Min | Max | Unit | Notes |
|-----------------------|----------------------------|-------------------|----------------|----------------|------|-------|
| AC input low voltage | > 1200 MT/s data rate | V _{ILAC} | — | MVREFn – 0.150 | V | — |
| | \leq 1200 MT/s data rate | | | MVREFn – 0.175 | | |
| AC input high voltage | > 1200 MT/s data rate | V _{IHAC} | MVREFn + 0.150 | _ | V | — |
| | \leq 1200 MT/s data rate | | MVREFn + 0.175 | | | |

This table provides the input AC timing specifications for the DDR controller when interfacing to DDR3L SDRAM.

Table 25. DDR3L SDRAM Interface Input AC Timing Specifications

For recommended operating conditions, see Table 3.

| Para | imeter | Symbol | Min | Мах | Unit | Notes |
|-----------------------|----------------------------|-------------------|------------------------|-----------------------|------|-------|
| AC input low voltage | > 1200 MT/s data rate | V _{ILAC} | — | MVREF <i>n</i> -0.135 | V | — |
| | \leq 1200 MT/s data rate | | | MVREF <i>n</i> -0.160 | | |
| AC input high voltage | > 1200 MT/s data rate | V _{IHAC} | MVREF <i>n</i> + 0.135 | _ | V | — |
| | \leq 1200 MT/s data rate | | MVREF <i>n</i> + 0.160 | | | |

This table provides the input AC timing specifications for the DDR controller when interfacing to DDR3 SDRAM.

Table 26. DDR3 and DDR3L SDRAM Interface Input AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|-----------------------------------|---------------------|------|-----|------|-------|
| Controller Skew for MDQS—MDQ/MECC | t _{CISKEW} | | | ps | 1 |
| 1333 MT/s data rate | | -125 | 125 | | |
| 1200 MT/s data rate | | -142 | 142 | | |
| 1066 MT/s data rate | | -170 | 170 | | |
| 800 MT/s data rate | | -200 | 200 | | |

Table 26. DDR3 and DDR3L SDRAM Interface Input AC Timing Specifications (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|----------------------------------|---------------------|------|-----|------|-------|
| Tolerated Skew for MDQS—MDQ/MECC | t _{DISKEW} | | | ps | 2 |
| 1333 MT/s data rate | | -250 | 250 | | |
| 1200 MT/s data rate | | -275 | 275 | | |
| 1066 MT/s data rate | | -300 | 300 | | |
| 800 MT/s data rate | | -425 | 425 | | |

Note:

1. t_{CISKEW} represents the total amount of skew consumed by the controller between MDQS[n] and any corresponding bit that is captured with MDQS[n]. This must be subtracted from the total timing budget.

2. The amount of skew that can be tolerated from MDQS to a corresponding MDQ signal is called t_{DISKEW}. This can be determined by the following equation: t_{DISKEW} = ±(T ÷ 4 – abs(t_{CISKEW})) where T is the clock period and abs(t_{CISKEW}) is the absolute value of t_{CISKEW}.

This figure shows the DDR3 and DDR3L SDRAM interface input timing diagram.

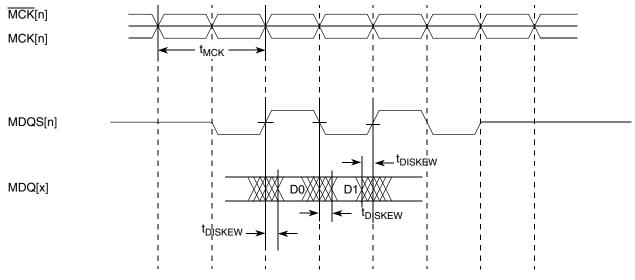


Figure 9. DDR3 and DDR3L SDRAM Interface Input Timing Diagram

2.8.2.2 DDR3 and DDDR3L SDRAM Interface Output AC Timing Specifications

This table contains the output AC timing targets for the DDR3 SDRAM interface.

Table 27. DDR3 and DDR3L SDRAM Interface Output AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Мах | Unit | Notes |
|--|---|--------|-------|------|-------|
| MCK[n] cycle time | t _{MCK} | 1.5 | 2.5 | ns | 2 |
| ADDR/CMD output setup with respect to MCK | t _{DDKHAS} | | | ns | 3 |
| 1333 MT/s data rate | | 0.606 | _ | | |
| 1200 MT/s data rate | | 0.675 | _ | | |
| 1066 MT/s data rate | | 0.744 | _ | | |
| 800 MT/s data rate | | 0.917 | _ | | |
| ADDR/CMD output hold with respect to MCK | t _{DDKHAX} | | | ns | 3 |
| 1333 MT/s data rate | | 0.606 | — | | |
| 1200 MT/s data rate | | 0.675 | _ | | |
| 1066 MT/s data rate | | 0.744 | — | | |
| 800 MT/s data rate | | 0.917 | — | | |
| MCS[n] output setup with respect to MCK | t _{DDKHCS} | | | ns | 3 |
| 1333 MT/s data rate | | 0.606 | — | | |
| 1200 MT/s data rate | | 0.675 | — | | |
| 1066 MT/s data rate | | 0.744 | — | | |
| 800 MT/s data rate | | 0.917 | — | | |
| MCS[n] output hold with respect to MCK | t _{DDKHCX} | | | ns | 3 |
| 1333 MT/s data rate | | 0.606 | — | | |
| 1200 MT/s data rate | | 0.675 | — | | |
| 1066 MT/s data rate | | 0.744 | — | | |
| 800 MT/s data rate | | 0.917 | — | | |
| MCK to MDQS Skew | t _{DDKHMH} | | | ns | 4 |
| ≥ 1066 MT/s data rate | | -0.245 | 0.245 | | 4, 6 |
| 800 MT/s data rate | | -0.375 | 0.375 | | 4 |
| MDQ/MECC/MDM output setup with respect to MDQS | t _{DDKHDS,} t _{DDKLDS} | | | ps | 5 |
| 1333 MT/s data rate | | 250 | — | | |
| 1200 MT/s data rate | | 275 | — | | |
| 1066 MT/s data rate | | 300 | — | | |
| 800 MT/s data rate | | 375 | — | | |

Table 27. DDR3 and DDR3L SDRAM Interface Output AC Timing Specifications (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Мах | Unit | Notes |
|---|---|---------------------|---------------------|------|-------|
| MDQ/MECC/MDM output hold with respect to MDQS | t _{DDKHDX,} t _{DDKLDX} | | | ps | 5 |
| 1333 MT/s data rate | | 250 | — | | |
| 1200 MT/s data rate | | 275 | — | | |
| 1066 MT/s data rate | | 300 | — | | |
| 800 MT/s data rate | | 375 | — | | |
| MDQS preamble | t _{DDKHMP} | $0.9 	imes t_{MCK}$ | — | ns | _ |
| MDQS postamble | t _{DDKHME} | $0.4 	imes t_{MCK}$ | $0.6 	imes t_{MCK}$ | ns | _ |

Note:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state) (reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. Output hold time can be read as DDR timing (DD) from the rising or falling edge of the reference clock (KH or KL) until the output went invalid (AX or DX). For example, t_{DDKHAS} symbolizes DDR timing (DD) for the time t_{MCK} memory clock reference (K) goes from the high (H) state until outputs (A) are setup (S) or output valid time. Also, t_{DDKLDX} symbolizes DDR timing (DD) for the time t_{MCK} memory clock reference (K) goes low (L) until data outputs (D) are invalid (X) or data output hold time.
</sub>

2. All MCK/MCK and MDQS/MDQS referenced measurements are made from the crossing of the two signals.

3. ADDR/CMD includes all DDR SDRAM output signals except MCK/MCK, MCS, and MDQ/MECC/MDM/MDQS.

- 4. Note that t_{DDKHMH} follows the symbol conventions described in note 1. For example, t_{DDKHMH} describes the DDR timing (DD) from the rising edge of the MCK[n] clock (KH) until the MDQS signal is valid (MH). t_{DDKHMH} can be modified through control of the MDQS override bits (called WR_DATA_DELAY) in the TIMING_CFG_2 register. This is typically set to the same delay as in DDR_SDRAM_CLK_CNTL[CLK_ADJUST]. The timing parameters listed in the table assume that these two parameters have been set to the same adjustment value. See the *P3041 QorlQ Integrated Multicore Communication Processor Family* for a description and explanation of the timing modifications enabled by use of these bits.
- 5. Determined by maximum possible skew between a data strobe (MDQS) and any corresponding bit of data (MDQ), ECC (MECC), or data mask (MDM). The data strobe must be centered inside of the data eye at the pins of the microprocessor.
- 6. Note that for 1200/1333/1600 frequencies it is required to program the start value of the DQS adjust for write leveling.

NOTE

For the ADDR/CMD setup and hold specifications in Table 27, it is assumed that the clock control register is set to adjust the memory clocks by ½ applied cycle.

This figure shows the DDR3 and DDR3L SDRAM interface output timing for the MCK to MDQS skew measurement (t_{DDKHMH}).

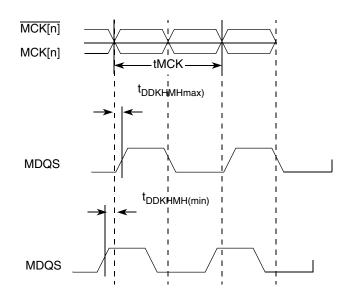


Figure 10. t_{DDKHMH} Timing Diagram

This figure shows the DDR3 and DDR3L SDRAM output timing diagram.

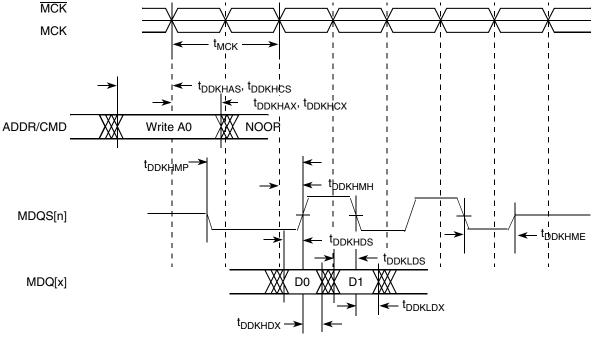


Figure 11. DDR3 and DDR3L Output Timing Diagram

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This figure provides the AC test load for the DDR3 controller bus.

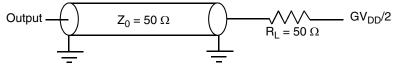


Figure 12. DDR3 Controller Bus AC Test Load

2.8.2.3 DDR3 and DDR3L SDRAM Differential Timing Specifications

This section describes the DC and AC differential timing specifications for the DDR3 and DDR3L SDRAM controller interface. This figure shows the differential timing specification.

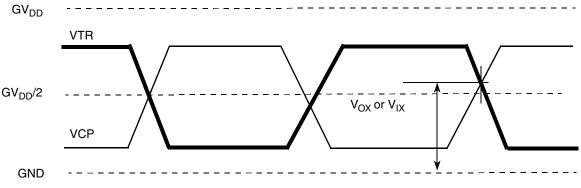


Figure 13. DDR3 and DDR3L SDRAM Differential Timing Specifications

NOTE

VTR specifies the true input signal (such as MCK or MDQS) and VCP is the complementary input signal (such as \overline{MCK} or \overline{MDQS}).

This table provides the DDR3 differential specifications for the differential signals MDQS/MDQS and MCK/MCK.

Table 28. DDR3 SDRAM Differential Electrical Characteristics

| Parameter | Symbol Min | | Мах | Unit | Notes |
|--|-------------------|---------------------------|---------------------------|------|-------|
| Input AC Differential Cross-Point Voltage | V _{IXAC} | $0.5\times GV_{DD}-0.150$ | $0.5\times GV_{DD}+0.150$ | V | 1 |
| Output AC Differential Cross-Point Voltage | V _{OXAC} | $0.5\times GV_{DD}-0.115$ | $0.5\times GV_{DD}+0.115$ | V | 1 |

Note:

1. I/O drivers are calibrated before making measurements.

This table provides the DDR3L differential specifications for the differential signals MDQS/MDQS and MCK/MCK.

Table 29. DDR3L SDRAM Differential Electrical Characteristics

| Parameter | Symbol Min | | Мах | Unit | Notes |
|--|-------------------|---------------------------|---------------------------|------|-------|
| Input AC Differential Cross-Point Voltage | V _{IXAC} | $0.5\times GV_{DD}-0.135$ | $0.5\times GV_{DD}+0.135$ | V | 1 |
| Output AC Differential Cross-Point Voltage | V _{OXAC} | $0.5\times GV_{DD}-0.105$ | $0.5\times GV_{DD}+0.105$ | V | 1 |

Note:

1. I/O drivers are calibrated before making measurements.

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2.9 eSPI

This section describes the DC and AC electrical specifications for the eSPI interface.

2.9.1 eSPI DC Electrical Characteristics

This table provides the DC electrical characteristics for the eSPI interface operating at $CV_{DD} = 3.3$ V.

Table 30. eSPI DC Electrical Characteristics $(CV_{DD} = 3.3 V)^{1,2}$

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit |
|--|-----------------|-----|-----|------|
| Input high voltage | V _{IH} | 2.0 | _ | V |
| Input low voltage | V _{IL} | — | 0.8 | V |
| Input current ($V_{IN} = 0 V \text{ or } V_{IN} = CV_{DD}$) | I _{IN} | — | ±40 | μA |
| Output high voltage (CV _{DD} = min, I _{OH} = -2 mA) | V _{OH} | 2.4 | _ | V |
| Output low voltage (CV _{DD} = min, I _{OL} = 2 mA) | V _{OL} | — | 0.4 | V |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max CV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the CV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the DC electrical characteristics for the eSPI interface operating at $CV_{DD} = 2.5$ V.

Table 31. eSPI DC Electrical Characteristics $(CV_{DD} = 2.5 V)^{1,2}$

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit |
|--|-----------------|-----|-----|------|
| Input high voltage | V _{IH} | 1.7 | — | V |
| Input low voltage | V _{IL} | _ | 0.7 | V |
| Input current ($V_{IN} = 0 V \text{ or } V_{IN} = CV_{DD}$) | I _{IN} | — | ±40 | μA |
| Output high voltage ($CV_{DD} = min, I_{OH} = -1 mA$) | V _{OH} | 2.0 | | V |
| Output low voltage (CV _{DD} = min, I _{OL} = 1 mA) | V _{OL} | _ | 0.4 | V |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max CV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the CV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the DC electrical characteristics for the eSPI interface operating at $CV_{DD} = 1.8$ V.

Table 32. eSPI DC Electrical Characteristics (CV_{DD} = 1.8 V)^{1,2}

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit |
|--|-----------------|------|-----|------|
| Input high voltage | V _{IH} | 1.25 | _ | V |
| Input low voltage | V _{IL} | — | 0.6 | V |
| Input current ($V_{IN} = 0 V \text{ or } V_{IN} = CV_{DD}$) | I _{IN} | _ | ±40 | μΑ |
| Output high voltage (CV _{DD} = min, I _{OH} = -0.5 mA) | V _{OH} | 1.35 | _ | V |
| Output low voltage (CV _{DD} = min, I _{OL} = 0.5 mA) | V _{OL} | — | 0.4 | V |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max CV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the CV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.9.2 eSPI AC Timing Specifications

This table provides the eSPI input and output AC timing specifications.

Table 33. eSPI AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Мах | Unit | Note |
|---|----------------------|--|--|------|------|
| SPI_MOSI output—Master data (internal clock) hold time | t _{NIKHOX} | 2 + (t _{PLATFORM_CLK} *SPMODE[HO_ADJ]) | _ | ns | 2, 3 |
| SPI_MOSI output—Master data (internal clock) delay | t _{NIKHOV} | — | 5.24 + (t _{PLATFORM_CLK} * SPMODE[HO_ADJ]) | ns | 2, 3 |
| SPI_CS outputs—Master data (internal clock) hold time | t _{NIKHOX2} | 0 | — | ns | 2 |
| SPI_CS outputs—Master data (internal clock) delay | t _{NIKHOV2} | — | 6.0 | ns | 2 |
| eSPI inputs—Master data (internal clock) input setup time | t _{NIIVKH} | 7 | — | ns | _ |
| eSPI inputs—Master data (internal clock) input hold time | t _{NIIXKH} | 0 | — | ns | |

Notes:

The symbols used for timing specifications follow the pattern of t_{(first two letters of functional block)(signal)(state)} (reference)(state) for inputs and t_(first two letters of functional block)(signal)(state) (reference)(state)(signal)(state) for outputs. For example, t_{NIKHOV} symbolizes the NMSI outputs internal timing (NI) for the time t_{SPI} memory clock reference (K) goes from the high state (H) until outputs (O) are valid (V).

2. Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.

 The greater of the two output timings for t_{NIKHOX} and t_{NIKHOV} are used when SPCOM[RxDelay] of the eSPI command register is set. For example, the t_{NIKHOX} is 4.0 and t_{NIKHOV} is 7.0 if SPCOM[RxDelay] is set to be 1. This figure provides the AC test load for the eSPI.

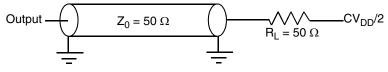


Figure 14. eSPI AC Test Load

This table represents the AC timing from Table 33 in master mode (internal clock). Note that although timing specifications generally refer to the rising edge of the clock, Figure 15 also applies when the falling edge is the active edge. Also, note that the clock edge is selectable on eSPI.

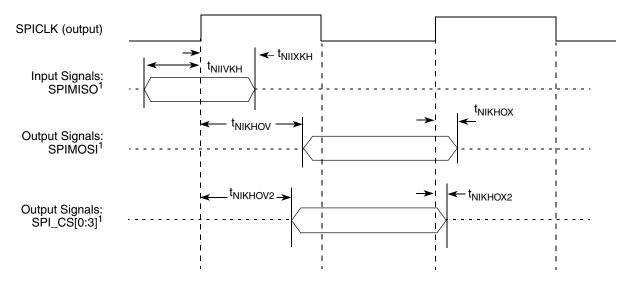


Figure 15. eSPI AC Timing in Master Mode (Internal Clock) Diagram

2.10 DUART

This section describes the DC and AC electrical specifications for the DUART interface.

2.10.1 DUART DC Electrical Characteristics

This table provides the DC electrical characteristics for the DUART interface.

Table 34. DUART DC Electrical Characteristics (OV_{DD} = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|--------------------|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2 | — | V | 1 |
| Input low voltage | V _{IL} | _ | 0.8 | V | 1 |

Table 34. DUART DC Electrical Characteristics (OV_{DD} = 3.3 V) (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input current (OV _{IN} = 0 V or OV _{IN} = OV _{DD}) | I _{IN} | | ±40 | μA | 2 |
| Output high voltage ($OV_{DD} = min, I_{OH} = -2 mA$) | V _{OH} | 2.4 | — | V | — |
| Output low voltage ($OV_{DD} = min, I_{OL} = 2 mA$) | V _{OL} | _ | 0.4 | V | — |

Notes:

1. The symbol OV_{IN} , in this case, represents the OV_{IN} symbol referenced in Table 3.

2. Note that the symbol OV_{IN}, in this case, represents the OV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.10.2 DUART AC Electrical Specifications

This table provides the AC timing parameters for the DUART interface.

Table 35. DUART AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Value | Unit | Notes |
|-------------------|----------------------------------|------|-------|
| Minimum baud rate | f _{PLAT} /(2*1,048,576) | baud | 1 |
| Maximum baud rate | f _{PLAT} /(2*16) | baud | 1, 2 |
| Oversample rate | 16 | | 3 |

Notes:

1. f_{PLAT} refers to the internal platform clock.

- 2. The actual attainable baud rate is limited by the latency of interrupt processing.
- 3. The middle of a start bit is detected as the eighth sampled 0 after the 1-to-0 transition of the start bit. Subsequent bit values are sampled each 16th sample.

2.11 Ethernet: Datapath Three-Speed Ethernet (dTSEC), Management Interface, IEEE Std 1588

This section provides the AC and DC electrical characteristics for the datapath three-speed Ethernet controller, the Ethernet Management Interface, and the IEEE Std 1588 interface.

2.11.1 SGMII Timing Specifications

See Section 2.19.9, "SGMII Interface."

2.11.2 RGMII Timing Specifications

This section discusses the electrical characteristics for the RGMII interfaces.

2.11.2.1 RGMII DC Electrical Characteristics

This table shows the RGMII DC electrical characteristics when operating at $LV_{DD} = 2.5$ V supply.

Table 36. RGMII DC Electrical Characteristics (LV_{DD} = 2.5 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|------|------|------|-------|
| Input high voltage | V _{IH} | 1.70 | _ | V | _ |
| Input low voltage | V _{IL} | — | 0.70 | V | — |
| Input current ($LV_{IN} = 0$ V or $LV_{IN} = LV_{DD}$) | IIH | — | ±40 | μΑ | 2 |
| Output high voltage (LV _{DD} = min, $I_{OH} = -1.0$ mA) | V _{OH} | 2.00 | — | V | — |
| Output low voltage ($LV_{DD} = min, I_{OL} = 1.0 mA$) | V _{OL} | — | 0.40 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max LV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the LV_{IN} symbols referenced in Table 2 and Table 3.

2.11.2.2 RGMII AC Timing Specifications

This table presents the RGMII AC timing specifications.

Table 37. RGMII AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter/Condition | Symbol ¹ | Min | Тур | Мах | Unit | Notes |
|--|-------------------------------------|------|-----|------|------|-------|
| Data to clock output skew (at transmitter) | t _{SKRGT_TX} | -500 | 0 | 500 | ps | 5 |
| Data to clock input skew (at receiver) | t _{SKRGT_RX} | 1.0 | — | 2.8 | ns | 2 |
| Clock period duration | t _{RGT} | 7.2 | 8.0 | 8.8 | ns | 3 |
| Duty cycle for 10BASE-T and 100BASE-TX | t _{RGTH} /t _{RGT} | 40 | 50 | 60 | % | 3, 4 |
| Duty cycle for Gigabit | t _{RGTH} /t _{RGT} | 45 | 50 | 55 | % | — |
| Rise time (20%–80%) | t _{RGTR} | — | — | 0.75 | ns | — |
| Fall time (20%-80%) | t _{RGTF} | — | — | 0.75 | ns | — |

Notes:

1. In general, the clock reference symbol representation for this section is based on the symbols RGT to represent RGMII timing. Note that the notation for rise (R) and fall (F) times follows the clock symbol that is being represented. For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (RGT).

2. This implies that PC board design requires clocks to be routed such that an additional trace delay of greater than 1.5 ns is added to the associated clock signal. Many PHY vendors already incorporate the necessary delay inside their chip. If so, additional PCB delay is probably not needed.

3. For 10 and 100 Mbps, t_{RGT} scales to 400 ns \pm 40 ns and 40 ns \pm 4 ns, respectively.

4. Duty cycle may be stretched/shrunk during speed changes or while transitioning to a received packet's clock domains as long as the minimum duty cycle is not violated and stretching occurs for no more than three t_{RGT} of the lowest speed transitioned between.

5. The frequency of RX_CLK should not exceed the frequency of GTX_CLK125 by more than 300 ppm.

This figure shows the RGMII AC timing and multiplexing diagrams.

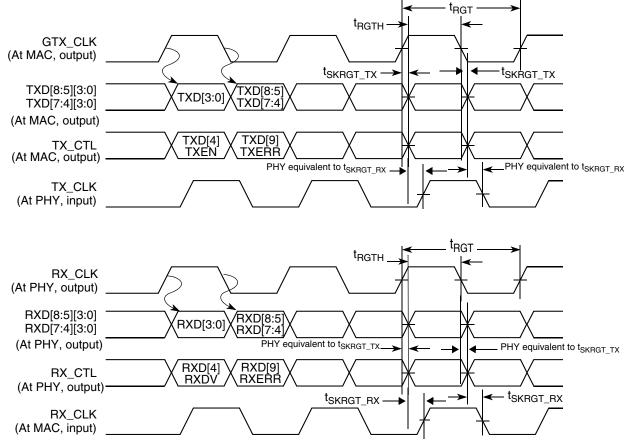


Figure 16. RGMII AC Timing and Multiplexing Diagrams

2.11.3 Ethernet Management Interface

This section discusses the electrical characteristics for the EMI1 and EMI2 interfaces. EMI1 is the PHY management interface controlled by the MDIO controller associated with Frame Manager 1 1GMAC-1. EMI2 is the XAUI PHY management interface controlled by the MDIO controller associated with Frame Manager 1 10GMAC-0.

2.11.3.1 Ethernet Management Interface 1 DC Electrical Characteristics

The Ethernet management interface is defined to operate at a supply voltage of 3.3 V. This table provides the DC electrical characteristics for the Ethernet management interface.

Table 38. Ethernet Management Interface 1 DC Electrical Characteristics (LV_{DD} = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|---|-----------------|------|-----|------|-------|
| Input high voltage | V _{IH} | 2.0 | — | V | 2 |
| Input low voltage | V _{IL} | — | 0.9 | V | 2 |
| Input high current (LV _{DD} = Max, V _{IN} = 2.1 V) | I _{IH} | — | 40 | μΑ | 1 |
| Input low current (LV _{DD} = Max, V _{IN} = 0.5 V) | IIL | -600 | — | μΑ | 1 |
| Output high voltage (LV _{DD} = Min, $I_{OH} = -1.0$ mA) | V _{OH} | 2.4 | _ | V | _ |
| Output low voltage (LV _{DD} = Min, I _{OL} = 1.0 mA) | V _{OL} | — | 0.4 | V | — |

Note:

1. Note that the symbol V_{IN} , in this case, represents the LV_{IN} symbol referenced in Table 2 and Table 3.

2. The min V_{IL} and max V_{IH} values are based on the respective LV_{IN} values found in Table 3.

The Ethernet management interface is defined to operate at a supply voltage of 2.5 V. The DC electrical characteristics for the Ethernet management interface is provided in this table.

Table 39. Ethernet Management Interface 1 DC Electrical Characteristics (LV_{DD} = 2.5 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 1.7 | _ | V | 1 |
| Input low voltage | V _{IL} | _ | 0.7 | V | 1 |
| Input current (LV _{IN} = 0 V or LV _{IN} = LV _{DD}) | I _{IH} | - | ±40 | μΑ | 2 |
| Output high voltage ($LV_{DD} = Min, IOH = -1.0 mA$) | V _{OH} | 2.0 | — | V | — |
| Output low voltage (LV _{DD} = Min, I _{OL} = 1.0 mA) | V _{OL} | | 0.4 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max LV_{IN} values found in Table 3.

2. Note that the symbol LV_{IN}, in this case, represents the LV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.11.3.2 Ethernet Management Interface 2 DC Electrical Characteristics

Ethernet Management Interface 2 pins function as open drain I/Os. The interface shall conform to 1.2 V nominal voltage levels. LV_{DD} must be powered to use this interface. The DC electrical characteristics for EMI2_MDIO and EMI2_MDC are provided in this section.

Table 40. Ethernet Management Interface 2 DC Electrical Characteristics (1.2 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|---|-----------------|------|------|------|-------|
| Input high voltage | V _{IH} | 0.84 | _ | V | — |
| Input low voltage | V _{IL} | — | 0.36 | V | — |
| Output high voltage (I _{OH} = -100 μA) | V _{OH} | 1.0 | _ | V | — |
| Output low voltage ($I_{OL} = 100 \ \mu A$) | V _{OL} | — | 0.2 | V | — |
| Output low current (V _{OL} = 0.2 V) | I _{OL} | 4 | _ | mA | — |
| Input capacitance | C _{IN} | — | 10 | pF | — |

2.11.3.3 Ethernet Management Interface 1 AC Timing Specifications

This table provides the Ethernet management interface AC timing specifications.

Table 41. Ethernet Management Interface 1 AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Тур | Мах | Unit | Notes |
|----------------------------|---------------------|--------------------------------|-----|--------------------------------|------|-------|
| MDC frequency | f _{MDC} | — | _ | 2.5 | MHz | 2 |
| MDC clock pulse width high | t _{MDCH} | 160 | _ | — | ns | — |
| MDC to MDIO delay | t _{MDKHDX} | $(16 \times t_{plb_clk}) - 6$ | _ | $(16 \times t_{plb_clk}) + 6$ | ns | 3, 4 |
| MDIO to MDC setup time | t _{MDDVKH} | 10 | _ | — | ns | — |
| MDIO to MDC hold time | t _{MDDXKH} | 0 | — | — | ns | — |

Notes:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{MDKHDX} symbolizes management data timing (MD) for the time t_{MDC} from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also, t_{MDDVKH} symbolizes management data timing (MD) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{MDC} clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
</sub>

- 2. This parameter is dependent on the platform clock frequency (MIIMCFG [MgmtClk] field determines the clock frequency of the MgmtClk Clock EC_MDC).
- 3. This parameter is dependent on the platform clock frequency. The delay is equal to 16 platform clock periods ±3 ns. For example, with a platform clock of 333 MHz, the min/max delay is 48 ns ± 3 ns. Similarly, if the platform clock is 400 MHz, the min/max delay is 40 ns ± 3 ns.
- 4. $t_{plb \ clk}$ is the frame manager clock period.

2.11.3.4 Ethernet Management Interface 2 AC Electrical Characteristics

Table 42. Ethernet Management Interface 2 AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter/Condition | Symbol ¹ | Min | Тур | Мах | Unit | Notes |
|----------------------------|---------------------|--------------------------------|-----|--------------------------------|------|-------|
| MDC frequency | f _{MDC} | _ | _ | 2.5 | MHz | 2 |
| MDC clock pulse width high | t _{MDCH} | 160 | _ | — | ns | _ |
| MDC to MDIO delay | t _{MDKHDX} | $(0.5 \times (1/f_{MDC})) - 6$ | _ | $(0.5 \times (1/f_{MDC})) + 6$ | ns | 3 |
| MDIO to MDC setup time | t _{MDDVKH} | 10 | _ | — | ns | _ |
| MDIO to MDC hold time | t _{MDDXKH} | 0 | _ | — | ns | _ |

Notes:

The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{MDKHDX} symbolizes management data timing (MD) for the time t_{MDC} from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also, t_{MDDVKH} symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MDC} clock reference (K) going to the high (H) state or setup time.
</sub>

2. This parameter is dependent on the frame manager clock frequency (MIIMCFG [MgmtClk] field determines the clock frequency of the MgmtClk Clock EC_MDC).

3. This parameter is dependent on the management data clock frequency, f_{MDC}. The delay is equal to 0.5 management data clock period ±6 ns. For example, with a management data clock of 2.5 MHz, the min/max delay is 200 ns ± 6 ns.

This figure shows the Ethernet management interface timing diagram.

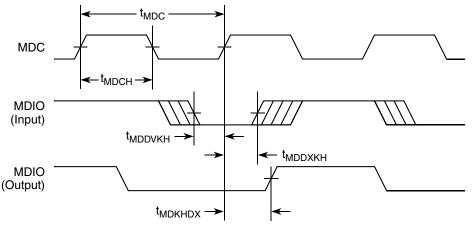


Figure 17. Ethernet Management Interface Timing Diagram

2.11.4 eTSEC IEEE Std 1588 Timing Specifications

This section discusses the electrical characteristics for the eTSEC IEEE Std 1588 interfaces.

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2.11.4.1 eTSEC IEEE Std 1588 DC Electrical Characteristics

This table shows eTSEC IEEE Std 1588 DC electrical characteristics when operating at $LV_{DD} = 3.3$ V supply.

Table 43. eTSEC IEEE 1588 DC Electrical Characteristics (LV_{DD} = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|------|-----|------|-------|
| Input high voltage | V _{IH} | 2.0 | — | V | 2 |
| Input low voltage | V _{IL} | — | 0.9 | V | 2 |
| Input high current (LV _{DD} = Max, V _{IN} = 2.1 V) | I _{IH} | — | 40 | μΑ | 1 |
| Input low current (LV _{DD} = Max, V _{IN} = 0.5 V) | I | -600 | — | μΑ | 1 |
| Output high voltage ($LV_{DD} = Min, I_{OH} = -1.0 mA$) | V _{OH} | 2.4 | — | V | _ |
| Output low voltage ($LV_{DD} = Min$, $I_{OL} = 1.0 mA$) | V _{OL} | — | 0.4 | V | — |

Note:

1. Note that the symbol V_{IN} , in this case, represents the LV_{IN} symbol referenced in Table 2 and Table 3.

2. The min V_{IL} and max V_{IH} values are based on the respective LV_{IN} values found in Table 3.

This table shows the IEEE 1588 DC electrical characteristics when operating at $LV_{DD} = 2.5$ V supply.

Table 44. eTSEC IEEE 1588 DC Electrical Characteristics (LV_{DD} = 2.5 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|---|-----------------|------|------|------|-------|
| Input high voltage | V _{IH} | 1.70 | _ | V | |
| Input low voltage | V _{IL} | _ | 0.70 | V | _ |
| Input current ($LV_{IN} = 0$ V or $LV_{IN} = LV_{DD}$) | I _{IH} | _ | ±40 | μA | 2 |
| Output high voltage (LV_{DD} = min, I_{OH} = -1.0 mA) | V _{OH} | 2.00 | _ | V | _ |
| Output low voltage (LV _{DD} = min, I _{OL} = 1.0 mA) | V _{OL} | — | 0.40 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max LV_{IN} values found in Table 3.

2. The symbol V_{IN} in this case, represents the LV_{IN} symbols referenced in Table 2 and Table 3.

2.11.4.2 eTSEC IEEE Std 1588 AC Electrical Characteristics

This table provides the IEEE 1588 AC timing specifications.

Table 45. eTSEC IEEE 1588 AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Unit | Notes |
|------------------------------------|--|------------------------------|-----|----------------------------------|------|-------|
| TSEC_1588_CLK clock period | t _{T1588CLK} | 6.4 | | ${\rm T}_{\rm RX_CLK} \times 7$ | ns | 1, 2 |
| TSEC_1588_CLK duty cycle | t _{T1588CLKH} / t _{T1588CLK} | 40 | 50 | 60 | % | 3 |
| TSEC_1588_CLK peak-to-peak jitter | t _{T1588} CLKINJ | — | _ | 250 | ps | _ |
| Rise time eTSEC_1588_CLK (20%-80%) | t _{T1588} CLKINR | 1.0 | _ | 2.0 | ns | — |
| Fall time eTSEC_1588_CLK (80%-20%) | t _{T1588} CLKINF | 1.0 | _ | 2.0 | ns | _ |
| TSEC_1588_CLK_OUT clock period | t _{T1588CLKOUT} | $2 \times t_{T1588CLK}$ | _ | _ | ns | _ |
| TSEC_1588_CLK_OUT duty cycle | t _{T1588CLKOTH} / t _{T1588CLKOUT} | 30 | 50 | 70 | % | — |
| TSEC_1588_PULSE_OUT | t _{T1588OV} | 0.5 | _ | 3.5 | ns | — |
| TSEC_1588_TRIG_IN pulse width | t _{T1588} TRIGH | $2 \times t_{T1588CLK_MAX}$ | | — | ns | 2 |

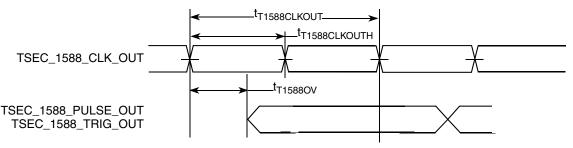
Notes:

1.T_{RX_CLK} is the maximum clock period of eTSEC receiving clock selected by TMR_CTRL[CKSEL]. See the P3041P2041 *QorlQ* Integrated Processor Reference Manual for a description of TMR_CTRL registers.

The maximum value of t_{T1588CLK} is not only defined by the value of T_{RX_CLK}, but also defined by the recovered clock. For example, for 10/100/1000 Mbps modes, the maximum value of t_{T1588CLK} is 2800, 280, and 56 ns, respectively.

2. It needs to be at least two times the clock period of the clock selected by TMR_CTRL[CKSEL]. See the *QorlQ Integrated Processor Reference Manual* for a description of TMR_CTRL registers.

This figure shows the data and command output AC timing diagram.



Note: The output delay is counted starting at the rising edge if t_{T1588CLKOUT} is noninverting. Otherwise, it is counted starting at the falling edge.

Figure 18. eTSEC IEEE 1588 Output AC Timing

This figure shows the data and command input AC timing diagram.

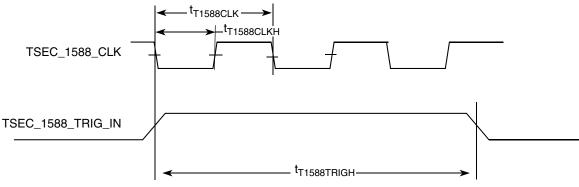


Figure 19. eTSEC IEEE 1588 Input AC Timing

2.12 USB

This section provides the AC and DC electrical specifications for the USB interface.

2.12.1 USB DC Electrical Characteristics

This table provides the DC electrical characteristics for the USB interface at USB_VDD_3P3 = 3.3 V.

Table 46. USB DC Electrical Characteristics (USB_V_{DD}_3P3 = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|---|-----------------|-----|-----|------|-------|
| Input high voltage ¹ | V _{IH} | 2.0 | _ | V | 1 |
| Input low voltage | V _{IL} | — | 0.8 | V | 1 |
| Input current (USB_V _{IN} _3P3 = 0 V or USB_V _{IN} _3P3 = USB_V _{DD} _3P3) | I _{IN} | _ | ±40 | μA | 2 |
| Output high voltage (USB_V _{DD} _3P3 = min, I _{OH} = -2 mA) | V _{OH} | 2.8 | _ | V | — |
| Output low voltage (USB_V _{DD} _3P3 = min, I_{OL} = 2 mA) | V _{OL} | — | 0.3 | V | — |

Notes:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max USB_ V_{IN} _3P3 values found in Table 3.

2. The symbol USB_V_{IN}_3P3, in this case, represents the USB_V_{IN}_3P3 symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.12.2 USB AC Electrical Specifications

This table provides the USB clock input (USBn_CLKIN) AC timing specifications.

Table 47. USB_CLK_IN AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Condition | Symbol | Min | Тур | Max | Unit | Notes |
|---|---|-------------------------|--------|-----|-------|------|-------|
| Frequency range | - | f _{USB_CLK_IN} | — | 24 | — | MHz | — |
| Rise/Fall time | Measured between 10% and 90% | t _{USRF} | — | _ | 6 | ns | 1 |
| Clock frequency tolerance | _ | ^t CLK_TOL | -0.005 | 0 | 0.005 | % | — |
| Reference clock duty cycle | Measured at 1.6 V | ^t CLK_DUTY | 40 | 50 | 60 | % | — |
| Total input jitter/time interval error | RMS value measured with a second-order, high-pass filter of 500-kHz bandwidth | t _{CLK_PJ} | _ | | 5 | ps | |

Note:

1. System/board must be designed to ensure the input requirement to the device is achieved. Proper device operation is guaranteed for inputs meeting this requirement by design, simulation, characterization, or functional testing.

2.13 Enhanced Local Bus Interface (eLBC)

This section describes the DC and AC electrical specifications for the enhanced local bus interface.

2.13.1 Enhanced Local Bus DC Electrical Characteristics

This table provides the DC electrical characteristics for the enhanced local bus interface operating at $BV_{DD} = 3.3$ V.

Table 48. Enhanced Local Bus DC Electrical Characteristics (BV_{DD} = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2 | — | V | 1 |
| Input low voltage | V _{IL} | — | 0.8 | V | 1 |
| Input current (V _{IN} = 0 V or V _{IN} = BV _{DD}) | I _{IN} | — | ±40 | μΑ | 2 |
| Output high voltage (BV _{DD} = min, I _{OH} = -2 mA) | V _{OH} | 2.4 | — | V | — |
| Output low voltage (BV _{DD} = min, I _{OL} = 2 mA) | V _{OL} | — | 0.4 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max BV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the BV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the DC electrical characteristics for the enhanced local bus interface operating at $BV_{DD} = 2.5$ V.

Table 49. Enhanced Local Bus DC Electrical Characteristics (BV_{DD} = 2.5 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 1.7 | — | V | 1 |
| Input low voltage | V _{IL} | — | 0.7 | V | 1 |
| Input current ($V_{IN} = 0$ V or $V_{IN} = BV_{DD}$) | I _{IN} | — | ±40 | μA | 2 |
| Output high voltage (BV _{DD} = min, I _{OH} = –1 mA) | V _{OH} | 2.0 | — | V | — |
| Output low voltage (BV _{DD} = min, I _{OL} = 1 mA) | V _{OL} | — | 0.4 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max BV_{IN} values found in Table 3

2. The symbol V_{IN}, in this case, represents the BV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the DC electrical characteristics for the enhanced local bus interface operating at $BV_{DD} = 1.8$ V.

Table 50. Enhanced Local Bus DC Electrical Characteristics (BV_{DD} = 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|--|-----------------|------|-----|------|-------|
| Input high voltage | V _{IH} | 1.25 | _ | V | 1 |
| Input low voltage | V _{IL} | — | 0.6 | V | 1 |
| Input current ($V_{IN} = 0 V \text{ or } V_{IN} = BV_{DD}$) | I _{IN} | — | ±40 | μΑ | 2 |
| Output high voltage (BV _{DD} = min, I _{OH} = -0.5 mA) | V _{OH} | 1.35 | — | V | — |
| Output low voltage (BV _{DD} = min, I _{OL} = 0.5 mA) | V _{OL} | — | 0.4 | V | _ |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max BV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the BV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.13.2 Enhanced Local Bus AC Timing Specifications

This section describes the AC timing specifications for the enhanced local bus interface.

2.13.2.1 Test Condition

This figure provides the AC test load for the enhanced local bus.

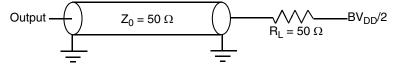


Figure 20. Enhanced Local Bus AC Test Load

2.13.2.2 Local Bus AC Timing Specification

All output signal timings are relative to the falling edge of any LCLKs. The external circuit must use the rising edge of the LCLKs to latch the data.

All input timings except LGTA/LUPWAIT/LFRB are relative to the rising edge of LCLKs. LGTA/LUPWAIT/LFRB are relative to the falling edge of LCLKs.

This table describes the AC timing specifications of the local bus interface.

Table 51. Enhanced Local Bus AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Мах | Unit | Notes |
|---|-------------------------------------|---|-----|------|-------|
| Local bus cycle time | t _{LBK} | 12 | _ | ns | — |
| Local bus duty cycle | t _{LBKH} /t _{LBK} | 45 | 55 | % | — |
| LCLK[n] skew to LCLK[m] | t _{LBKSKEW} | — | 150 | ps | 2 |
| Input setup (except LGTA/LUPWAIT/LFRB) | t _{LBIVKH} | 6 | _ | ns | _ |
| Input hold (except LGTA/LUPWAIT/LFRB) | t _{LBIXKH} | 1 | | ns | _ |
| Input setup (for LGTA/LUPWAIT/LFRB) | t _{LBIVKL} | 6 | | ns | _ |
| Input hold (for LGTA/LUPWAIT/LFRB) | t _{LBIXKL} | 1 | | ns | _ |
| Output delay (Except LALE) | t _{LBKLOV} | — | 2.0 | ns | — |
| Output hold (Except LALE) | t _{LBKLOX} | -3.5 | | ns | 5 |
| Local bus clock to output high impedance for LAD/LDP | t _{LBKLOZ} | — | 2 | ns | 3 |
| LALE output negation to LAD/LDP output transition (LATCH hold time) | t _{lbonot} | 2 platform clock cycles - 1ns (LBCR[AHD] = 1) | | ns | 4 |
| | | 4 platform clock cycles - 1ns (LBCR[AHD] = 0) | | | |

Note:

1. All signals are measured from BV_{DD}/2 of rising/falling edge of LCLK to BV_{DD}/2 of the signal in question.

2. Skew measured between different LCLKs at $BV_{DD}/2$.

3. For purposes of active/float timing measurements, the high impedance or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.

- 4. t_{LBONOT} is a measurement of the minimum time between the negation of LALE and any change in LAD. t_{LBONOT} is determined by LBCR[AHD]. The unit is the eLBC controller clock cycle, which is the internal clock that runs the local bus controller, not the external LCLK. After power on reset, LBCR[AHD] defaults to 0.
- 5. Output hold is negative. This means that output transition happens earlier than the falling edge of LCLK.

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This figure shows the AC timing diagram of the local bus interface.

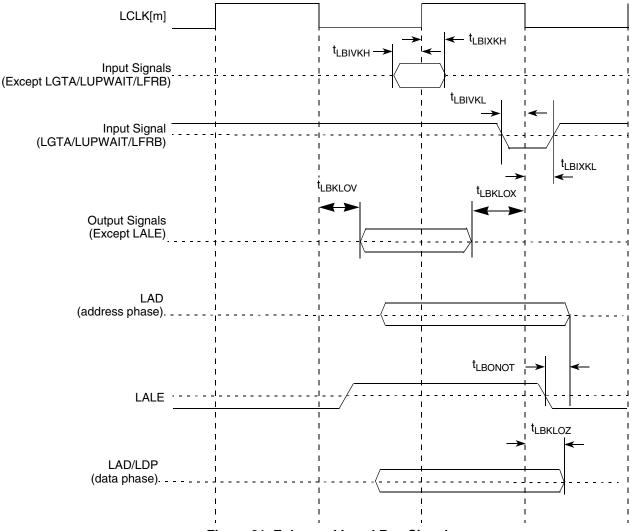


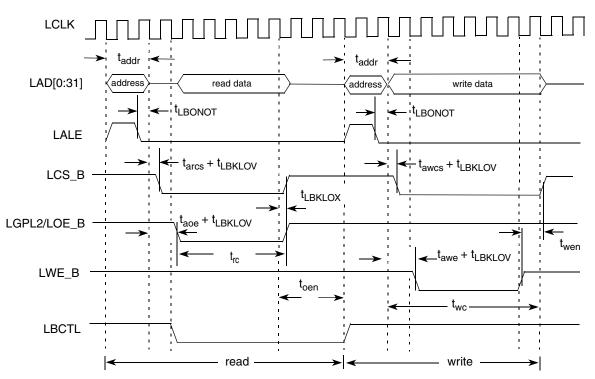
Figure 21. Enhanced Local Bus Signals

Figure 22 applies to all three controllers that eLBC supports: GPCM, UPM, and FCM.

For input signals, the AC timing data is used directly for all three controllers.

For output signals, each type of controller provides its own unique method to control the signal timing. The final signal delay value for output signals is the programmed delay plus the AC timing delay. For example, for GPCM, LCS can be programmed to delay by t_{acs} (0, ¹/₄, ¹/₂, 1, 1 + ¹/₄, 1 + ¹/₂, 2, 3 cycles), so the final delay is $t_{acs} + t_{LBKLOV}$.

This figure shows how the AC timing diagram applies to GPCM. The same principle applies to UPM and FCM.



¹ t_{addr} is programmable and determined by LCRR[EADC] and ORx[EAD].

² t_{arcs}, t_{awcs}, t_{aoe}, t_{rc}, t_{oen}, t_{awe}, t_{wc}, t_{wen} are determined by ORx. See the P3041 QorIQ Integrated Multicore Communication Processor Family Reference Manual.

Figure 22. GPCM Output Timing Diagram

2.14 Enhanced Secure Digital Host Controller (eSDHC)

This section describes the DC and AC electrical specifications for the eSDHC interface.

2.14.1 eSDHC DC Electrical Characteristics

This table provides the DC electrical characteristics for the eSDHC interface.

Table 52. eSDHC Interface DC Electrical Characteristics

For recommended operating conditions, see Table 3.

| Characteristic | Symbol | Condition | Min | Max | Unit | Notes |
|------------------------------|----------------------------------|--|------------------------|----------------------|------|-------|
| Input high voltage | V _{IH} | — | $0.625 \times CV_{DD}$ | — | V | 1 |
| Input low voltage | V _{IL} | _ | — | $0.25\times CV_{DD}$ | V | 1 |
| Input/Output leakage current | I _{IN} /I _{OZ} | _ | -50 | 50 | μA | _ |
| Output high voltage | V _{OH} | I _{OH} = −100 μA at CV _{DD} min | $0.75 \times CV_{DD}$ | _ | V | — |

Table 52. eSDHC Interface DC Electrical Characteristics (continued)

For recommended operating conditions, see Table 3.

| Characteristic | Symbol | Condition | Min | Мах | Unit | Notes |
|---------------------|-----------------|--|------------------------|------------------------|------|-------|
| Output low voltage | V _{OL} | I _{OL} = 100μA at CV _{DD} min | — | $0.125 \times CV_{DD}$ | V | _ |
| Output high voltage | V _{OH} | I _{OH} = −100 μA at CV _{DD} min | CV _{DD} - 0.2 | — | V | 2 |
| Output low voltage | V _{OL} | I _{OL} = 2 mA at CV _{DD} min | — | 0.3 | V | 2 |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max CV_{IN} values found in Table 3.

2. Open drain mode for MMC cards only.

2.14.2 eSDHC AC Timing Specifications

This table provides the eSDHC AC timing specifications as defined in Figure 23 and Figure 24.

Table 53. eSDHC AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Мах | Unit | Notes |
|---|---|------|----------------|------|-------|
| SD_CLK clock frequency: SD/SDIO Full-speed/high-speed mode MMC Full-speed/high-speed mode | fsнscк | 0 | 25/50 20/52 | MHz | 2, 4 |
| SD_CLK clock low time—Full-speed/high-speed mode | t _{SHSCKL} | 10/7 | — | ns | 4 |
| SD_CLK clock high time—Full-speed/high-speed mode | t _{sнscкн} | 10/7 | — | ns | 4 |
| SD_CLK clock rise and fall times | t _{SHSCKR∕} t _{SHSCKF} | — | 3 | ns | 4 |
| Input setup times: SD_CMD, SD_DATx, SD_CD to SD_CLK | t _{SHSIVKH} | 2.5 | — | ns | 4 |
| Input hold times: SD_CMD, SD_DATx, SD_CD to SD_CLK | t _{SHSIXKH} | 2.5 | _ | ns | 3, 4 |
| Output delay time: SD_CLK to SD_CMD, SD_DATx valid | t _{SHSKHOV} | -3 | 3 | ns | 4 |

Notes:

1. The symbols used for timing specifications herein follow the pattern of t_{(first three letters of functional block)(signal)(state)} (reference)(state) for inputs and t_{(first three letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{FHSKHOV} symbolizes eSDHC high-speed mode device timing (SHS) clock reference (K) going to the high (H) state, with respect to the output (O) reaching the invalid state (X) or output hold time. Note that in general, the clock reference symbol is based on five letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

2. In full-speed mode, the clock frequency value can be 0–25 MHz for an SD/SDIO card and 0–20 MHz for an MMC card. In high-speed mode, the clock frequency value can be 0–50 MHz for an SD/SDIO card and 0–52 MHz for an MMC card.

- 3. To satisfy setup timing, the delay difference between clock input and cmd/data input must not exceed 2 ns.
- 4. $C_{CARD} \leq$ 10 pF, (1 card), and C_L = C_{BUS} + C_{HOST} + $C_{CARD} \leq$ 40 pF

This figure provides the eSDHC clock input timing diagram.

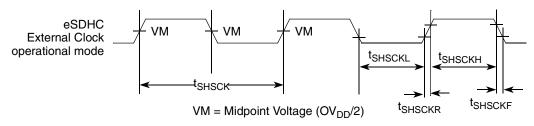
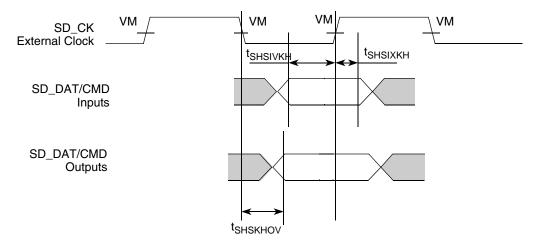


Figure 23. eSDHC Clock Input Timing Diagram

This figure provides the data and command input/output timing diagram.



 $VM = Midpoint Voltage (OV_{DD}/2)$

Figure 24. eSDHC Data and Command Input/Output Timing Diagram Referenced to Clock

2.15 Multicore Programmable Interrupt Controller (MPIC) and Trust Specifications

This section describes the DC and AC electrical specifications for the multicore programmable interrupt controller.

2.15.1 MPIC and Trust DC specifications

This figure provides the DC electrical characteristics for the MPIC interface.

Table 54. MPIC DC Electrical Characteristics (OV_{DD} = 3.3 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|--------------------|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2.0 | _ | V | 1 |
| Input low voltage | V _{IL} | — | 0.8 | V | 1 |

Table 54. MPIC DC Electrical Characteristics (OV_{DD} = 3.3 V) (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|---|-----------------|-----|-----|------|-------|
| Input current ($OV_{IN} = 0 V \text{ or } OV_{IN} = OV_{DD}$) | I _{IN} | — | ±40 | μΑ | 2 |
| Output high voltage ($OV_{DD} = min, I_{OH} = -2 mA$) | V _{OH} | 2.4 | _ | V | — |
| Output low voltage ($OV_{DD} = min$, $I_{OL} = 2 mA$) | V _{OL} | — | 0.4 | V | — |

Note:

1. The min VIL and max VIH values are based on the min and max OVIN respective values found in Table 3

2. The symbol OV_{IN} , in this case, represents the OV_{IN} symbol referenced in Table 3

2.15.2 MPIC and Trust AC Timing Specifications

This table provides the MPIC input and output AC timing specifications.

Table 55. MPIC Input AC Timing Specifications

For recommended operating conditions, see Table 3.

| Characteristic | Symbol | Min | Мах | Unit | Notes |
|----------------------------------|--------------------|-----|-----|---------|-------|
| MPIC inputs—minimum pulse width | t _{PIWID} | 3 | — | SYSCLKs | 1 |
| Trust inputs-minimum pulse width | t _{TIWID} | 3 | — | SYSCLKs | 2 |

Note:

1. MPIC inputs and outputs are asynchronous to any visible clock. MPIC outputs must be synchronized before use by any external synchronous logic. MPIC inputs are required to be valid for at least t_{PIWID} ns to ensure proper operation when working in edge triggered mode

 Trust inputs are asynchronous to any visible clock. Trust inputs are required to be valid for at least t_{TIWID} ns to ensure proper operation when working in edge triggered mode. For low power trust input pin LP_TMP_DETECT, the voltage is V_{DD_LP} and see Table 3 for the voltage requirment.

2.16 JTAG Controller

This section describes the DC and AC electrical specifications for the IEEE 1149.1 (JTAG) interface.

2.16.1 JTAG DC Electrical Characteristics

This table provides the JTAG DC electrical characteristics.

Table 56. JTAG DC Electrical Characteristics ($OV_{DD} = 3.3 V$)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--------------------|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2 | — | V | 1 |
| Input low voltage | V _{IL} | | 0.8 | V | 1 |

Table 56. JTAG DC Electrical Characteristics (OV_{DD} = 3.3 V) (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Max | Unit | Notes |
|---|-----------------|-----|-----|------|-------|
| Input current ($OV_{IN} = 0 V \text{ or } OV_{IN} = OV_{DD}$) | I _{IN} | _ | ±40 | μΑ | 2 |
| Output high voltage ($OV_{DD} = min, I_{OH} = -2 mA$) | V _{OH} | 2.4 | _ | V | — |
| Output low voltage ($OV_{DD} = min$, $I_{OL} = 2 mA$) | V _{OL} | | 0.4 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max OV_{IN} values found in Table 3.

2. The symbol V_{IN} , in this case, represents the OV_{IN} symbol found in Table 3.

2.16.2 JTAG AC Timing Specifications

This table provides the JTAG AC timing specifications as defined in Figure 25 through Figure 28.

| Table | 57. | JTAG | AC | Timina | Specifications |
|-------|-----|------|----|------------|----------------|
| Table | 57. | UIAG | πu | i iiiiiiig | opeenications |

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Max | Unit | Notes |
|--|--------------------------------------|--------------|----------|------|-------|
| JTAG external clock frequency of operation | f _{JTG} | 0 | 33.3 | MHz | — |
| JTAG external clock cycle time | t _{JTG} | 30 | — | ns | — |
| JTAG external clock pulse width measured at OVDD/2 V | t _{JTKHKL} | 15 | — | ns | — |
| JTAG external clock rise and fall times | t _{JTGR} /t _{JTGF} | 0 | 2 | ns | — |
| TRST assert time | t _{TRST} | 25 | — | ns | 2 |
| Input setup times Boundary-scan USB only Boundary (except USB) TDI, TMS | 01DVI(II | 14 4 4 | _ | ns | _ |
| Input hold times | t _{JTDXKH} | 10 | _ | ns | |
| Output valid times Boundary-scan data TDO | t _{JTKLDV} | _ | 15 10 | ns | 3 |
| Output hold times | t _{JTKLDX} | 0 | — | ns | 3 |

Notes:

1. The symbols used for timing specifications follow the pattern t_{(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{JTDVKH} symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{JTG} clock reference (K) going to the high (H) state or setup time. Also, t_{JTDXKH} symbolizes JTAG timing (JT) with respect to the time data input signals (D) reaching the invalid state (X) relative to the t_{JTG} clock reference (K) going to the high (H) state. Note that in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).}

2. TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.

3. All outputs are measured from the midpoint voltage of the falling edge of t_{TCLK} to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50- Ω load. Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.

This figure provides the AC test load for TDO and the boundary-scan outputs of the device.

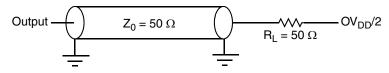


Figure 25. AC Test Load for the JTAG Interface

This figure provides the JTAG clock input timing diagram.

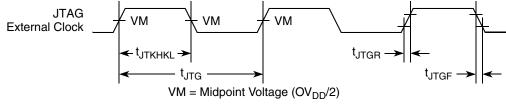
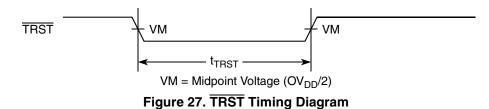


Figure 26. JTAG Clock Input Timing Diagram

This figure provides the $\overline{\text{TRST}}$ timing diagram.



This figure provides the boundary-scan timing diagram.

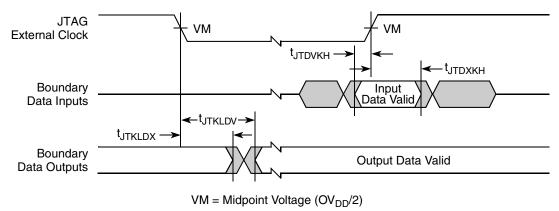


Figure 28. Boundary-Scan Timing Diagram

2.17 l²C

This section describes the DC and AC electrical characteristics for the I²C interface.

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2.17.1 I²C DC Electrical Characteristics

This table provides the DC electrical characteristics for the I^2C interface.

```
Table 58. I<sup>2</sup>C DC Electrical Characteristics (OV<sub>DD</sub> = 3.3 V)
```

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|---|---------------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2 | _ | V | 1 |
| Input low voltage | V _{IL} | — | 0.8 | V | 1 |
| Output low voltage (OV _{DD} = min, I _{OL} = 2 mA) | V _{OL} | 0 | 0.4 | V | 2 |
| Pulse width of spikes which must be suppressed by the input filter | t _{I2KHKL} | 0 | 50 | ns | 3 |
| Input current for each I/O pin (input voltage is between 0.1 \times OV_{DD} and 0.9 \times OV_{DD}(max) | I | -40 | 40 | μA | 4 |
| Capacitance for each I/O pin | CI | — | 10 | pF | |

Notes:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max OV_{IN} values found in Table 3.

2. Output voltage (open drain or open collector) condition = 3 mA sink current.

3. Refer to the P3041QorIQ Integrated Multicore Communication Processor Family Reference Manual for information about the digital filter used.

4. I/O pins obstruct the SDA and SCL lines if $\ensuremath{\mathsf{OV}_{\mathsf{DD}}}$ is switched off.

2.17.2 I²C AC Electrical Specifications

This table provides the AC timing parameters for the I²C interfaces.

Table 59. I²C AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Max | Unit | Notes |
|--|---------------------|-----|-----|------|-------|
| SCL clock frequency | f _{I2C} | 0 | 400 | kHz | 2 |
| Low period of the SCL clock | t _{I2CL} | 1.3 | — | μS | — |
| High period of the SCL clock | t _{I2CH} | 0.6 | — | μs | — |
| Setup time for a repeated START condition | t _{I2SVKH} | 0.6 | — | μS | — |
| Hold time (repeated) START condition (after this period, the first clock pulse is generated) | t _{I2SXKL} | 0.6 | _ | μS | — |
| Data setup time | t _{i2DVKH} | 100 | _ | ns | — |
| Data input hold time: CBUS compatible masters I ² C bus devices | t _{i2DXKL} | 0 | | μs | 3 |
| Data output delay time | t _{I2OVKL} | | 0.9 | μS | 4 |
| Setup time for STOP condition | t _{I2PVKH} | 0.6 | — | μs | — |
| Bus free time between a STOP and START condition | t _{I2KHDX} | 1.3 | — | μs | — |

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Table 59. I²C AC Timing Specifications (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol ¹ | Min | Max | Unit | Notes |
|---|---------------------|----------------------|-----|------|-------|
| Noise margin at the LOW level for each connected device (including hysteresis) | V _{NL} | $0.1 \times OV_{DD}$ | | V | — |
| Noise margin at the HIGH level for each connected device (including hysteresis) | V _{NH} | $0.2 \times OV_{DD}$ | | V | — |
| Capacitive load for each bus line | Cb | _ | 400 | pF | — |

Notes:

- 1. The symbols used for timing specifications herein follow the pattern t(first two letters of functional block)(signal)(state)(reference)(state) for inputs and $t_{(first two letters of functional block)(reference)(state)(signal)(state)}$ for outputs. For example, t_{I2DVKH} symbolizes I²C timing (I2) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{I2C} clock reference (K) going to the high (H) state or setup time. Also, t_{I2SXKL} symbolizes I²C timing (I2) for the time that the data with respect to the START condition (S) went invalid (X) relative to the t_{I2C} clock reference (K) going to the low (L) state or hold time. Also, t_{I2PVKH} symbolizes I²C timing (I2) for the time that the data with respect to the STOP condition (P) reaches the valid state (V) relative to the t_{I2C} clock reference (K) going to the high (H) state or setup time.
- 2. The requirements for I²C frequency calculation must be followed. Refer to Freescale application note AN2919, "Determining the I2C Frequency Divider Ratio for SCL."
- 3. As a transmitter, the device provides a delay time of at least 300 ns for the SDA signal (referred to the VIHmin of the SCL signal) to bridge the undefined region of the falling edge of SCL to avoid unintended generation of a START or STOP condition. When the chip acts as the I²C bus master while transmitting, it drives both SCL and SDA. As long as the load on SCL and SDA are balanced, the chip does not generate an unintended START or STOP condition. Therefore, the 300 ns SDA output delay time is not a concern. If, under some rare condition, the 300 ns SDA output delay time is required for the chip as transmitter, application note AN2919 referred to in note 2 above is recommended.
- 4. The maximum t_{I2OVKI} must be met only if the device does not stretch the LOW period (t_{I2CI}) of the SCL signal.

This figure provides the AC test load for the I^2C .

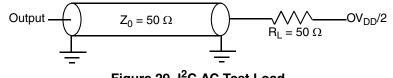


Figure 29. I²C AC Test Load

This figure shows the AC timing diagram for the I^2C bus.

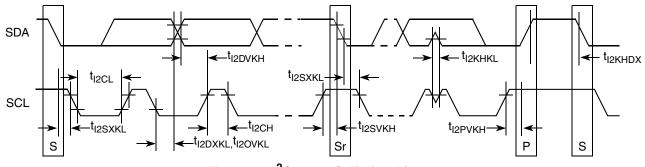


Figure 30. I²C Bus AC Timing Diagram

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2.18 GPIO

This section describes the DC and AC electrical characteristics for the GPIO interface.

2.18.1 GPIO DC Electrical Characteristics

This table provides the DC electrical characteristics for GPIO pins operating at 3.3 V.

Table 60. GPIO DC Electrical Characteristics (LV_{DD} or $OV_{DD} = 3.3 V$)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 2.0 | — | V | 1 |
| Input low voltage | V _{IL} | — | 0.8 | V | 1 |
| Input current (OV _{IN} = 0 V or OV _{IN} = OV _{DD}) | I _{IN} | — | ±40 | μA | 2 |
| Output high voltage (OV _{DD} = min, I _{OH} = -2 mA) | V _{OH} | 2.4 | — | V | — |
| Output low voltage ($OV_{DD} = min, I_{OL} = 2 mA$) | V _{OL} | — | 0.4 | V | — |

Note:

1. The min V_{IL} and max V_{IH} values are based on the min and max L/OV_{IN} respective values found in Table 3.

 The symbol V_{IN}, in this case, represents the L/OV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

This table provides the DC electrical characteristics for GPIO pins operating at $LV_{DD} = 2.5$ V.

Table 61. GPIO DC Electrical Characteristics (LV_{DD} = 2.5 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Мах | Unit | Notes |
|--|-----------------|-----|-----|------|-------|
| Input high voltage | V _{IH} | 1.7 | — | V | 1 |
| Input low voltage | V _{IL} | — | 0.7 | V | 1 |
| Input current ($V_{IN} = 0 V \text{ or } V_{IN} = LV_{DD}$) | I _{IN} | _ | ±40 | μΑ | 2 |
| Output high voltage (LV _{DD} = min, I _{OH} = -2 mA) | V _{OH} | 2.0 | — | V | _ |
| Output low voltage (LV _{DD} = min, I _{OH} = 2 mA) | V _{OL} | — | 0.4 | V | _ |

Note:

1. The min V_{IL} and max V_{IH} values are based on the respective min and max LV_{IN} values found in Table 3.

2. The symbol V_{IN}, in this case, represents the LV_{IN} symbol referenced in Section 2.1.2, "Recommended Operating Conditions."

2.18.2 GPIO AC Timing Specifications

This table provides the GPIO input and output AC timing specifications.

Table 62. GPIO Input AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Unit | Notes |
|---------------------------------|--------------------|-----|------|-------|
| GPIO inputs—minimum pulse width | t _{PIWID} | 20 | ns | 1 |

Notes:

1. GPIO inputs and outputs are asynchronous to any visible clock. GPIO outputs must be synchronized before use by any external synchronous logic. GPIO inputs are required to be valid for at least t_{PIWID} to ensure proper operation.

This figure provides the AC test load for the GPIO.

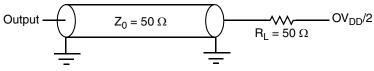


Figure 31. GPIO AC Test Load

2.19 High-Speed Serial Interfaces (HSSI)

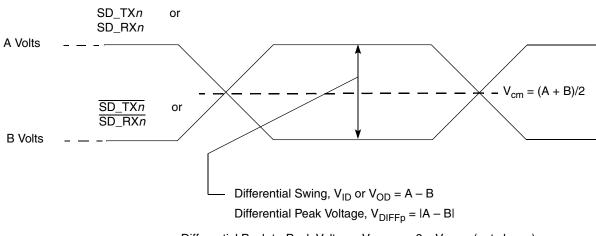
The chip features a serializer/deserializer (SerDes) interface to be used for high-speed serial interconnect applications. The SerDes interface can be used for PCI Express, Serial RapidIO, XAUI, Aurora and SGMII data transfers.

This section describes the common portion of SerDes DC electrical specifications: the DC requirement for SerDes reference clocks. The SerDes data lane's transmitter (Tx) and receiver (Rx) reference circuits are also shown.

2.19.1 Signal Terms Definition

The SerDes utilizes differential signaling to transfer data across the serial link. This section defines the terms that are used in the description and specification of differential signals.

This figure shows how the signals are defined. For illustration purposes only, one SerDes lane is used in the description. Figure 32 shows the waveform for either a transmitter output (SD_TX*n* and \overline{SD} _TX*n*) or a receiver input (SD_RX*n* and \overline{SD} _RX*n*). Each signal swings between A volts and B volts where A > B.



Differential Peak-to-Peak Voltage, $V_{DIFFpp} = 2 \times V_{DIFFp}$ (not shown)

Figure 32. Differential Voltage Definitions for Transmitter or Receiver

Using this waveform, the definitions are as shown in the following list. To simplify the illustration, the definitions assume that the SerDes transmitter and receiver operate in a fully symmetrical differential signaling environment:

Single-Ended Swing The transmitter output signals and the receiver input signals SD_TXn , $\overline{SD_TXn}$, SD_RXn and $\overline{SD_RXn}$ each have a peak-to-peak swing of A - B volts. This is also referred as each signal wire's single-ended swing.

Differential Output Voltage, V_{OD} (or Differential Output Swing)

The differential output voltage (or swing) of the transmitter, V_{OD} , is defined as the difference of the two complimentary output voltages: $V_{SD_TXn} - V_{\overline{SD_TXn}}$. The V_{OD} value can be either positive or negative.

Differential Input Voltage, V_{ID} (or Differential Input Swing)

The differential input voltage (or swing) of the receiver, V_{ID} , is defined as the difference of the two complimentary input voltages: $V_{SD_RXn} - V_{\overline{SD_RXn}}$. The V_{ID} value can be either positive or negative.

Differential Peak Voltage, V_{DIFFp}

The peak value of the differential transmitter output signal or the differential receiver input signal is defined as the differential peak voltage, $V_{DIFFp} = |A - B|$ volts.

Differential Peak-to-Peak, V_{DIFFp-p}

Since the differential output signal of the transmitter and the differential input signal of the receiver each range from A – B to –(A – B) volts, the peak-to-peak value of the differential transmitter output signal or the differential receiver input signal is defined as differential peak-to-peak voltage, $V_{DIFFp-p} = 2 \times V_{DIFFp} = 2 \times |(A - B)|$ volts, which is twice the differential swing in amplitude, or twice of the differential peak. For example, the output differential peak-to-peak voltage can also be calculated as $V_{TX-DIFFp-p} = 2 \times |V_{OD}|$.

Differential Waveform

The differential waveform is constructed by subtracting the inverting signal ($\overline{SD_TXn}$, for example) from the non-inverting signal ($\overline{SD_TXn}$, for example) within a differential pair. There is

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only one signal trace curve in a differential waveform. The voltage represented in the differential waveform is not referenced to ground. Refer to Figure 37 as an example for differential waveform.

Common Mode Voltage, V_{cm}

The common mode voltage is equal to half of the sum of the voltages between each conductor of a balanced interchange circuit and ground. In this example, for SerDes output,

 $V_{cm_out} = (V_{SD_TXn} + V_{\overline{SD_TXn}}) \div 2 = (A + B) \div 2$, which is the arithmetic mean of the two complimentary output voltages within a differential pair. In a system, the common mode voltage may often differ from one component's output to the other's input. It may be different between the receiver input and driver output circuits within the same component. It is also referred to as the DC offset on some occasions.

To illustrate these definitions using real values, consider the example of a current mode logic (CML) transmitter that has a common mode voltage of 2.25 V and outputs, TD and TD. If these outputs have a swing from 2.0 V to 2.5 V, the peak-to-peak voltage swing of each signal (TD or TD) is 500 mV p-p, which is referred to as the single-ended swing for each signal. Because the differential signaling environment is fully symmetrical in this example, the transmitter output's differential swing (V_{OD}) has the same amplitude as each signal's single-ended swing. The differential output signal ranges between 500 mV and –500 mV. In other words, V_{OD} is 500 mV in one phase and –500 mV in the other phase. The peak differential voltage (V_{DIFFp}) is 500 mV. The peak-to-peak differential voltage (V_{DIFFp}) is 1000 mV p-p.

2.19.2 SerDes Reference Clocks

The SerDes reference clock inputs are applied to an internal PLL whose output creates the clock used by the corresponding SerDes lanes. The SerDes reference clocks inputs are SD_REF_CLK1 and <u>SD_REF_CLK1</u> for SerDes bank1, SD_REF_CLK2 and <u>SD_REF_CLK2</u> for SerDes bank2, and SD_REF_CLK3 and <u>SD_REF_CLK3</u> for SerDes bank3.

SerDes banks 1–3 may be used for various combinations of the following IP blocks based on the RCW Configuration field SRDS_PRTCL:

- SerDes bank 1: PEX1/2/3/4, sRIO1/2, SGMII (1.25 Gbps only) or Aurora.
- SerDes bank 2: PEX3, SGMII (1.25 or 3.125 GBaud) or XAUI.
- SerDes bank 3: sRIO1, SATA, SGMII (1.25 or 3.125 GBaud) or XAUI.

The following sections describe the SerDes reference clock requirements and provide application information.

2.19.2.1 SerDes Reference Clock Receiver Characteristics

This figure shows a receiver reference diagram of the SerDes reference clocks.

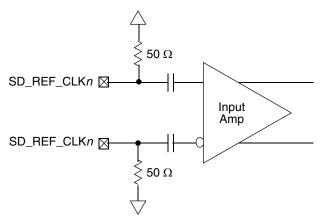


Figure 33. Receiver of SerDes Reference Clocks

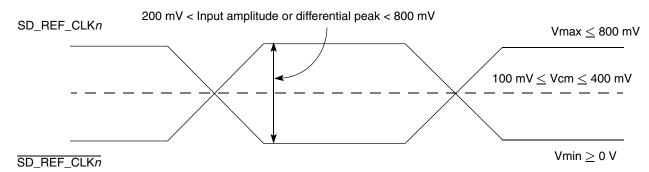
The characteristics of the clock signals are as follows:

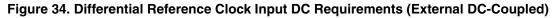
- The SerDes transceivers core power supply voltage requirements (SV_{DD}) are as specified in Section 2.1.2, "Recommended Operating Conditions."
- The SerDes reference clock receiver reference circuit structure is as follows:
 - The SD_REF_CLKn and SD_REF_CLKn are internally AC-coupled differential inputs as shown in Figure 33.
 Each differential clock input (SD_REF_CLKn or SD_REF_CLKn) has on-chip 50-Ω termination to SGND followed by on-chip AC-coupling.
 - The external reference clock driver must be able to drive this termination.
 - The SerDes reference clock input can be either differential or single-ended. Refer to the differential mode and single-ended mode descriptions below for detailed requirements.
- The maximum average current requirement also determines the common mode voltage range.
 - When the SerDes reference clock differential inputs are DC coupled externally with the clock driver chip, the maximum average current allowed for each input pin is 8 mA. In this case, the exact common mode input voltage is not critical as long as it is within the range allowed by the maximum average current of 8 mA because the input is AC-coupled on-chip.
 - This current limitation sets the maximum common mode input voltage to be less than $0.4 \text{ V} (0.4 \text{ V} \div 50 = 8 \text{ mA})$ while the minimum common mode input level is 0.1 V above SGND. For example, a clock with a 50/50 duty cycle can be produced by a clock driver with output driven by its current source from 0 mA to 16 mA (0–0.8 V), such that each phase of the differential input has a single-ended swing from 0 V to 800 mV with the common mode voltage at 400 mV.
 - If the device driving the SD_REF_CLK*n* and $\overline{SD_REF_CLKn}$ inputs cannot drive 50 Ω to SGND DC or the drive strength of the clock driver chip exceeds the maximum input current limitations, it must be AC-coupled off-chip.
- The input amplitude requirement is described in detail in the following sections.

2.19.2.2 DC Level Requirement for SerDes Reference Clocks

The DC level requirement for the SerDes reference clock inputs is different depending on the signaling mode used to connect the clock driver chip and SerDes reference clock inputs, as described below:

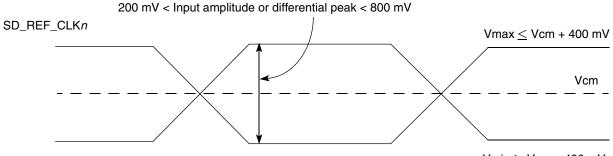
- Differential Mode
 - The input amplitude of the differential clock must be between 400 mV and 1600 mV differential peak-to-peak (or between 200 mV and 800 mV differential peak). In other words, each signal wire of the differential pair must have a single-ended swing of less than 800 mV and greater than 200 mV. This requirement is the same for both external DC-coupled or AC-coupled connection.
 - For an external DC-coupled connection, as described in Section 2.19.2.1, "SerDes Reference Clock Receiver Characteristics," the maximum average current requirements sets the requirement for average voltage (common mode voltage) as between 100 mV and 400 mV. Figure 34 shows the SerDes reference clock input requirement for DC-coupled connection scheme.





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— For an external AC-coupled connection, there is no common mode voltage requirement for the clock driver. Because the external AC-coupling capacitor blocks the DC level, the clock driver and the SerDes reference clock receiver operate in different common mode voltages. The SerDes reference clock receiver in this connection scheme has its common mode voltage set to SGND. Each signal wire of the differential inputs is allowed to swing below and above the common mode voltage (SGND). Figure 35 shows the SerDes reference clock input requirement for AC-coupled connection scheme.



SD_REF_CLKn

 $Vmin \ge Vcm - 400 mV$



- Single-Ended Mode
 - The reference clock can also be single-ended. The SD_REF_CLKn input amplitude (single-ended swing) must be between 400 mV and 800 mV peak-to-peak (from V_{MIN} to V_{MAX}) with SD_REF_CLKn either left unconnected or tied to ground.
 - The SD_REF_CLKn input average voltage must be between 200 and 400 mV. Figure 36 shows the SerDes reference clock input requirement for single-ended signaling mode.
 - To meet the input amplitude requirement, the reference clock inputs may need to be DC- or AC-coupled externally. For the best noise performance, the reference of the clock could be DC- or AC-coupled into the unused phase (SD_REF_CLKn) through the same source impedance as the clock input (SD_REF_CLKn) in use.

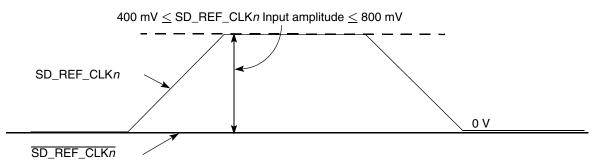


Figure 36. Single-Ended Reference Clock Input DC Requirements

2.19.2.3 AC Requirements for SerDes Reference Clocks

This table lists AC requirements for the PCI Express, SGMII, Serial RapidIO and Aurora SerDes reference clocks to be guaranteed by the customer's application design.

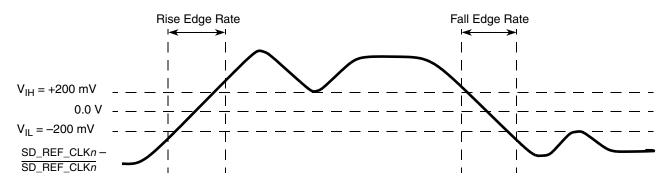
Table 63. SD_REF_CLK*n* and $\overline{SD_REF_CLKn}$ Input Clock Requirements (SV_{DD} = 1.0 V)

For recommended operating conditions, see Table 3.

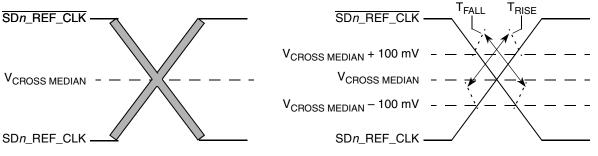
| Parameter | Symbol | Min | Тур | Max | Unit | Notes |
|--|--|------|----------------|------|------|-------|
| SD_REF_CLK/SD_REF_CLK frequency range | ^t CLK_REF | _ | 100/125/156.25 | _ | MHz | 1 |
| SD_REF_CLK/SD_REF_CLK clock frequency tolerance | ^t CLK_TOL | -350 | — | 350 | ppm | — |
| SD_REF_CLK/SD_REF_CLK reference clock duty cycle | ^t CLK_DUTY | 40 | 50 | 60 | % | 4 |
| SD_REF_CLK/ <u>SD_REF_CLK</u> max deterministic peak-to-peak jitter at 10 ⁻⁶ BER | ^t CLK_DJ | _ | | 42 | ps | — |
| SD_REF_CLK/SD_REF_CLK total reference clock jitter at 10 ⁻⁶ BER (peak-to-peak jitter at refClk input) | ^t CLK_TJ | _ | — | 86 | ps | 2 |
| SD_REF_CLK/SD_REF_CLK rising/falling edge rate | ^t CLKRR/ ^t CLKFR | 1 | | 4 | V/ns | 3 |
| Differential input high voltage | V _{IH} | 200 | _ | | mV | 4 |
| Differential input low voltage | V _{IL} | _ | — | -200 | mV | 4 |
| Rising edge rate (SD_REF_CLK <i>n</i>) to falling edge rate (SD_REF_CLK <i>n</i>) matching | Rise-Fall Matching | | — | 20 | % | 5, 6 |

Notes:

- 1. Caution: Only 100, 125 and 156.25 have been tested. In-between values do not work correctly with the rest of the system.
- 2. Limits from PCI Express CEM Rev 2.0
- 3. Measured from –200 mV to +200 mV on the differential waveform (derived from SD_REF_CLK*n* minus SD_REF_CLK*n*). The signal must be monotonic through the measurement region for rise and fall time. The 400 mV measurement window is centered on the differential zero crossing. See Figure 37.
- 4. Measurement taken from differential waveform
- 5. Measurement taken from single-ended waveform
- 6. Matching applies to rising edge for SD_REF_CLKn and falling edge rate for SD_REF_CLKn. It is measured using a 200 mV window centered on the median cross point where SD_REF_CLKn rising meets SD_REF_CLKn falling. The median cross point is used to calculate the voltage thresholds that the oscilloscope uses for the edge rate calculations. The rise edge rate of SD_REF_CLKn must be compared to the fall edge rate of SD_REF_CLKn, the maximum allowed difference should not exceed 20% of the slowest edge rate. See Figure 38.









2.19.2.4 Spread Spectrum Clock

SD_REF_CLK1/SD_REF_CLK1 were designed to work with a spread spectrum clock (+0 to 0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock. For better results, a source without significant unintended modulation must be used.

SD_REF_CLK2/SD_REF_CLK2 were designed to work with a spread spectrum clock (+0 to 0.5% spreading at 30–33 kHz rate is allowed), assuming both ends have same reference clock and the industry protocol specifications supports it. For better results, a source without significant unintended modulation must be used.

SD_REF_CLK3/SD_REF_CLK3 are not intended to be used with, and should not be clocked by, a spread spectrum clock source.

2.19.3 SerDes Transmitter and Receiver Reference Circuits

This figure shows the reference circuits for SerDes data lane's transmitter and receiver.

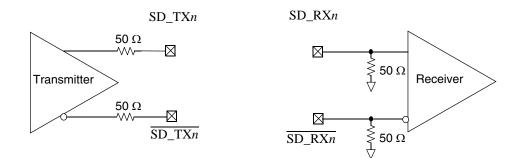


Figure 39. SerDes Transmitter and Receiver Reference Circuits

The DC and AC specification of SerDes data lanes are defined in each interface protocol section below based on the application usage:

- Section 2.19.4, "PCI Express"
- Section 2.19.5, "Serial RapidIO (sRIO)"
- Section 2.19.6, "XAUI"
- Section 2.19.7, "Aurora"
- Section 2.19.8, "Serial ATA (SATA)
- Section 2.19.9, "SGMII Interface"

Note that external AC-coupling capacitor is required for the above serial transmission protocols per the protocol's standard requirements.

2.19.4 PCI Express

This section describes the clocking dependencies, DC and AC electrical specifications for the PCI Express bus.

2.19.4.1 Clocking Dependencies

The ports on the two ends of a link must transmit data at a rate that is within 600 parts per million (ppm) of each other at all times. This is specified to allow bit rate clock sources with a \pm 300 ppm tolerance.

2.19.4.2 PCI Express Clocking Requirements for SD_REF_CLK*n* and SD_REF_CLK*n*

SerDes banks 1–2 (SD_REF_CLK[1:2] and SD_REF_CLK[1:2]) may be used for various SerDes PCI Express configurations based on the RCW Configuration field SRDS_PRTCL. PCI Express is not supported on SerDes bank 3.

For more information on these specifications, see Section 2.19.2, "SerDes Reference Clocks."

2.19.4.3 PCI Express DC Physical Layer Specifications

This section contains the DC specifications for the physical layer of PCI Express on this device.

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2.19.4.3.1 PCI Express DC Physical Layer Transmitter Specifications

This section discusses the PCI Express DC physical layer transmitter specifications for 2.5 GT/s and 5 GT/s.

This table defines the PCI Express 2.0 (2.5 GT/s) DC specifications for the differential output at all transmitters. The parameters are specified at the component pins.

Table 64. PCI Express 2.0 (2.5 GT/s) Differential Transmitter (Tx) Output DC Specifications(XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Units | Notes |
|---|--------------------------|-----|---------|------|-------|--|
| Differential peak-to-peak output voltage | V _{TX-DIFFp-p} | 800 | — | 1200 | mV | $V_{TX-DIFFp-p} = 2 \times V_{TX-D+} - V_{TX-D-} $ See Note 1. |
| De-emphasized differential output voltage (ratio) | V _{TX-DE-RATIO} | 3.0 | 3.5 | 4.0 | dB | Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. See Note 1. |
| DC differential Tx impedance | Z _{TX-DIFF-DC} | 80 | 100 | 120 | Ω | Tx DC differential mode low Impedance |
| Transmitter DC impedance | Z _{TX-DC} | 40 | 50 | 60 | Ω | Required Tx D+ as well as D– DC Impedance during all states |

Note:

1. Measured at the package pins with a test load of 50Ω to GND on each pin.

This table defines the PCI Express 2.0 (5 GT/s) DC specifications for the differential output at all transmitters. The parameters are specified at the component pins.

Table 65. PCI Express 2.0 (5 GT/s) Differential Transmitter (Tx) Output DC Specifications $(XV_{DD} = 1.5 \text{ V or } 1.8 \text{ V})$

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Units | Notes |
|---|--------------------------------|-----|---------|------|-------|--|
| Differential peak-to-peak output voltage | V _{TX-DIFFp-p} | 800 | — | 1200 | mV | $V_{TX-DIFFp-p} = 2 \times V_{TX-D+} - V_{TX-D-} $ See Note 1. |
| Low power differential peak-to-peak output voltage | V _{TX-DIFFp-p_low} | 400 | 500 | 1200 | mV | $V_{TX-DIFFp-p} = 2 \times V_{TX-D+} - V_{TX-D-} $ See Note 1. |
| De-emphasized differential output voltage (ratio) | V _{TX-DE-RATIO-3.5dB} | 3.0 | 3.5 | 4.0 | dB | Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. See Note 1. |
| De-emphasized differential output voltage (ratio) | V _{TX-DE-RATIO-6.0dB} | 5.5 | 6.0 | 6.5 | dB | Ratio of the $V_{TX-DIFFp-p}$ of the second and following bits after a transition divided by the $V_{TX-DIFFp-p}$ of the first bit after a transition. See Note 1. |
| DC differential Tx impedance | Z _{TX-DIFF-DC} | 80 | 100 | 120 | Ω | Tx DC differential mode low impedance |

Table 65. PCI Express 2.0 (5 GT/s) Differential Transmitter (Tx) Output DC Specifications(XV_{DD} = 1.5 V or 1.8 V) (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Units | Notes |
|--------------------------|--------------------|-----|---------|-----|-------|---|
| Transmitter DC Impedance | Z _{TX-DC} | 40 | 50 | 60 | | Required Tx D+ as well as D– DC impedance during all states |

Note:

1. Measured at the package pins with a test load of 50 Ω to GND on each pin.

2.19.4.4 PCI Express DC Physical Layer Receiver Specifications

This section discusses the PCI Express DC physical layer receiver specifications 2.5 GT/s, and 5 GT/s

This table defines the DC specifications for the PCI Express 2.0 (2.5 GT/s) differential input at all receivers. The parameters are specified at the component pins.

Table 66. PCI Express 2.0 (2.5 GT/s) Differential Receiver (Rx) Input DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|---|----------------------------------|------|-----|------|-------|--|
| Differential input peak-to-peak voltage | V _{RX-DIFFp-p} | 120 | — | 1200 | mV | $V_{RX-DIFFp-p} = 2 \times V_{RX-D+} - V_{RX-D-} $ See Note 1. |
| DC differential input impedance | Z _{RX-DIFF-DC} | 80 | 100 | 120 | Ω | Rx DC differential mode impedance. See Note 2 |
| DC input impedance | Z _{RX-DC} | 40 | 50 | 60 | Ω | Required Rx D+ as well as D– DC Impedance (50 \pm 20% tolerance). See Notes 1 and 2. |
| Powered down DC input impedance | Z _{RX-HIGH-IMP-DC} | 50 k | | _ | Ω | Required Rx D+ as well as D– DC Impedance when the receiver terminations do not have power. See Note 3. |
| Electrical idle detect threshold | V _{RX-IDLE-DET-DIFFp-p} | 65 | | 175 | mV | $V_{RX-IDLE-DET-DIFFp-p} =$ 2 × IV _{RX-D+} – V _{RX-D-} I Measured at the package pins of the receiver |

Notes:

1. Measured at the package pins with a test load of 50Ω to GND on each pin.

2. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.

3. The Rx DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the Rx ground.

This table defines the DC specifications for the PCI Express 2.0 (5 GT/s) differential input at all receivers (RXs). The parameters are specified at the component pins.

Table 67. PCI Express 2.0 (5 GT/s) Differential Receiver (Rx) Input DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|---|----------------------------------|-----|-----|------|-------|---|
| Differential input peak-to-peak voltage | V _{RX-DIFFp-p} | 120 | — | 1200 | V | $V_{RX-DIFFp-p} = 2 \times V_{RX-D+} - V_{RX-D-} $ See Note 1. |
| DC differential input impedance | Z _{RX-DIFF-DC} | 80 | 100 | 120 | Ω | Rx DC Differential mode impedance. See Note 2 |
| DC input impedance | Z _{RX-DC} | 40 | 50 | 60 | Ω | Required Rx D+ as well as D– DC Impedance (50 ±20% tolerance). See Notes 1 and 2. |
| Powered down DC input impedance | Z _{RX-HIGH-IMP-DC} | 50 | | | kΩ | Required Rx D+ as well as D– DC Impedance when the Receiver terminations do not have power. See Note 3. |
| Electrical idle detect threshold | V _{RX-IDLE-DET-DIFFp-p} | 65 | | 175 | mV | $V_{RX-IDLE-DET-DIFFp-p} =$ 2 × IV _{RX-D+} – V _{RX-D} I Measured at the package pins of the receiver |

Notes:

1. Measured at the package pins with a test load of 50Ω to GND on each pin.

2. Impedance during all LTSSM states. When transitioning from a fundamental reset to detect (the initial state of the LTSSM) there is a 5 ms transition time before receiver termination values must be met on all unconfigured lanes of a port.

3. The Rx DC common mode impedance that exists when no power is present or fundamental reset is asserted. This helps ensure that the receiver detect circuit does not falsely assume a receiver is powered on when it is not. This term must be measured at 300 mV above the Rx ground.

2.19.4.5 PCI Express AC Physical Layer Specifications

This section contains the DC specifications for the physical layer of PCI Express on this device.

2.19.4.5.1 PCI Express AC Physical Layer Transmitter Specifications

This section discusses the PCI Express AC physical layer transmitter specifications 2.5 GT/s and 5 GT/s.

This table defines the PCI Express 2.0 (2.5 GT/s) AC specifications for the differential output at all transmitters (TXs). The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

Table 68. PCI Express 2.0 (2.5 GT/s) Differential Transmitter (Tx) Output AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|--|---|--------|-----|--------|-------|---|
| Unit interval | UI | 399.88 | 400 | 400.12 | ps | Each UI is 400 ps ± 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1. |
| Minimum Tx eye width | T _{TX-EYE} | 0.75 | _ | | UI | The maximum transmitter jitter can be derived as $T_{TX-MAX-JITTER} = 1 - T_{TX-EYE} = 0.25$ UI. Does not include spread spectrum or RefCLK jitter. Includes device random jitter at 10 ⁻¹² . See Notes 2 and 3. |
| Maximum time between the jitter median and maximum deviation from the median | T _{TX-EYE-MEDIAN-} to- MAX-JITTER | | | 0.125 | UI | Jitter is defined as the measurement variation of the crossing points ($V_{TX-DIFFp-p} = 0$ V) in relation to a recovered Tx UI. A recovered Tx UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the Tx UI. See Notes 2 and 3. |
| AC coupling capacitor | C _{TX} | 75 | _ | 200 | nF | All transmitters must be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See Note 4. |

Notes:

- 2. Specified at the measurement point into a timing and voltage test load as shown in Figure 40 and measured over any 250 consecutive Tx UIs.
- 3. A $T_{TX-EYE} = 0.75$ UI provides for a total sum of deterministic and random jitter budget of $T_{TX-JITTER-MAX} = 0.25$ UI for the transmitter collected over any 250 consecutive Tx UIs. The $T_{TX-EYE-MEDIAN-to-MAX-JITTER}$ median is less than half of the total Tx jitter budget collected over any 250 consecutive Tx UIs. It must be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value.
- 4. The chip's SerDes transmitter does not have C_{TX} built-in. An external AC coupling capacitor is required.

^{1.} No test load is necessarily associated with this value.

This table defines the PCI Express 2.0 (5 GT/s) AC specifications for the differential output at all transmitters. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

Table 69. PCI Express 2.0 (5 GT/s) Differential Transmitter (Tx) Output AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|--|--------------------------|--------|--------|--------|-------|---|
| Unit Interval | UI | 199.94 | 200.00 | 200.06 | ps | Each UI is 400 ps \pm 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1. |
| Minimum Tx eye width | T _{TX-EYE} | 0.75 | _ | _ | UI | The maximum transmitter jitter can be derived as: $T_{TX-MAX-JITTER} = 1 - T_{TX-EYE} = 0.25$ UI. See Notes 2 and 3. |
| Tx RMS deterministic jitter > 1.5 MHz | T _{TX-HF-DJ-DD} | _ | — | 0.15 | ps | _ |
| Tx RMS deterministic jitter < 1.5 MHz | T _{TX-LF-RMS} | _ | 3.0 | — | ps | Reference input clock RMS jitter (< 1.5 MHz) at pin < 1 ps |
| AC coupling capacitor | C _{TX} | 75 | | 200 | nF | All transmitters must be AC coupled. The AC coupling is required either within the media or within the transmitting component itself. See Note 4. |

Notes:

1. No test load is necessarily associated with this value.

- 2. Specified at the measurement point into a timing and voltage test load as shown in Figure 40 and measured over any 250 consecutive Tx UIs.
- 3. A T_{TX-EYE} = 0.75 UI provides for a total sum of deterministic and random jitter budget of T_{TX-JITTER-MAX} = 0.25 UI for the Transmitter collected over any 250 consecutive Tx UIs. The T_{TX-EYE-MEDIAN-to-MAX-JITTER} median is less than half of the total Tx jitter budget collected over any 250 consecutive Tx UIs. It must be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value.
- 4. The chip's SerDes transmitter does not have C_{TX} built-in. An external AC coupling capacitor is required.

2.19.4.5.2 PCI Express AC Physical Layer Receiver Specifications

This section discusses the PCI Express AC physical layer receiver specifications 2.5 GT/s and 5 GT/s.

This table defines the AC specifications for the PCI Express 2.0 (2.5 GT/s) differential input at all receivers. The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

Table 70. PCI Express 2.0 (2.5 GT/s) Differential Receiver (Rx) Input AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|---|---|--------|--------|--------|-------|--|
| Unit Interval | UI | 399.88 | 400.00 | 400.12 | ps | Each UI is 400 ps \pm 300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1. |
| Minimum receiver eye width | T _{RX-EYE} | 0.4 | _ | | UI | The maximum interconnect media and Transmitter jitter that can be tolerated by the Receiver can be derived as $T_{RX-MAX-JITTER} = 1 - T_{RX-EYE} = 0.6$ UI. See Notes 2 and 3. |
| Maximum time between the jitter median and maximum deviation from the median. | T _{RX-EYE-MEDIAN-} to-MAX-JITTER | | | 0.3 | UI | Jitter is defined as the measurement variation of the crossing points ($V_{RX-DIFFp-p} = 0$ V) in relation to a recovered Tx UI. A recovered Tx UI is calculated over 3500 consecutive unit intervals of sample data. Jitter is measured using all edges of the 250 consecutive UI in the center of the 3500 UI used for calculating the Tx UI. See Notes 2, 3 and 4. |

Notes:

1. No test load is necessarily associated with this value.

- 2. Specified at the measurement point and measured over any 250 consecutive UIs. The test load in Figure 40 must be used as the Rx device when taking measurements. If the clocks to the Rx and Tx are not derived from the same reference clock, the Tx UI recovered from 3500 consecutive UI must be used as a reference for the eye diagram.
- 3. A T_{RX-EYE} = 0.40 UI provides for a total sum of 0.60 UI deterministic and random jitter budget for the Transmitter and interconnect collected any 250 consecutive UIs. The TRX-EYE-MEDIAN-to-MAX-JITTER specification ensures a jitter distribution in which the median and the maximum deviation from the median is less than half of the total. UI jitter budget collected over any 250 consecutive Tx UIs. It must be noted that the median is not the same as the mean. The jitter median describes the point in time where the number of jitter points on either side is approximately equal as opposed to the averaged time value. If the clocks to the Rx and Tx are not derived from the same reference clock, the Tx UI recovered from 3500 consecutive UI must be used as the reference for the eye diagram.
- 4. It is recommended that the recovered Tx UI is calculated using all edges in the 3500 consecutive UI interval with a fit algorithm using a minimization merit function. Least squares and median deviation fits have worked well with experimental and simulated data.

This table defines the AC specifications for the PCI Express 2.0 (5 GT/s) differential input at all receivers (RXs). The parameters are specified at the component pins. The AC timing specifications do not include RefClk jitter.

Table 71. PCI Express 2.0 (5 GT/s) Differential Receiver (Rx) Input AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|--|--------------------------|--------|--------|--------|-------|--|
| Unit Interval | UI | 199.40 | 200.00 | 200.06 | ps | Each UI is 400 ps ±300 ppm. UI does not account for spread spectrum clock dictated variations. See Note 1. |
| Max Rx inherent timing error | T _{RX-TJ-CC} | — | — | 0.4 | UI | The maximum inherent total timing error for common RefClk Rx architecture |
| Maximum time between the jitter median and maximum deviation from the median | T _{RX-TJ-DC} | — | _ | 0.34 | UI | Max Rx inherent total timing error |
| Max Rx inherent deterministic timing error | T _{RX-DJ-DD-CC} | — | — | 0.30 | UI | The maximum inherent deterministic timing error for common RefClk Rx architecture |
| Max Rx inherent deterministic timing error | T _{RX-DJ-DD-DC} | — | — | 0.24 | UI | The maximum inherent deterministic timing error for common RefClk Rx architecture |

Note:

1. No test load is necessarily associated with this value.

2.19.4.6 Test and Measurement Load

The AC timing and voltage parameters must be verified at the measurement point. The package pins of the device must be connected to the test/measurement load within 0.2 inches of that load, as shown in the following figure.

NOTE

The allowance of the measurement point to be within 0.2 inches of the package pins is meant to acknowledge that package/board routing may benefit from D+ and D- not being exactly matched in length at the package pin boundary. If the vendor does not explicitly state where the measurement point is located, the measurement point is assumed to be the D+ and D- package pins.

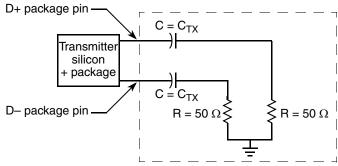


Figure 40. Test/Measurement Load

2.19.5 Serial RapidIO (sRIO)

This section describes the DC and AC electrical specifications for the Serial RapidIO interface of the LP-Serial physical layer. The electrical specifications cover both single and multiple-lane links. Two transmitters (short run and long run) and a single receiver are specified for each of three baud rates:

Two transmitter specifications allow for solutions ranging from simple board-to-board interconnect to driving two connectors across a backplane. A single receiver specification is given that accepts signals from both the short run and long run transmitter specifications.

The short run transmitter must be used mainly for chip-to-chip connections on either the same printed circuit board or across a single connector. This covers the case where connections are made to a mezzanine (daughter) card. The minimum swings of the short run specification reduce the overall power used by the transceivers.

The long run transmitter specifications use larger voltage swings that are capable of driving signals across backplanes. This allows a user to drive signals across two connectors and a backplane. The specifications allow a distance of at least 50 cm at all baud rates.

All unit intervals are specified with a tolerance of ± 100 ppm. The worst case frequency difference between any transmit and receive clock is 200 ppm.

To ensure interoperability between drivers and receivers of different vendors and technologies, AC coupling at the receiver input must be used.

2.19.5.1 Signal Definitions

This section defines the terms used in the description and specification of the differential signals used by the LP-Serial links. The following figure shows how the signals are defined. The figures show waveforms for either a transmitter output (TD and $\overline{\text{TD}}$) or a receiver input (RD and $\overline{\text{RD}}$). Each signal swings between A volts and B volts where A > B. Using these waveforms, the definitions are as follows:

- The transmitter output signals and the receiver input signals—TD, TD, RD, and RD—each have a peak-to-peak swing of A B volts.
- The differential output signal of the transmitter, V_{OD} , is defined as $V_{TD} V_{\overline{TD}}$
- The differential input signal of the receiver, V_{ID} , is defined as $V_{RD} V_{\overline{RD}}$
- The differential output signal of the transmitter and the differential input signal of the receiver each range from A B to -(A B) volts
- The peak value of the differential transmitter output signal and the differential receiver input signal is A B volts.
- The peak-to-peak value of the differential transmitter output signal and the differential receiver input signal is $2 \times (A B)$ volts.

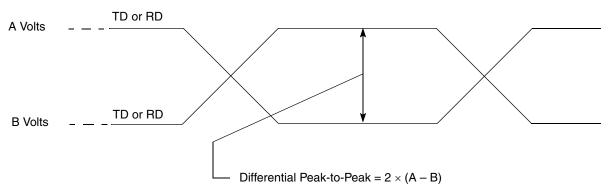


Figure 41. Differential Peak-to-Peak Voltage of Transmitter or Receiver

To illustrate these definitions using real values, consider the case of a CML (current mode logic) transmitter that has a common mode voltage of 2.25 V, and each of its outputs TD and $\overline{\text{TD}}$, has a swing that goes between 2.5 V and 2.0 V. Using these values, the peak-to-peak voltage swing of the signals TD and $\overline{\text{TD}}$ is 500 mV p-p. The differential output signal ranges between 500 mV and -500 mV. The peak differential voltage is 500 mV. The peak-to-peak differential voltage is 1000 mV p-p.

2.19.5.2 Equalization

With the use of high-speed serial links, the interconnect media causes degradation of the signal at the receiver and produces effects such as inter-symbol interference (ISI) or data-dependent jitter. This loss can be large enough to degrade the eye opening at the receiver beyond what is allowed in the specification. To negate a portion of these effects, equalization can be used. The most common equalization techniques that can be used are as follows:

- Pre-emphasis on the transmitter
- A passive high-pass filter network placed at the receiver, often referred to as passive equalization.
- The use of active circuits in the receiver, often referred to as adaptive equalization.

2.19.5.3 <u>Serial RapidIO Clocking Requirements for SD_REF_CLK*n* and SD_REF_CLK*n*</u>

SerDes bank 1 and bank 3 (SD_REF_CLK1 and SD_REF_CLK1) may be used for various SerDes Serial RapidIO configurations based on the RCW Configuration field SRDS_PRTCL. Serial RapidIO is not supported on SerDes banks 2.

For more information on these specifications, see Section 2.19.2, "SerDes Reference Clocks."

2.19.5.4 DC Requirements for Serial RapidIO

This section explains the DC requirements for the Serial RapidIO interface.

2.19.5.4.1 DC Serial RapidIO Timing Transmitter Specifications

LP-Serial transmitter electrical and timing specifications are stated in the text and tables of this section.

The differential return loss, S11, of the transmitter in each case is better than the following:

- $-10 \text{ dB for (Baud Frequency)} \div 10 < \text{Freq(f)} < 625 \text{ MHz}$
- $-10 \text{ dB} + 10\log(\text{f} \div 625 \text{ MHz}) \text{ dB}$ for $625 \text{ MHz} \le \text{Freq}(\text{f}) \le \text{Baud}$ Frequency

The reference impedance for the differential return loss measurements is $100-\Omega$ resistive. Differential return loss includes contributions from on-chip circuitry, chip packaging, and any off-chip components related to the driver. The output impedance requirement applies to all valid output levels.

It is recommended that the 20%–80% rise/fall time of the transmitter, as measured at the transmitter output, have a minimum value 60 ps in each case.

It is recommended that the timing skew at the output of an LP-Serial transmitter between the two signals that comprise a differential pair not exceed 20 ps at 2.50 GBaud and 15 ps at 3.125 GBaud.

This table defines the transmitter DC specifications for Serial RapidIO operating at $XV_{DD} = 1.5$ V or 1.8 V.

Table 72. Serial RapidIO Transmitter DC Timing Specifications—2.5 GBaud, 3.125 GBaud, 5 GBaud

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Unit | Notes |
|---------------------------------------|---------------------|-------|-----|------|--------|-------|
| Output Voltage, | V _O | -0.40 | _ | 2.30 | V | 1 |
| Long-run differential output voltage | V _{DIFFPP} | 800 | _ | 1600 | mV p-p | — |
| Short-run differential output voltage | V _{DIFFPP} | 500 | _ | 1000 | mV p-p | — |

Note:

1. Voltage relative to COMMON of either signal comprising a differential pair.

2.19.5.4.2 DC Serial RapidIO Receiver Specifications

LP-Serial receiver electrical and timing specifications are stated in the text and tables of this section.

Receiver input impedance results in a differential return loss better than 10 dB and a common mode return loss better than 6 dB from 100 MHz to $(0.8) \times (Baud Frequency)$. This includes contributions from on-chip circuitry, the chip package, and any off-chip components related to the receiver. AC coupling components are included in this requirement. The reference impedance for return loss measurements is 100- Ω resistive for differential return loss and 25- Ω resistive for common mode.

This table defines the receiver DC specifications for Serial RapidIO operating at $XV_{DD} = 1.5$ V or 1.8 V.

Table 73. Serial RapidIO Receiver DC Timing Specifications—2.5 GBaud, 3.125 GBaud, 5 GBaud

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Unit | Notes |
|----------------------------|-----------------|-----|-----|------|--------|-------|
| Differential input voltage | V _{IN} | 200 | | 1600 | mV p-p | 1 |

Note:

1. Measured at the receiver.

2.19.5.5 AC Requirements for Serial RapidIO

This section explains the AC requirements for the Serial RapidIO interface.

2.19.5.5.1 AC Requirements for Serial RapidIO Transmitter

This table defines the transmitter AC specifications for the Serial RapidIO. The AC timing specifications do not include RefClk jitter.

Table 74. Serial RapidIO Transmitter AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit |
|----------------------------|----------------|--------------|---------|--------------|--------|
| Deterministic jitter | J _D | — | _ | 0.17 | UI p-p |
| Total jitter | J _T | — | _ | 0.35 | UI p-p |
| Unit Interval: 2.5 GBaud | UI | 400 – 100ppm | 400 | 400 + 100ppm | ps |
| Unit Interval: 3.125 GBaud | UI | 320 – 100ppm | 320 | 320 + 100ppm | ps |

This table defines the receiver AC specifications for Serial RapidIO. The AC timing specifications do not include RefClk jitter.

Table 75. Serial RapidIO Receiver AC Timing Specifications

For recommended operating conditions, see Table 3.

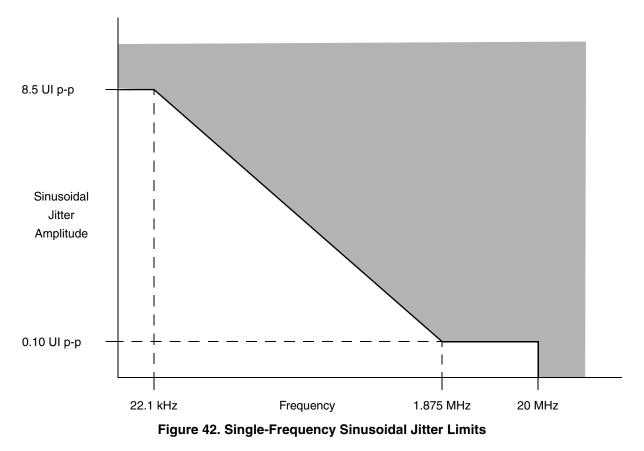
| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|--|-----------------|--------------|---------|-------------------|--------|-------|
| Deterministic jitter tolerance | J _D | 0.37 | — | — | UI p-p | 1 |
| Combined deterministic and random jitter tolerance | J _{DR} | 0.55 | — | — | UI p-p | 1 |
| Total jitter tolerance ² | J _T | 0.65 | — | — | UI p-p | 1 |
| Bit error rate | BER | — | _ | 10 ⁻¹² | | |
| Unit Interval: 2.5 GBaud | UI | 400 – 100ppm | 400 | 400 + 100 ppm | ps | |
| Unit Interval: 3.125 GBaud | UI | 320 – 100ppm | 320 | 320 + 100 ppm | ps | |

Notes:

1. Measured at receiver

2. Total jitter is composed of three components: deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 42. The sinusoidal jitter component is included to ensure margin for low-frequency jitter, wander, noise, crosstalk, and other variable system effects.

This figure shows the single-frequency sinusoidal jitter limits.



2.19.6 XAUI

This section describes the DC and AC electrical specifications for the XAUI bus.

2.19.6.1 XAUI DC Electrical Characteristics

This section discusses the XAUI DC electrical characteristics for the clocking signals, transmitter, and receiver.

2.19.6.1.1 DC Requirements for XAUI SD_REF_CLKn and SD_REF_CLKn

Only SerDes banks 2-3 (SD_REF_CLK[2:3] and SD_REF_CLK[2:3]) may be used for various SerDes XAUI configurations based on the RCW Configuration field SRDS_PRTCL. XAUI is not supported on SerDes bank 1.

For more information on these specifications, see Section 2.19.2, "SerDes Reference Clocks."

2.19.6.1.2 XAUI Transmitter DC Electrical Characteristics

This table defines the XAUI transmitter DC electrical characteristics.

Table 76. XAUI Transmitter DC Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|-----------------------------|---------------------|-------|---------|------|--------|-------|
| Output voltage | Vo | -0.40 | — | 2.30 | V | 1 |
| Differential output voltage | V _{DIFFPP} | 800 | _ | 1600 | mV p-p | — |

Note:

1. Absolute output voltage limit

2.19.6.1.3 XAUI Receiver DC Electrical Characteristics

This table defines the XAUI receiver DC electrical characteristics.

Table 77. XAUI Receiver DC Timing Specifications ($XV_{DD} = 1.5 V \text{ or } 1.8 V$)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|----------------------------|-----------------|-----|---------|------|--------|-------|
| Differential input voltage | V _{IN} | 200 | 900 | 1600 | mV p-p | 1 |

Note:

1. Measured at the receiver.

2.19.6.2 XAUI AC Timing Specifications

This section discusses the XAUI AC timing specifications for the clocking signals, transmitter, and receiver.

2.19.6.2.1 AC Requirements for XAUI SD_REF_CLK*n* and SD_REF_CLK*n*

This table specifies AC requirements for SD_REF_CLK*n* and $\overline{SD_REF_CLKn}$, where n = [2:3]. Only SerDes banks 2–3 may be used for various SerDes XAUI configurations based on the RCW Configuration field SRDS_PRTCL. XAUI is not supported on SerDes bank 1.

Table 78. XAUI AC SD_REF_CLKn and SD_REF_CLKn Input Clock Requirements (SV_{DD} = 1.0 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Unit | Notes |
|--|--|------|------------|------|------|-------|
| SD_REF_CLK/SD_REF_CLK frequency range | t _{CLK_REF} | _ | 125/156.25 | | MHz | _ |
| SD_REF_CLK/SD_REF_CLK clock frequency tolerance | ^t CLK_TOL | -100 | _ | 100 | ppm | — |
| SD_REF_CLK/SD_REF_CLK reference clock duty cycle (measured at 1.6 V) | ^t CLK_DUTY | 40 | 50 | 60 | % | — |
| SD_REF_CLK/SD_REF_CLK cycle to cycle jitter (period jitter at refClk input) | t _{CLK_CJ} | | — | 100 | ps | — |
| SD_REF_CLK/SD_REF_CLK total reference clock jitter (peak-to-peak phase jitter at refClk input) | t _{CLK_PJ} | -50 | — | 50 | ps | — |
| SD_REF_CLK/SD_REF_CLK rising/falling edge rate | t _{CLKRR} /t _{CLKFR} | 1 | — | 4 | V/ns | 1 |
| Differential input high voltage | V _{IH} | 200 | — | _ | mV | 2 |
| Differential input low voltage | V _{IL} | _ | — | -200 | mV | 2 |
| Rising edge rate (SD_REF_CLK <i>n</i>) to falling edge rate (SD_REF_CLK <i>n</i>) matching | Rise-Fall Matching | | — | 20 | % | 3, 4 |

Notes:

1. Measured from -200 mV to +200 mV on the differential waveform (derived from SD_REF_CLK*n* minus SD_REF_CLK*n*). The signal must be monotonic through the measurement region for rise and fall time. The 400 mV measurement window is centered on the differential zero crossing. See Figure 37.

- 2. Measurement taken from differential waveform
- 3. Measurement taken from single-ended waveform
- 4. Matching applies to rising edge for SD_REF_CLK*n* and falling edge rate for SD_REF_CLK*n*. It is measured using a 200 mV window centered on the median cross point where SD_REF_CLK*n* rising meets SD_REF_CLK*n* falling. The median cross point is used to calculate the voltage thresholds that the oscilloscope uses for the edge rate calculations. The rise edge rate of SD_REF_CLK*n* must be compared to the fall edge rate of SD_REF_CLK*n*, the maximum allowed difference should not exceed 20% of the slowest edge rate. See Figure 38.

2.19.6.2.2 XAUI Transmitter AC Timing Specifications

This table defines the XAUI transmitter AC timing specifications. RefClk jitter is not included.

Table 79. XAUI Transmitter AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|----------------------------|----------------|---------------|---------|---------------|--------|-------|
| Deterministic jitter | J _D | — | _ | 0.17 | UI p-p | _ |
| Total jitter | J _T | — | _ | 0.35 | UI p-p | — |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps | _ |

2.19.6.2.3 XAUI Receiver AC Timing Specifications

This table defines the receiver AC specifications for XAUI. RefClk jitter is not included.

Table 80. XAUI Receiver AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Unit | Notes |
|--|-----------------|---------------|---------|-------------------|--------|-------|
| Deterministic jitter tolerance | J _D | 0.37 | _ | — | UI p-p | 1 |
| Combined deterministic and random jitter tolerance | J _{DR} | 0.55 | | | UI p-p | 1 |
| Total jitter tolerance | J _T | 0.65 | _ | — | UI p-p | 1, 2 |
| Bit error rate | BER | — | _ | 10 ⁻¹² | _ | |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps | — |

Notes:

1. Measured at receiver

2. Total jitter is composed of three components: deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 42. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk, and other variable system effects.

2.19.7 Aurora

This section describes the Aurora clocking requirements and its AC and DC electrical characteristics.

2.19.7.1 Aurora DC Electrical Characteristics

This section describes the DC electrical characteristics for Aurora.

2.19.7.1.1 Aurora DC Clocking Requirements for SD_REF_CLKn and SD_REF_CLKn

Only SerDes bank 1 (SD_REF_CLK1 and SD_REF_CLK1) may be used for SerDes Aurora configurations based on the RCW Configuration field SRDS_PRTCL. Aurora is not supported on SerDes banks 2-3.

For more information on these specifications, see Section 2.19.2, "SerDes Reference Clocks."

2.19.7.1.2 Aurora Transmitter DC Electrical Characteristics

This table defines the Aurora transmitter DC electrical characteristics.

Table 81. Aurora Transmitter DC Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit |
|-----------------------------|---------------------|-----|---------|------|--------|
| Differential output voltage | V _{DIFFPP} | 800 | | 1600 | mV p-p |

2.19.7.1.3 Aurora Receiver DC Electrical Characteristics

This table defines the Aurora receiver DC electrical characteristics for Aurora.

Table 82. Aurora Receiver DC Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|----------------------------|-----------------|-----|---------|------|--------|-------|
| Differential input voltage | V _{IN} | 120 | 900 | 1200 | mV p-p | 1 |

Note:

1. Measured at receiver

2.19.7.2 Aurora AC Timing Specifications

This section describes the AC timing specifications for Aurora.

2.19.7.2.1 Aurora AC Clocking Requirements for SD_REF_CLK*n* and SD_REF_CLK*n*

Only SerDes bank 1 (SD_REF_CLK1 and SD_REF_CLK1) may be used for SerDes Aurora configurations based on the RCW Configuration field SRDS_PRTCL. Aurora is not supported on SerDes banks 2-3.

2.19.7.2.2 Aurora Transmitter AC Timing Specifications

This table defines the Aurora transmitter AC timing specifications. RefClk jitter is not included.

Table 83. Aurora Transmitter AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Unit |
|----------------------------|----------------|---------------|---------|---------------|--------|
| Deterministic jitter | J _D | — | _ | 0.17 | UI p-p |
| Total jitter | J _T | _ | _ | 0.35 | UI p-p |
| Unit Interval: 2.5 GBaud | UI | 400 – 100 ppm | 400 | 400 + 100 ppm | ps |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps |
| Unit Interval: 5.0 GBaud | UI | 200 – 100 ppm | 200 | 200 + 100 ppm | ps |

2.19.7.2.3 Aurora Receiver AC Timing Specifications

This table defines the Aurora receiver AC timing specifications. RefClk jitter is not included.

Table 84. Aurora Receiver AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|--|-----------------|------|---------|-------------------|--------|-------|
| Deterministic jitter tolerance | J _D | 0.37 | _ | _ | UI p-p | 1 |
| Combined deterministic and random jitter tolerance | J _{DR} | 0.55 | — | — | UI p-p | 1 |
| Total jitter tolerance | J _T | 0.65 | — | — | UI p-p | 1, 2 |
| Bit error rate | BER | _ | — | 10 ⁻¹² | — | — |

Table 84. Aurora Receiver AC Timing Specifications (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Unit | Notes |
|----------------------------|--------|---------------|---------|---------------|------|-------|
| Unit Interval: 2.5 GBaud | UI | 400 – 100 ppm | 400 | 400 + 100 ppm | ps | — |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps | — |
| Unit Interval: 5.0 GBaud | UI | 200 – 100 ppm | 200 | 200 + 100 ppm | ps | — |

Note:

1. Measured at receiver

2. Total jitter is composed of three components: deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 42. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

2.19.8 Serial ATA (SATA)

This section describes the DC and AC electrical specifications for the serial ATA (SATA) interface.

2.19.8.1 SATA DC Electrical Characteristics

This section describes the DC electrical characteristics for SATA.

2.19.8.1.1 SATA DC Transmitter Output Characteristics

This table provides the differential transmitter output DC characteristics for the SATA interface at Gen1i or 1.5 Gbits/s transmission.

Table 85. Gen1i/1.5G Transmitter (Tx) DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|--------------------------------|----------------------------|-----|-----|-----|--------|-------|
| Tx differential output voltage | V _{SATA_TXDIFF} | 400 | _ | 600 | mV p-p | 1 |
| Tx differential pair impedance | Z _{SATA_TXDIFFIM} | 85 | 100 | 115 | Ω | 2 |

Notes:

1. Terminated by 50 Ω load.

2. DC impedance

This table provides the differential transmitter output DC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission.

Table 86. Gen 2i/3G Transmitter (Tx) DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Units | Notes |
|--------------------------------|----------------------------|-----|-----|-----|--------|-------|
| Tx diff output voltage | V _{SATA_TXDIFF} | 400 | — | 700 | mV p-p | 1 |
| Tx differential pair impedance | Z _{SATA_TXDIFFIM} | 85 | 100 | 115 | Ω | |

Note:

1. Terminated by 50 Ω load.

2.19.8.1.2 SATA DC Receiver (Rx) Input Characteristics

This table provides the Gen1i or 1.5 Gbits/s differential receiver input DC characteristics for the SATA interface.

Table 87. Gen1i/1.5 G Receiver (Rx) Input DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Units | Notes |
|---------------------------------|--------------------------|-----|---------|-----|--------|-------|
| Differential input voltage | V _{SATA_RXDIFF} | 240 | _ | 600 | mV p-p | 1 |
| Differential Rx input impedance | Z _{SATA_RXSEIM} | 85 | 100 | 115 | Ω | 2 |
| OOB signal detection threshold | V _{SATA_OOB} | 50 | 120 | 240 | mV p-p | 2 |

Note:

1. Voltage relative to common of either signal comprising a differential pair

2. DC impedance

This table provides the Gen2i or 3 Gbits/s differential receiver input DC characteristics for the SATA interface.

Table 88. Gen2i/3 G Receiver (Rx) Input DC Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Units | Notes |
|---------------------------------|--------------------------|-----|---------|-----|--------|-------|
| Differential input voltage | V _{SATA_RXDIFF} | 275 | _ | 750 | mV p-p | 1 |
| Differential Rx input impedance | Z _{SATA_RXSEIM} | 85 | 100 | 115 | Ω | 2 |
| OOB signal detection threshold | V _{SATA_OOB} | 75 | 120 | 240 | mV p-p | 2 |

Notes:

1. Voltage relative to common of either signal comprising a differential pair

2. DC impedance

2.19.8.2 SATA AC Timing Specifications

This section discusses the SATA AC timing specifications.

2.19.8.2.1 AC Requirements for SATA REF_CLK

The AC requirements for the SATA reference clock listed in this table are to be guaranteed by the customer's application design.

Table 89. SATA Reference Clock Input Requirements

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Unit | Notes |
|--|-----------------------|------|---------|------|------|---------|
| SD_REF_CLK/SD_REF_CLK frequency range | t _{CLK_REF} | _ | 100/125 | _ | MHz | 1 |
| SD_REF_CLK/SD_REF_CLK clock frequency tolerance | ^t CLK_TOL | -350 | | +350 | ppm | _ |
| SD_REF_CLK/SD_REF_CLK reference clock duty cycle (measured at 1.6 V) | ^t CLK_DUTY | 40 | 50 | 60 | % | _ |
| SD_REF_CLK/SD_REF_CLK cycle-to-cycle clock jitter (period jitter) | t _{CLK_CJ} | | _ | 100 | ps | 2 |
| SD_REF_CLK/SD_REF_CLK total reference clock jitter, phase jitter (peak-to-peak) | t _{CLK_PJ} | -50 | | +50 | ps | 2, 3, 4 |

Notes:

1. Caution: Only 100 and 125MHz have been tested. In-between values do not work correctly with the rest of the system.

2. At RefClk input

3. In a frequency band from 150 kHz to 15 MHz at BER of $10^{\text{-12}}$

4. Total peak-to-peak deterministic jitter must be less than or equal to 50 ps.

This figure shows the reference clock timing waveform.

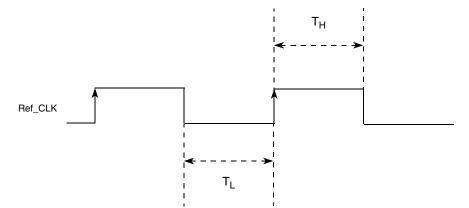


Figure 43. Reference Clock Timing Waveform

2.19.8.3 AC Transmitter Output Characteristics

This table provides the differential transmitter output AC characteristics for the SATA interface at Gen1i or 1.5 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

Table 90. Gen1i/1.5 G Transmitter (Tx) AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Units | Notes |
|--|-----------------------------|----------|----------|----------|--------|-------|
| Channel speed | t _{CH_SPEED} | — | 1.5 | _ | Gbps | |
| Unit Interval | T _{UI} | 666.4333 | 666.6667 | 670.2333 | ps | — |
| Total jitter data-data 5 UI | U _{SATA_TXTJ5UI} | — | — | 0.355 | UI p-p | 1 |
| Total jitter, data-data 250 UI | U _{SATA_TXTJ250UI} | — | — | 0.47 | UI p-p | 1 |
| Deterministic jitter, data-data 5 UI | U _{SATA_TXDJ5UI} | — | — | 0.175 | UI p-p | 1 |
| Deterministic jitter, data-data 250 UI | U _{SATA_TXDJ250UI} | — | — | 0.22 | UI p-p | 1 |

Note:

1. Measured at Tx output pins peak to peak phase variation, random data pattern

This table provides the differential transmitter output AC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

Table 91. Gen 2i/3 G Transmitter (Tx) AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Max | Units | Notes |
|--|-------------------------------|----------|----------|----------|--------|-------|
| Channel speed | t _{CH_SPEED} | _ | 3.0 | | Gbps | |
| Unit Interval | T _{UI} | 333.2167 | 333.3333 | 335.1167 | ps | _ |
| Total jitter $f_{C3dB} = f_{BAUD} \div 10$ | U _{SATA_TXTJfB/10} | _ | — | 0.3 | UI p-p | 1 |
| Total jitter $f_{C3dB} = f_{BAUD} \div 500$ | U _{SATA_TXTJfB/500} | _ | — | 0.37 | UI p-p | 1 |
| Total jitter $f_{C3dB} = f_{BAUD} \div 1667$ | U _{SATA_TXTJfB/1667} | _ | — | 0.55 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 10$ | U _{SATA_TXDJfB/10} | — | — | 0.17 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 500$ | U _{SATA_TXDJfB/500} | | — | 0.19 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 1667$ | U _{SATA_TXDJfB/1667} | _ | _ | 0.35 | UI p-p | 1 |

Note:

1. Measured at Tx output pins peak-to-peak phase variation, random data pattern

2.19.8.4 AC Differential Receiver Input Characteristics

This table provides the Gen1i or 1.5 Gbits/s differential receiver input AC characteristics for the SATA interface. The AC timing specifications do not include RefClk jitter.

Table 92. Gen 1i/1.5G Receiver (Rx) AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Units | Notes |
|--|-----------------------------|----------|----------|----------|--------|-------|
| Unit Interval | T _{UI} | 666.4333 | 666.6667 | 670.2333 | ps | _ |
| Total jitter data-data 5 UI | U _{SATA_TXTJ5UI} | — | _ | 0.43 | UI p-p | 1 |
| Total jitter, data-data 250 UI | U _{SATA_TXTJ250UI} | — | _ | 0.60 | UI p-p | 1 |
| Deterministic jitter, data-data 5 UI | U _{SATA_TXDJ5UI} | — | _ | 0.25 | UI p-p | 1 |
| Deterministic jitter, data-data 250 UI | U _{SATA_TXDJ250UI} | — | _ | 0.35 | UI p-p | 1 |

Note:

1. Measured at receiver.

This table provides the differential receiver input AC characteristics for the SATA interface at Gen2i or 3.0 Gbits/s transmission. The AC timing specifications do not include RefClk jitter.

Table 93. Gen 2i/3G Receiver (Rx) AC Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Units | Notes |
|---|-------------------------------|----------|----------|----------|--------|-------|
| Unit Interval | T _{UI} | 333.2167 | 333.3333 | 335.1167 | ps | |
| Total jitter $f_{C3dB} = f_{BAUD} \div 10$ | U _{SATA_TXTJfB/10} | _ | _ | 0.46 | UI p-p | 1 |
| Total jitter $f_{C3dB} = f_{BAUD} \div 500$ | U _{SATA_TXTJfB/500} | _ | — | 0.60 | UI p-p | 1 |
| Total jitter $f_{C3dB} = f_{BAUD} \div 1667$ | U _{SATA_TXTJfB/1667} | _ | — | 0.65 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 10$ | U _{SATA_TXDJfB/10} | _ | — | 0.35 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 500$ | U _{SATA_TXDJfB/500} | _ | _ | 0.42 | UI p-p | 1 |
| Deterministic jitter, $f_{C3dB} = f_{BAUD} \div 1667$ | U _{SATA_TXDJfB/1667} | _ | _ | 0.35 | UI p-p | 1 |

Note:

1. Measured at receiver.

2.19.9 SGMII Interface

Each SGMII port features a 4-wire AC-coupled serial link from the SerDes interface of the chip, as shown in Figure 44, where C_{TX} is the external (on board) AC-coupled capacitor. Each output pin of the SerDes transmitter differential pair features 50- Ω output impedance. Each input of the SerDes receiver differential pair features 50- Ω on-die termination to XGND. The reference circuit of the SerDes transmitter and receiver is shown in Figure 39.

2.19.9.0.1 SGMII Clocking Requirements for SD_REF_CLK*n* and SD_REF_CLK*n*

When operating in SGMII mode, the EC_GTX_CLK125 clock is not required for this port. Instead, a SerDes reference clock is required on SD_REF_CLK[1:3] and SD_REF_CLK[1:3] pins. SerDes banks 1-3 may be used for SerDes SGMII configurations based on the RCW Configuration field SRDS_PRTCL.

For more information on these specifications, see Section 2.19.2, "SerDes Reference Clocks."

2.19.9.1 SGMII DC Electrical Characteristics

This section discusses the electrical characteristics for the SGMII interface.

2.19.9.1.1 SGMII Transmit DC Timing Specifications

This table describe the SGMII SerDes transmitter and receiver AC-coupled DC electrical characteristics for 1.25 GBaud. Transmitter DC characteristics are measured at the transmitter outputs (SD_TXn and $\overline{SD_TXn}$) as shown in Figure 45.

Table 94. SGMII DC Transmitter Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Unit | Notes |
|---|--------------------|---------------------------------------|-------|--|------|---|
| Output high voltage | V _{OH} | | — | 1.5 x IV _{OD} I _{-max} | mV | 1 |
| Output low voltage | V _{OL} | IV _{OD} I _{-min} /2 | — | _ | mV | 1 |
| Output differential voltage ^{2, 3, 4} (XV _{DD-Typ} at 1.5 V and 1.8 V) | IV _{OD} I | 320 | 500.0 | 725.0 | mV | B(1-3)TECR(lane)0 [AMP_RED] =0b000000 |
| | | 293.8 | 459.0 | 665.6 | | B(1–3)TECR(lane)0 [AMP_RED] =0b000010 |
| | | 266.9 | 417.0 | 604.7 | | B(1-3)TECR(lane)0 [AMP_RED] =0b000101 |
| | | 240.6 | 376.0 | 545.2 | | B(1-3)TECR(lane)0[AMP_RED] =0b001000 |
| | | 213.1 | 333.0 | 482.9 | | B(1-3)TECR(lane)0 [AMP_RED] =0b001100 |
| | | 186.9 | 292.0 | 423.4 | | B(1-3)TECR(lane)0 [AMP_RED] =0b001111 |
| | | 160.0 | 250.0 | 362.5 | | B(1-3)TECR(lane)0 [AMP_RED] =0b010011 |
| Output impedance (single-ended) | R _O | 40 | 50 | 60 | Ω | — |

Notes:

1. This does not align to DC-coupled SGMII.

2. $|V_{OD}| = |V_{SD_TXn} - V_{\overline{SD_TXn}}|$. $|V_{OD}|$ is also referred to as output differential peak voltage. $V_{TX-DIFFp-p} = 2 \times |V_{OD}|$.

3. Example amplitude reduction setting for SGMII on SerDes bank 1 lane E: B1TECRE0[AMP_RED] = 0b000010 for an output differential voltage of 459 mV typical.

4. The IV_{OD}I value shown in the Typ column is based on the condition of XVDD_SRDSn-Typ = 1.5 V or 1.8 V, no common mode offset variation. SerDes transmitter is terminated with 100-Ω differential load between SD_TX*n* and SD_TX*n*.

This figure shows an example of a 4-wire AC-coupled SGMII serial link connection.

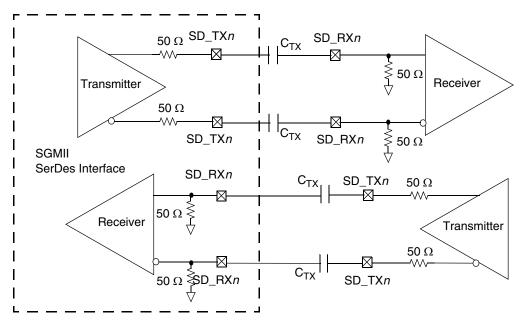


Figure 44. 4-Wire AC-Coupled SGMII Serial Link Connection Example

This figure shows the SGMII transmitter DC measurement circuit.

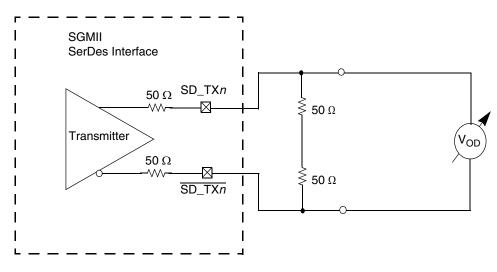


Figure 45. SGMII Transmitter DC Measurement Circuit

This figure defines the SGMII 2.5x transmitter DC electrical characteristics for 3.125 GBaud.

Table 95. SGMII 2.5x Transmitter DC Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Мах | Unit | Notes |
|-----------------------------|---------------------|-------|---------|------|--------|-------|
| Output voltage | V _O | -0.40 | — | 2.30 | V | 1 |
| Differential output voltage | V _{DIFFPP} | 800 | _ | 1600 | mV p-p | — |

Note:

1. Absolute output voltage limit

2.19.9.1.2 SGMII DC Receiver Electrical Characteristics

This figure lists the SGMII DC receiver electrical characteristics for 1.25 GBaud. Source synchronous clocking is not supported. Clock is recovered from the data.

Table 96. SGMII DC Receiver Electrical Characteristics (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parame | ter | Symbol | Min | Тур | Мах | Unit | Notes |
|----------------------------------|-------------------|-------------------------|-----|-----|------|------|-------|
| DC Input voltage range | | _ | | N/A | | | 1 |
| Input differential voltage | REIDL_CTL = 001xx | V _{RX_DIFFp-p} | 100 | | 1200 | mV | 2, 4 |
| | REIDL_CTL = 100xx | | 175 | | | | |
| Loss of signal threshold | REIDL_CTL = 001xx | V _{LOS} | 30 | | 100 | mV | 3, 4 |
| | REIDL_CTL = 100xx | | 65 | _ | 175 | | |
| Receiver differential input impe | edance | Z _{RX_DIFF} | 80 | — | 120 | Ω | — |

Notes:

1. Input must be externally AC coupled.

2. V_{RX_DIFFp-p} is also referred to as peak-to-peak input differential voltage.

3. The concept of this parameter is equivalent to the electrical idle detect threshold parameter in PCI Express. Refer to Section 2.19.4.4, "PCI Express DC Physical Layer Receiver Specifications," and Section 2.19.4.5.2, "PCI Express AC Physical Layer Receiver Specifications," for further explanation.

4. The REIDL_CTL shown in the table refers to the chip's SerDes control register B(1-3)GCR(lane)1[REIDL_CTL] bit field.

This table defines the SGMII 2.5x receiver DC electrical characteristics for 3.125 GBaud.

Table 97. SGMII 2.5x Receiver DC Timing Specifications (XV_{DD} = 1.5 V or 1.8 V)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Typical | Max | Unit | Notes |
|----------------------------|-----------------|-----|---------|------|--------|-------|
| Differential input voltage | V _{IN} | 200 | 900 | 1600 | mV p-p | 1 |

Note:

1. Measured at the receiver

2.19.9.2 SGMII AC Timing Specifications

This section discusses the AC timing specifications for the SGMII interface.

2.19.9.2.1 SGMII Transmit AC Timing Specifications

This table provides the SGMII transmit AC timing specifications. A source synchronous clock is not supported. The AC timing specifications do not include RefClk jitter.

Table 98. SGMII Transmit AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Min Typ Max | | Unit | Notes |
|----------------------------|-----------------|---------------|-------------|---------------|--------|-------|
| Deterministic jitter | JD | — | | 0.17 | UI p-p | _ |
| Total jitter | JT | — | | 0.35 | UI p-p | 1 |
| Unit Interval: 1.25 GBaud | UI | 800 – 100 ppm | 800 | 800 + 100 ppm | ps | _ |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps | _ |
| AC coupling capacitor | C _{TX} | 10 | | 200 | nF | 2 |

Notes:

1. See Figure 42 for single frequency sinusoidal jitter measurements.

2. The external AC coupling capacitor is required. It is recommended that it be placed near the device transmitter outputs.

2.19.9.2.2 SGMII AC Measurement Details

Transmitter and receiver AC characteristics are measured at the transmitter outputs (SD_TX*n* and \overline{SD}_TXn) or at the receiver inputs (SD_RX*n* and \overline{SD}_RXn) respectively, as depicted in this figure.

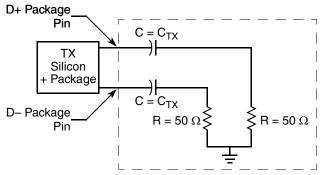


Figure 46. SGMII AC Test/Measurement Load

2.19.9.2.3 SGMII Receiver AC Timing Specification

This table provides the SGMII receiver AC timing specifications. The AC timing specifications do not include RefClk jitter. Source synchronous clocking is not supported. Clock is recovered from the data.

Table 99. SGMII Receive AC Timing Specifications

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Unit | Notes |
|--|--------|------|-----|-----|--------|---------|
| Deterministic jitter tolerance | JD | 0.37 | — | _ | UI p-p | 1, 2 |
| Combined deterministic and random jitter tolerance | JDR | 0.55 | — | _ | UI p-p | 1, 2 |
| Total jitter tolerance | JT | 0.65 | — | _ | UI p-p | 1, 2, 3 |

Table 99. SGMII Receive AC Timing Specifications (continued)

For recommended operating conditions, see Table 3.

| Parameter | Symbol | Min | Тур | Мах | Unit | Notes |
|----------------------------|--------|---------------|-----|-------------------|------|-------|
| Bit error ratio | BER | — | _ | 10 ⁻¹² | _ | — |
| Unit Interval: 1.25 GBaud | UI | 800 – 100 ppm | 800 | 800 + 100 ppm | ps | 1 |
| Unit Interval: 3.125 GBaud | UI | 320 – 100 ppm | 320 | 320 + 100 ppm | ps | 1 |

Notes:

1. Measured at receiver

2. See RapidIO[®] $1 \times /4 \times LP$ Serial Physical Layer Specification for interpretation of jitter specifications.

3. Total jitter is composed of three components: deterministic jitter, random jitter, and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 42. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

The sinusoidal jitter in the total jitter tolerance may have any amplitude and frequency in the unshaded region of Figure 42.

3 Hardware Design Considerations

3.1 System Clocking

This section describes the PLL configuration of the chip.

This device includes 7 PLLs, as follows:

- There are two selectable core cluster PLLs, which generate a core clock from the externally supplied SYSCLK input. Core complex 0–1 and platform can select from CC1 PLL and core complex 2–3 can select from CC2 PLL. The frequency ratio between the core cluster PLLs and SYSCLK is selected using the configuration bits as described in Section 3.1.3, "e500mc Core Cluster to SYSCLK PLL Ratio." The frequency for each core complex 0–3 is selected using the configuration bits as described in Table 103.
- The platform PLL generates the platform clock from the externally supplied SYSCLK input. The frequency ratio between the platform and SYSCLK is selected using the platform PLL ratio configuration bits as described in Section 3.1.2, "Platform to SYSCLK PLL Ratio."
- The DDR block PLL generates the DDR clock from the externally supplied SYSCLK input (asynchronous mode) or from the platform clock (synchronous mode). The frequency ratio is selected using the Memory Controller Complex PLL multiplier/ratio configuration bits as described in Section 3.1.5, "DDR Controller PLL Ratios."
- Each of the three SerDes blocks has a PLL, which generate a core clock from their respective externally supplied SD_REF_CLKn/SD_REF_CLKn inputs. The frequency ratio is selected using the SerDes PLL ratio configuration bits as described in Section 3.1.6, "Frequency Options."

3.1.1 Clock Ranges

This table provides the clocking specifications for the processor core, platform, memory, and local bus.

| | | Maximum Processor Core Frequency | | | | | | |
|----------------------------|------|----------------------------------|------|------|------|------|------|------------|
| Characteristic | 1200 | MHz | 1333 | MHz | 1500 | MHz | Unit | Notes |
| | Min | Max | Min | Max | Min | Max | | |
| e500mc core PLL frequency | 800 | 1200 | 800 | 1333 | 800 | 1500 | MHz | 1, 4 |
| e500mc core Frequency | 400 | 1200 | 400 | 1333 | 400 | 1500 | MHz | 4, 8 |
| Platform clock Frequency | 600 | 600 | 600 | 667 | 600 | 750 | MHz | 1 |
| Memory bus clock frequency | 400 | 600 | 400 | 667 | 400 | 667 | MHz | 1, 2, 5, 6 |
| Local bus clock frequency | _ | 83 | _ | 83 | _ | 83 | MHz | 3 |
| PME | | 300 | _ | 333 | — | 375 | MHz | 7 |
| FMan | — — | 500 | _ | 541 | — | 583 | MHz | |

Table 100. Processor Clocking Specifications

Notes

- 1. **Caution:** The platform clock to SYSCLK ratio and e500-mc core to SYSCLK ratio settings must be chosen such that the resulting SYSCLK frequency, e500mc (core) frequency, and platform clock frequency do not exceed their respective maximum or minimum operating frequencies.
- The memory bus clock speed is half the DDR3/DDR3L data rate. DDR3 memory bus clock frequency is limited to min = 400 MHz.
- 3. The local bus clock speed on LCLK[0:1] is determined by the platform clock divided by the local bus ratio programmed in LCRR[CLKDIV]. Refer to the *P3041 QorlQ Integrated Multicore Communication Processor Family Reference Manual*, for more information.
- 4. The e500mc core can run at e500mc core complex PLL/1 or PLL/2. With a minimum core complex PLL frequency of 800 MHz, this results in a minimum allowable e500mc core frequency of 400 MHz for PLL/2.
- 5. In synchronous mode, the memory bus clock speed is half the platform clock frequency. In other words, the DDR data rate is the same as the platform frequency. If the desired DDR data rate is higher than the platform frequency, asynchronous mode must be used.
- 6. In asynchronous mode, the memory bus clock speed is dictated by its own PLL.
- 7. The PME runs synchronously to the platform clock, running at a frequency of platform clock/2.
- 8. Core frequency must be at least as fast as the platform frequency (Rev 1.1 silicon).

3.1.2 Platform to SYSCLK PLL Ratio

The allowed platform clock to SYSCLK ratios are shown in the following table.

Note that in synchronous DDR mode, the DDR data rate is the determining factor for selecting the platform bus frequency because the platform frequency must equal to the DDR data rate.

In asynchronous DDR mode, the memory bus clock frequency is decoupled from the platform bus frequency. The platform frequency must be greater than or equal to ½ the DDR data rate.For platform clock frequency targeting 667 MHz and above, set the RCW Configuration field SYS_PLL_CFG = 0b00, and for 533–666-MHz frequencies, set SYS_PLL_CFG= 0b01.

| Binary Value of SYS_PLL_RAT | Platform:SYSCLK Ratio |
|--------------------------------|-----------------------|
| 0_0100 | 4:1 |
| 0_0101 | 5:1 |
| 0_0110 | 6:1 |
| 0_0111 | 7:1 |
| 0_1000 | 8:1 |
| 0_1001 | 9:1 |
| 0_1010 | 10:1 |
| All Others | Reserved |

Table 101. Platform to SYSCLK PLL Ratios

3.1.3 e500mc Core Cluster to SYSCLK PLL Ratio

The clock ratio between SYSCLK and each of the two core cluster PLLs is determined at power up by the binary value of the RCW field CCn_PLL_RAT. The following table describes the supported ratios. Note that a core cluster PLL frequency targeting 1 GHz and above must set RCW field CCn_PLL_CFG = 0b00 for a frequency targeting below 1 GHz set $CCn_PLL_CFG = 0b01$.

This table lists the supported Core Cluster to SYSCLK ratios.

| Binary Value of CCn_PLL_RAT | Core Cluster:SYSCLK Ratio |
|--------------------------------|---------------------------|
| 0_1000 | 8:1 |
| 0_1001 | 9:1 |
| 0_1010 | 10:1 |
| 0_1011 | 11:1 |
| 0_1100 | 12:1 |
| 0_1101 | 13:1 |
| 0_1110 | 14:1 |
| 0_1111 | 15:1 |
| 1_0000 | 16:1 |
| 1_0001 | 17:1 |
| 1_0010 | 18:1 |
| All Others | Reserved |

Table 102. e500mc Core Cluster PLL to SYSCLK Ratios

3.1.4 e500mc Core Complex PLL Select

The clock frequency of each core 0-3 complex is determined by the binary value of the RCW field CC*n*_PLL_SEL. The following table describes the supported ratios for each core complex 0-3, where each individual core complex can select a frequency from the table.

| Binary Value of C <i>n</i> _PLL_SEL for n = [0,1] | e500mc:Core Cluster Ratio |
|--|---------------------------|
| 0000 | CC1 PLL /1 |
| 0001 | CC1 PLL /2 |
| 0100 | CC2 PLL /1 |
| All Others | Reserved |

Table 103. e500mc Core Complex [0,1] PLL Select

Table 104. e500mc Core Complex [2,3] PLL Select

| Binary Value of C <i>n</i> _PLL_SEL for n=[0,1] | e500mc:Core Cluster Ratio |
|--|---------------------------|
| 0000 | CC1 PLL /1 |
| 0100 | CC2 PLL /1 |
| 0101 | CC2 PLL /2 |
| All Others | Reserved |

3.1.5 DDR Controller PLL Ratios

The single DDR memory controller complexes can be synchronous with or asynchronous to the platform, depending on configuration.

The following table describes the clock ratio between the DDR memory controller PLLs and the externally supplied SYSCLK input (asynchronous mode) or from the platform clock (synchronous mode).

In asynchronous DDR mode, the DDR data rate to SYSCLK ratios supported are listed in Table 105. This ratio is determined by the binary value of the RCW Configuration field MEM_PLL_RAT[10:14].

The RCW Configuration field MEM_PLL_CFG[8:9] must be set to MEM_PLL_CFG[8:9] = 0b01 if the applied DDR PLL reference clock frequency is greater than the cutoff frequency listed in Table 105 and Table 106 for asynchronous and synchronous DDR clock ratios respectively, else set MEM_PLL_CFG[8:9] = 0b00.

NOTE

- The RCW Configuration field DDR_SYNC (bit 184) must be set to 0b0 for asynchronous mode and 0b1 for synchronous mode.
- The RCW Configuration field DDR_RATE (bit 232) must be set to b'0 for asynchronous mode, and b'1 for synchronous mode.
- The RCW Configuration field DDR_RSV0 (bit 234) must be set to b'0 for all ratios.

Table 105. Asynchronous DDR Clock Ratio

| Binary Value of MEM_PLL_RAT[10:14] | DDR:SYSCLK Ratio | Set MEM_PLL_CFG = 01 for SYSCLK Freq ¹ |
|------------------------------------|------------------|---|
| 0_0101 | 5:1 | >96.7 MHz |
| 0_0110 | 6:1 | >80.6 MHz |
| 0_1000 | 8:1 | >120.9 MHz |
| 0_1001 | 9:1 | >107.4 MHz |
| 0_1010 | 10:1 | >96.7 MHz |

| 0_1100 | 12:1 | >80.6 MHz |
|------------|----------|-----------|
| 0_1101 | 13:1 | >74.4 MHz |
| 1_0000 | 16:1 | >60.4 MHz |
| 1_0010 | 18:1 | >53.7 MHz |
| 1_0011 | 19:1 | >50.9 MHz |
| 1_0100 | 20:1 | >48.4 MHz |
| All Others | Reserved | _ |

Table 105. Asynchronous DDR Clock Ratio (continued)

Notes:

1. Set RCW field MEM_PLL_CFG = 0b01 if the applied DDR PLL reference clock (SYSCLK) frequency is greater than given cutoff, else set to 0b00 for frequency that is less than or equal to cutoff.

In synchronous mode, the DDR data rate to platform clock ratios supported are listed in Table 106. This ratio is determined by the binary value of the RCW Configuration field MEM_PLL_RAT[10:14].

Table 106. Synchronous DDR Clock Ratio

| Binary Value of MEM_PLL_RAT[10:14] | DDR:Platform CLK Ratio | Set MEM_PLL_CFG=01 for Platform CLK Freq ¹ |
|---------------------------------------|------------------------|---|
| 0_0001 | 1:1 | >600 MHz |
| All Others | Reserved | _ |

Notes:

1. Set MEM_PLL_CFG=0b01 if the applied DDR PLL reference clock (Platform clock) frequency is greater than given cutoff, else set to 0b00 for frequency that is less than or equal to cutoff.

3.1.6 Frequency Options

This section discusses interface frequency options.

3.1.6.1 SYSCLK and Platform Frequency Options

This table shows the expected frequency options for SYSCLK and platform frequencies.

Table 107. SYSCLK and Platform Frequency Options

| Platform: | | SI | SCLK (MF | łz) | |
|-----------------|---------------------------------------|-------|----------|--------|--------|
| SYSCLK Ratio | 66.66 | 83.33 | 100.00 | 111.11 | 133.33 |
| Ralio | Platform Frequency (MHz) ¹ | | | | |
| 5:1 | | | | | 667 |
| 6:1 | | | 600 | 667 | |
| 7:1 | | | 700 | | |

Table 107. SYSCLK and Platform Frequency Options (continued)

| 8:1 | | 667 |
|------|-----|-----|
| 9:1 | 600 | 750 |
| 10:1 | 667 | |
| 11:1 | 733 | |

Platform frequency values are shown rounded down to the nearest whole number (decimal place accuracy removed)

3.1.6.2 Minimum Platform Frequency Requirements for High-Speed Interfaces

The platform clock frequency must be considered for proper operation of high-speed interfaces as described below.

For proper PCI Express operation, the platform clock frequency must be greater than or equal to the values shown in these figures.

$\frac{527 \text{ MHz} \times (\text{PCI Express link width})}{8}$

Figure 47. Gen 1 PEX Minimum Platform Frequency

527 MHz × (PCI Express link width)

4

Figure 48. Gen 2 PEX Minimum Platform Frequency

See Section 18.1.3.2 "Link Width," in the *P3041 QorIQ Integrated Multicore Communication Processor Family Reference Manual* for PCI Express interface width details. Note that "PCI Express link width" in the above equation refers to the negotiated link width of the single widest port used (not combined width of the number ports used) as the result of PCI Express link training, which may or may not be the same as the link width POR selection.

For proper serial RapidIO operation, the platform clock frequency must be greater than or equal to:

$2 \times (0.8512) \times (serial \ RapidIO \ interface \ frequency) \times (serial \ RapidIO \ link \ width)$

64

Figure 49. Serial RapidIO Minimum Platform Frequency

See Section 19.4 "LP-Serial Signal Descriptions," in the P3041 QorIQ Integrated Multicore Communication Processor Family Reference Manual for serial RapidIO interface width and frequency details.

3.1.7 SerDes PLL Ratio

The clock ratio between each of the three SerDes PLLs and their respective externally supplied SD_REF_CLK*n*/SD_REF_CLK*n* inputs is determined by the binary value of the RCW Configuration field SRDS_RATIO_B*n* as shown in Table 108. Furthermore, each SerDes lane grouping can be run at a SerDes PLL frequency divider determined by the binary value of the RCW field SRDS_DIV_B*n* as shown in Table 109 and Table 110.

This table lists the supported SerDes PLL Bank *n* to SD_REF_CLK*n* ratios.

| Binary Value of | S | SRDS_PLL_ <i>n</i> :SD_REF_CLK <i>n</i> Ratio | | | |
|-----------------|-----------------------|---|-----------------------|--|--|
| SRDS_RATIO_B1 | <i>n</i> = 1 (Bank 1) | <i>n</i> = 2 (Bank 2) | <i>n</i> = 3 (Bank 3) | | |
| 000 | Reserved | Reserved | Reserved | | |
| 001 | Reserved | 20:1 | 20:1 | | |
| 010 | 25:1 | 25:1 | 25:1 | | |
| 011 | 40:1 | 40:1 | 40:1 | | |
| 100 | 50:1 | 50:1 | 50:1 | | |
| 101 | Reserved | Reserved | 24:1 | | |
| 110 | Reserved | Reserved | 30:1 | | |
| All Others | Reserved | Reserved | Reserved | | |

Table 108. SerDes PLL Bank n to SD_REF_CLKn Ratios

These tables list the supported SerDes PLL dividers. Table 109 shows the PLL divider support for each pair of lanes on SerDes Bank 1.

Table 109. SerDes Bank 1 PLL Dividers

| Binary Value of SRDS_DIV_B1[0:4] | SerDes Bank 1 PLL Divider | | |
|----------------------------------|----------------------------|--|--|
| 0b0 | Divide by 1 off Bank 1 PLL | | |
| 0b1 | Divide by 2 off Bank 1 PLL | | |

Notes:

1. One bit (of 5 total SRDS_DIV_B1 bits) controls each pair of lanes where first bit controls the configuration of lanes A/B (or 0/1) and last bit controls the configuration of lanes I/J (or 8/9).

This table shows the PLL dividers supported for each 4 lane group for SerDes Banks 2 and 3.

Table 110. SerDes Banks 2 and 3 PLL Dividers

| Binary Value of SRDS_DIV_B <i>n</i> | SerDes Bank <i>n</i> PLL Divider |
|-------------------------------------|-----------------------------------|
| 0b0 | Divide by 1 off Bank <i>n</i> PLL |
| 0b1 | Divide by 2 off Bank <i>n</i> PLL |

Notes:

1. One bit controls all 4 lanes of each bank.

2. n = 2 or 3 (SerDes bank 2 or bank 3)

3.1.8 Frame Manager Clock Select

Each frame managers (FMs) can be synchronous to the platform.

This table describes the clocking options that may be applied to each FM. The clock selection is determined by the binary value of the RCW Clocking Configuration fields FM_CLK_SEL.

| Binary Value of FM_CLK_SEL | FM Frequency | |
|----------------------------|--|--|
| 0b0 | Platform Clock Frequency /2 | |
| 0b1 | Core Cluster 2 Frequency /2 ¹ | |

Table 111. Frame Manager Clock Select

Notes:

1. For asynchronous mode, max frequency refer to Table 100.

3.2 Supply Power Default Setting

This chip is capable of supporting multiple power supply levels on its I/O supplies. The I/O voltage select inputs, shown in this table, properly configure the receivers and drivers of the I/Os associated with the BVDD, CVDD, and LVDD power planes, respectively.

WARNING

Incorrect voltage select settings can lead to irreversible device damage.

| Signals | Value | VDD Voltage Selection | | |
|----------------------------------|----------|-----------------------|-------|----------|
| | (Binary) | BVDD | CVDD | LVDD |
| IO_VSEL[0:4] Default (0_0000) | 0_000 | 3.3 V | 3.3 V | 3.3 V |
| | 0_0001 | | | 2.5 V |
| | 0_0010 | | | Reserved |
| | 0_0011 | | 2.5 V | 3.3 V |
| | 0_0100 | | | 2.5 V |
| | 0_0101 | | | Reserved |
| | 0_0110 | | 1.8 V | 3.3 V |
| | 0_0111 | | | 2.5 V |
| | 0_1000 | | | Reserved |
| | 0_1001 | 2.5 V | 3.3 V | 3.3 V |
| | 0_1010 | | | 2.5 V |
| | 0_1011 | | | Reserved |
| | 0_1100 | | 2.5 V | 3.3 V |
| | 0_1101 | | | 2.5 V |
| | 0_1110 | | | Reserved |
| | 0_1111 | | 1.8 V | 3.3 V |
| | 1_0000 | | | 2.5 V |
| | 1_0001 | | | Reserved |
| | 1_0010 | 1.8 V | 3.3 V | 3.3 V |
| | 1_0011 | | | 2.5 V |
| | 1_0100 | | | Reserved |
| | 1_0101 | | 2.5 V | 3.3 V |
| | 1_0110 | | | 2.5 V |
| | 1_0111 | | | Reserved |
| | 1_1000 | | 1.8 V | 3.3 V |
| | 1_1001 | | | 2.5 V |
| | 1_1010 | | | Reserved |
| | 1_1011 | 3.3 V | 3.3 V | 3.3 V |
| | 1_1100 | | | |
| | 1_1101 | | | |
| | 1_1110 | | | |
| | 1_1111 | | | |

Table 112. I/O Voltage Selection

3.3 Power Supply Design

3.3.1 PLL Power Supply Filtering

Each of the PLLs described in Section 3.1, "System Clocking," is provided with power through independent power supply pins (AV_{DD_PLAT}, AV_{DD_CCn}, AV_{DD_DDR}, and AV_{DD_SRDSn}). AV_{DD_PLAT}, AV_{DD_CCn}, AV_{DD_DDR} voltages must be derived directly from the SVDD source through a low frequency filter scheme.

The recommended solution for PLL filtering is to provide independent filter circuits per PLL power supply, as illustrated in Figure 50, one for each of the AV_{DD} pins. By providing independent filters to each PLL, the opportunity to cause noise injection from one PLL to the other is reduced.

This circuit is intended to filter noise in the PLL's resonant frequency range from a 500-kHz to a 10-MHz range.

Each circuit must be placed as close as possible to the specific AV_{DD} pin being supplied to minimize noise coupled from nearby circuits. It must be possible to route directly from the capacitors to the AV_{DD} pin, which is on the periphery of the footprint, without the inductance of vias.

The following figure shows the PLL power supply filter circuit.

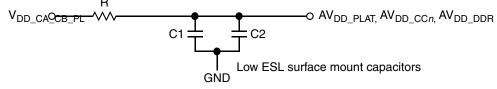
Where:

$$\begin{split} R &= 5 \ \Omega \pm 5\% \\ C1 &= 10 \mu F \pm 10\%, \, 0603, \, X5R, \, with \, ESL <= 0.5 \, nH \\ C2 &= 1.0 \, \mu F \pm 10\%, \, 0402, \, X5R, \, with \, ESL <= 0.5 \, nH \end{split}$$

NOTE

A higher capacitance value for C2 may be used to improve the filter as long as the other C2 parameters do not change (0402 body, X5R, ESL ≤ 0.5 nH).

Voltage for AV_{DD} is defined at the PLL supply filter and not the pin of AV_{DD}.





The AV_{DD-SRDS} signals provide power for the analog portions of the SerDes PLL. To ensure stability of the internal clock, the power supplied to the PLL is filtered using a circuit similar to the one shown in the following figure. For maximum effectiveness, the filter circuit is placed as closely as possible to the AV_{DD_SRDSn} balls to ensure it filters out as much noise as possible. The ground connection must be near the AV_{DD_SRDSn} balls. The 0.003- μ F capacitor is closest to the balls, followed by two 2.2- μ F capacitors, and finally the 1- Ω resistor to the board supply plane. The capacitors are connected from AV_{DD_SRDSn} to the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All traces must be kept short, wide, and direct.

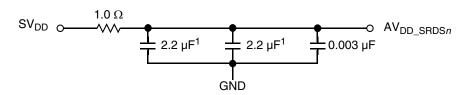


Figure 51. SerDes PLL Power Supply Filter Circuit

NOTE

- AV_{DD_SRDSn} must be a filtered version of SV_{DD}.
- Signals on the SerDes interface are fed from the XV_{DD} power plane.
- Voltage for AV_{DD_SRDSn} is defined at the PLL supply filter and not the pin of AV_{DD SRDSn}.
- An 0805 sized capacitor is recommended for system initial bring-up.

3.3.2 XV_{DD} Power Supply Filtering

 XV_{DD} may be supplied by a linear regulator or sourced by a filtered GV_{DD} . Systems may design in both options to allow flexibility to address system noise dependencies.

An example solution for XV_{DD} filtering, where XV_{DD} is sourced from GV_{DD} , is illustrated in the following figure. The component values in this example filter is system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

C1 = 2.2 μ F ± 10%, X5R, with ESL <= 0.5 nH C2 = 2.2 μ F ± 10%, X5R, with ESL <= 0.5 nH F1 = 120 Ω at 100-MHz 2A 25% 0603 Ferrite F2 = 120 Ω at 100-MHz 2A 25% 0603 Ferrite

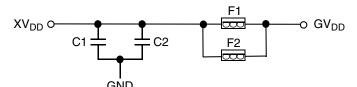


Figure 52. XV_{DD} Power Supply Filter Circuit

3.3.3 USB_V_{DD}_1P0 Power Supply Filtering

 USB_V_{DD} -1P0 must be sourced by a filtered $V_{DD_CA_CB_PL}$ using a star connection. An example solution for USB_V_{DD} -1P0 filtering, where USB_V_{DD} -1P0 is sourced from $V_{DD_CA_CB_PL}$, is illustrated in the following figure. The component values in this example filter is system dependent and are still under characterization, component values may need adjustment based on the system or environment noise.

Where:

 $C1 = 2.2 \ \mu\text{F} \pm 20\%$, X5R, with Low ESL (for example, Panasonic ECJ0EB0J225M) F1 = 120 Ω at 100-MHz 2A 25% Ferrite (for example, Murata BLM18PG121SH1) Bulk and decoupling capacitors are added, as needed, per power supply design.

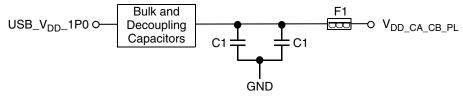


Figure 53. USB_V_{DD}_1P0 Power Supply Filter Circuit

3.4 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the chip system, and the chip itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each V_{DD} , BV_{DD} , OV_{DD} , CV_{DD} , GV_{DD} , and LV_{DD} pin of the device. These decoupling capacitors should receive their power from separate V_{DD} , BV_{DD} , OV_{DD} , CV_{DD} , GV_{DD} , GV_{DD} , LV_{DD} , and GND power planes in the PCB, utilizing short traces to minimize inductance. Capacitors may be placed directly under the device using a standard escape pattern. Others may surround the part.

These capacitors should have a value of 0.01 or 0.1 μ F. Only ceramic SMT (surface mount technology) capacitors must be used to minimize lead inductance, preferably 0402 or 0603 sizes.

Additionally, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the V_{DD} , BV_{DD} , OV_{DD} , CV_{DD} , GV_{DD} , GV_{DD} , and LV_{DD} planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They should also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 μ F (AVX TPS tantalum or Sanyo OSCON).

3.5 SerDes Block Power Supply Decoupling Recommendations

The SerDes block requires a clean, tightly regulated source of power (SV_{DD} and XV_{DD}) to ensure low jitter on transmit and reliable recovery of data in the receiver. An appropriate decoupling scheme is outlined below.

Only SMT capacitors must be used to minimize inductance. Connections from all capacitors to power and ground must be done with multiple vias to further reduce inductance.

- First, the board should have at least 10 × 10-nF SMT ceramic chip capacitors as close as possible to the supply balls of the device. Where the board has blind vias, these capacitors must be placed directly below the chip supply and ground connections. Where the board does not have blind vias, these capacitors must be placed in a ring around the device as close to the supply and ground connections as possible.
- Second, there must be a 1-µF ceramic chip capacitor on each side of the device. This must be done for all SerDes supplies.
- Third, between the device and any SerDes voltage regulator there must be a 10- μ F, low ESR SMT tantalum chip capacitor and a 100- μ F, low ESR SMT tantalum chip capacitor. This must be done for all SerDes supplies.

3.6 Connection Recommendations

Recommendations for proper connection are as follows:

- To ensure reliable operation, it is highly recommended to connect unused inputs to an appropriate signal level. All
 unused active low inputs must be tied to V_{DD}, BV_{DD}, CV_{DD}, OV_{DD}, GV_{DD}, and LV_{DD} as required. All unused active
 high inputs must be connected to GND. All NC (no-connect) signals must remain unconnected. Power and ground
 connections must be made to all external V_{DD}, BV_{DD}, CV_{DD}, OV_{DD}, GV_{DD}, LV_{DD}, and GND pins of the device.
- The Ethernet controllers 1 and/or 2 input pins may be disabled by setting their respective RCW Configuration field EC1 (bits 360–361), and EC2 (bits 363–364), to 0b11 = No parallel mode Ethernet. When disabled, these inputs do not need to be externally pulled to an appropriate signal level.
- ECn_GTX_CLK125 is a 125-MHz input clock on the dTSEC ports. If the dTSEC ports are not used for RGMII, the ECn_GTX_CLK125 input can be tied off to GND.
- If RCW field DMA1 = 0b1 (RCW bit 384), the DMA1 external interface is not enabled and this pin must be left as a no connect.
- If RCW field I2C = 0b100 or 0b101 (RCW bits 355–357), the SDHC_WP and SDHC_CD input signals are enabled for external use. If SDHC_WP and SDHC_CD are selected and not used, they must be externally pulled low such that SDHC_WP = 0 (write enabled) and SDHC_CD = 0 (card detected). If RCW field I2C != 0b100 or 0b101, thereby

selecting either I2C3 or GPIO functionality, SDHC_WP and \overline{SDHC}_{CD} are internally driven such that SDHC_WP = write enabled and \overline{SDHC}_{CD} = card detected and the selected I2C3 or GPIO external pin functionality may be used.

• TMP_DETECT pin and LP_TMP DETECT pin are active low input to the Security Monitor (see the "Secure Boot and Trust Architecture" chapter of the applicable chip reference manual). If a tamper sensor is used, it must maintain the signal at the specified voltage until a tamper is detected. 1K pull-down resistor strongly recommended. If Trust is used without tamper sensors, the high.VDD_LP must be connected even if Low Power features are not used. Otherwise the LP_Section will generate internal errors, which will prevent the high power trust section from reaching Trusted/Secure state.

3.6.1 Legacy JTAG Configuration Signals

Correct operation of the JTAG interface requires configuration of a group of system control pins as demonstrated in Figure 55. Care must be taken to ensure that these pins are maintained at a valid negated state under normal operating conditions as most have asynchronous behavior and spurious assertion will give unpredictable results.

Boundary-scan testing is enabled through the JTAG interface signals. The TRST signal is optional in the IEEE Std 1149.1 specification, but it is provided on all processors built on Power Architecture technology. The device requires TRST to be asserted during power-on reset flow to ensure that the JTAG boundary logic does not interfere with normal chip operation. While the TAP controller can be forced to the reset state using only the TCK and TMS signals, generally systems assert TRST during the power-on reset flow. Simply tying TRST to PORESET is not practical because the JTAG interface is also used for accessing the common on-chip processor (COP), which implements the debug interface to the chip.

The COP function of these processors allow a remote computer system (typically, a PC with dedicated hardware and debugging software) to access and control the internal operations of the processor. The COP interface connects primarily through the JTAG port of the processor, with some additional status monitoring signals. The COP port requires the ability to independently assert PORESET or TRST in order to fully control the processor. If the target system has independent reset sources, such as voltage monitors, watchdog timers, power supply failures, or push-button switches, then the COP reset signals must be merged into these signals with logic.

The arrangement shown in Figure 55 allows the COP port to independently assert **PORESET** or **TRST**, while ensuring that the target can drive **PORESET** as well.

The COP interface has a standard header, shown in Figure 54, for connection to the target system, and is based on the 0.025" square-post, 0.100" centered header assembly (often called a Berg header). The connector typically has pin 14 removed as a connector key.

The COP header adds many benefits such as breakpoints, watchpoints, register and memory examination/modification, and other standard debugger features. An inexpensive option can be to leave the COP header unpopulated until needed.

There is no standardized way to number the COP header; so emulator vendors have issued many different pin numbering schemes. Some COP headers are numbered top-to-bottom then left-to-right, while others use left-to-right then top-to-bottom. Still others number the pins counter-clockwise from pin 1 (as with an IC). Regardless of the numbering scheme, the signal placement recommended in Figure 54 is common to all known emulators.

3.6.1.1 Termination of Unused Signals

If the JTAG interface and COP header are not used, Freescale recommends the following connections:

- TRST must be tied to PORESET through a 0 kΩ isolation resistor so that it is asserted when the system reset signal (PORESET) is asserted, ensuring that the JTAG scan chain is initialized during the power-on reset flow. Freescale recommends that the COP header be designed into the system as shown in the following figure. If this is not possible, the isolation resistor will allow future access to TRST in case a JTAG interface may need to be wired onto the system in future debug situations.
- No pull-up/pull-down is required for TDI, TMS or TDO.

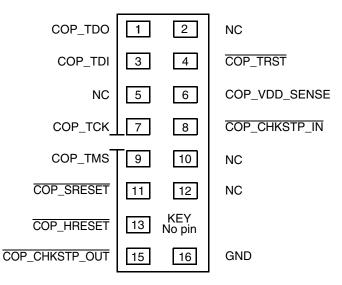
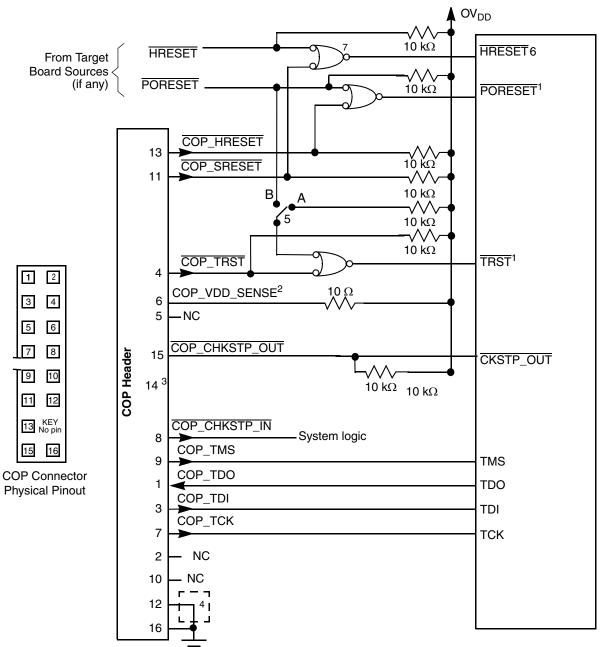


Figure 54. Legacy COP Connector Physical Pinout



Notes:

- 1. The COP port and target board must be able to independently assert PORESET and TRST to the processor in order to fully control the processor as shown here.
- 2. Populate this with a 10 Ω resistor for short-circuit/current-limiting protection.
- 3. The KEY location (pin 14) is not physically present on the COP header.
- 4. Although pin 12 is defined as a No-Connect, some debug tools may use pin 12 as an additional GND pin for improved signal integrity.
- 5. This switch is included as a precaution for BSDL testing. The switch must be closed to position A during BSDL testing to avoid accidentally asserting the TRST line. If BSDL testing is not being performed, this switch must be closed to position B.
- 6. Asserting HRESET causes a hard reset on the device.
- 7. This is an open-drain gate.

Figure 55. Legacy JTAG Interface Connection

3.6.2 Aurora Configuration Signals

Correct operation of the Aurora interface requires configuration of a group of system control pins as demonstrated in Figure 56 and Figure 57. Care must be taken to ensure that these pins are maintained at a valid negated state under normal operating conditions as most have asynchronous behavior and spurious assertion will give unpredictable results.

Freescale recommends that the Aurora 22 pin duplex connector be designed into the system as shown in Figure 58 or the 70 pin duplex connector be designed into the system as shown in Figure 59.

If the Aurora interface is not used, Freescale recommends the legacy COP header be designed into the system as described in Section 3.6.1.1, "Termination of Unused Signals."

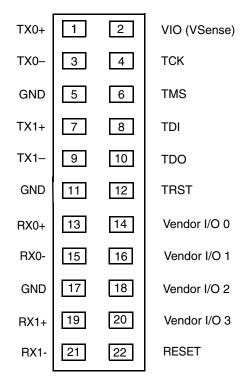
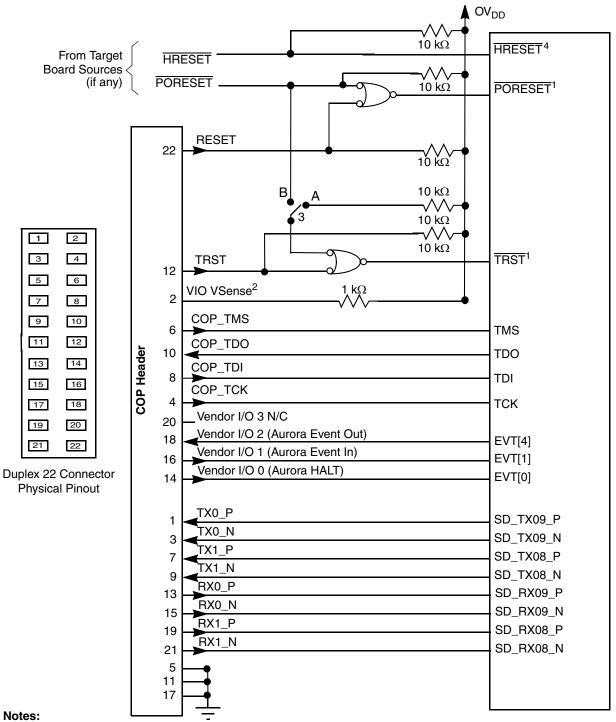


Figure 56. Aurora 22 Pin Connector Duplex Pinout

| 1 | | | 1 |
|------|----|----|--------------|
| TX0+ | 1 | 2 | VIO (VSense) |
| TX0– | 3 | 4 | ТСК |
| GND | 5 | 6 | TMS |
| TX1+ | 7 | 8 | TDI |
| TX1– | 9 | 10 | TDO |
| GND | 11 | 12 | TRST |
| RX0+ | 13 | 14 | Vendor I/O 0 |
| RX0– | 15 | 16 | Vendor I/O 1 |
| GND | 17 | 18 | Vendor I/O 2 |
| RX1+ | 19 | 20 | Vendor I/O 3 |
| RX1– | 21 | 22 | RESET |
| GND | 23 | 24 | GND |
| TX2+ | 25 | 26 | CLK+ |
| TX2– | 27 | 28 | CLK- |
| GND | 29 | 30 | GND |
| TX3+ | 31 | 32 | Vendor I/O 4 |
| TX3– | 33 | 34 | Vendor I/O 5 |
| GND | 35 | 36 | GND |
| RX2+ | 37 | 38 | N/C |
| RX2– | 39 | 40 | N/C |
| GND | 41 | 42 | GND |
| RX3+ | 43 | 44 | N/C |
| RX3– | 45 | 46 | N/C |
| GND | 47 | 48 | GND |
| TX4+ | 49 | 50 | N/C |
| TX4– | 51 | 52 | N/C |
| GND | 53 | 54 | GND |
| TX5+ | 55 | 56 | N/C |
| TX5– | 57 | 58 | N/C |
| GND | 59 | 60 | GND |
| TX6+ | 61 | 62 | N/C |
| TX6– | 63 | 64 | N/C |
| GND | 65 | 66 | GND |
| TX7+ | 67 | 68 | N/C |
| TX7– | 69 | 70 | N/C |
| | | | |

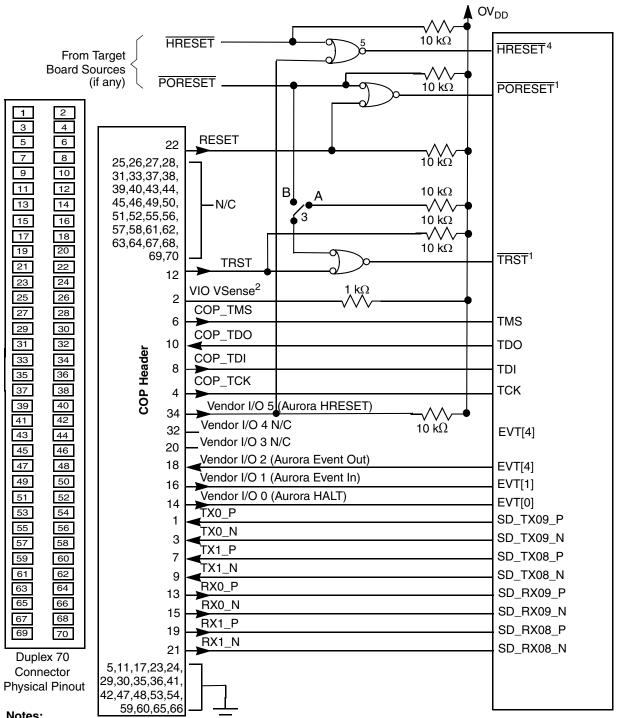
Figure 57. Aurora 70 Pin Connector Duplex Pinout



Notes:

- 1. The Aurora port and target board must be able to independently assert PORESET and TRST to the processor in order to fully control the processor as shown here.
- 2. Populate this with a 1 k Ω resistor for short-circuit/current-limiting protection.
- 3. This switch is included as a precaution for BSDL testing. The switch must be closed to position A during BSDL testing to avoid accidentally asserting the TRST line. If BSDL testing is not being performed, this switch must be closed to position B.
- 4. Asserting HRESET causes a hard reset on the device. HRESET is not used by the Aurora 22 pin connector.

Figure 58. Aurora 22 Pin Connector Duplex Interface Connection



Notes:

- 1. The Aurora port and target board must be able to independently assert PORESET and TRST to the processor in order to fully control the processor as shown here.
- 2. Populate this with a 1 k Ω resistor for short-circuit/current-limiting protection.
- 3. This switch is included as a precaution for BSDL testing. The switch must be closed to position A during BSDL testing to avoid accidentally asserting the TRST line. If BSDL testing is not being performed, this switch must be closed to position B.
- 4. Asserting HRESET causes a hard reset on the device. 5. This is an open-drain gate.

Figure 59. Aurora 70 Pin Connector Duplex Interface Connection

3.6.3 Guidelines for High-Speed Interface Termination

3.6.3.1 SerDes Interface Entirely Unused

If the high-speed SerDes interface is not used at all, the unused pin must be terminated as described in this section.

The following pins must be left unconnected:

- SD_TX[17:0]
- <u>SD_TX[17:0]</u>
- SD_IMP_CAL_RX
- SD_IMP_CAL_TX

The following pins must be connected to SGND:

- SD_RX[17:0]
- <u>SD_RX</u>[17:0]
- SD_REF_CLK1, SD_REF_CLK2, SD_REF_CLK3
- SD_REF_CLK1, SD_REF_CLK2, SD_REF_CLK3

The RCW configuration fields SRDS_LPD_B1, SRDS_LPD_B2, and SRDS_LPD_B3, all bits must be set to power down all the lanes in each bank.

The RCW configuration field SRDS_EN may be cleared to power down the SerDes block for power saving. Setting $RCW[SRDS_EN] = 0$ powers down the PLLs of all three banks.

Additionally, software may configure SRDSBnRSTCTL[SDRD] = 1 for the unused banks to power down the SerDes bank PLLs to save power.

Note that both SV_{DD} and XV_{DD} must remain powered.

3.6.3.2 SerDes Interface Partly Unused

If only part of the high speed SerDes interface pins are used, the remaining high-speed serial I/O pins must be terminated as described in this section.

The following unused pins must be left unconnected:

- SD_TX[*n*]
- $\overline{\text{SD}_{TX}}[n]$

The following unused pins must be connected to SGND:

- SD_RX[*n*]
- $\overline{\text{SD}}_{\text{RX}}[n]$
- SD_REF_CLK1, <u>SD_REF_CLK1</u> (If entire SerDes bank 1 unused)
- SD_REF_CLK2, <u>SD_REF_CLK2</u> (If entire SerDes bank 2 unused)
- SD_REF_CLK3, <u>SD_REF_CLK3</u> (If entire SerDes bank 3 unused)

In the RCW configuration field for each bank SRDS_LPD_B*n* with unused lanes, the respective bit for each unused lane must be set to power down the lane.

3.6.4 USB Controller Connections

This section details the hardware connections required for the USB controllers.

3.6.4.1 USB Divider Network

This figure shows the required divider network for the VBUS interface for the P3041. Additional requirements for the external components are:

- Both resistors require 0.1% accuracy and a current capability of up to 1 mA. They must both have the same temperature coefficient and accuracy.
- The zener diode must have a value of 5 V–5.25 V.
- The 0.6 V diode requires an $I_F = 10$ mA, $I_R < 500$ nA and $V_{F(Max)} = 0.8$ V.

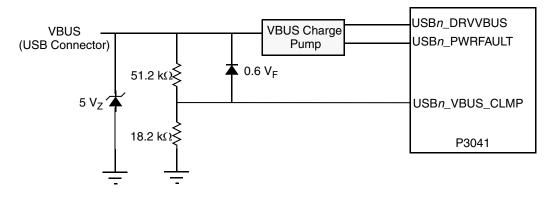


Figure 60. Divider Network at VBUS

USB1_DRVVBUS and USB1_PWRFAULT are muxed on GPIO[4:5] pins, respectively. USB2_DRVVBUS and USB2_PWRFAULT are muxed on GPIO[6:7] pins, respectively. Setting the RCW[GPIO] bit selects USB functionality on the GPIO pins.

3.6.4.2 USB*n*_V_{DD}_1P8_DECAP Capacitor Options

The USB n_V_{DD} -1P8_DECAP pins require a capacitor connected to GND. This table lists the recommended capacitors for the USB n_V_{DD} -1P8_DECAP signal.

| Manufacturer | Part Number | Value | ESR | Package |
|-----------------|----------------------|--------------|---------|---------|
| Kemet | T494B105(1)025A(2) | 1 μF, 25 V | 2 Ω | B(3528) |
| | T494B155(1)025A(2) | 1.5 μF, 25 V | 1.5 Ω | — |
| NIC | NMC0603X7R106KTRPF | 1 μF, 10 V | Low ESR | 0603 |
| TDK Corporation | CERB2CX5R0G105M | 1 μF, 4 V | 200 m-Ω | 0603 |
| Vishay | TR3B105(1)035(2)1500 | 1 μF, 35 V | 1.5 Ω | B(3528) |

Table 113. Recommended Capacitor Parts for USBn_V_{DD}_1P8_DECAP

3.7 Recommended Thermal Model

Information about Flotherm models of the package or thermal data not available in this document can be obtained from your local Freescale sales office.

3.8 Thermal Management Information

This section provides thermal management information for the flip chip plastic ball grid array (FC-PBGA) package for air-cooled applications. Proper thermal control design is primarily dependent on the system-level design—the heat sink, airflow, and thermal interface material.

The recommended attachment method to the heat sink is illustrated in this figure. The heat sink must be attached to the printed-circuit board with the spring force centered over the die. This spring force should not exceed 10 pounds force (45 Newton).

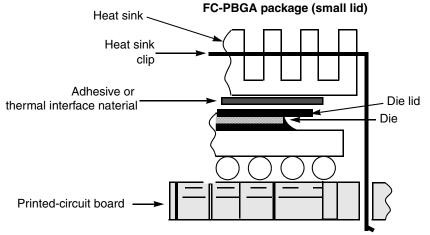


Figure 61. Package Exploded Cross-Sectional View—FC-PBGA (with Lid) Package

The system board designer can choose between several types of heat sinks to place on the device. There are several commercially-available thermal interfaces to choose from in the industry. Ultimately, the final selection of an appropriate heat sink depends on many factors, such as thermal performance at a given air velocity, spatial volume, mass, attachment method, assembly, and cost.

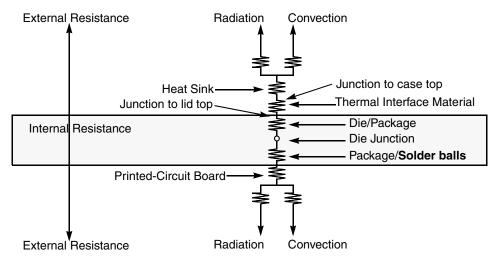
3.8.1 Internal Package Conduction Resistance

For the package, the intrinsic internal conduction thermal resistance paths are as follows:

- The die junction-to-case thermal resistance
- The die junction-to-lid-top thermal resistance
- The die junction-to-board thermal resistance

Package Information

This figure depicts the primary heat transfer path for a package with an attached heat sink mounted to a printed-circuit board.



(Note the internal versus external package resistance)

Figure 62. Package with Heat Sink Mounted to a Printed-Circuit Board

The heat sink removes most of the heat from the device. Heat generated on the active side of the chip is conducted through the silicon and through the heat sink attach material (or thermal interface material), and finally to the heat sink. The junction-to-case thermal resistance is low enough that the heat sink attach material and heat sink thermal resistance are the dominant terms.

3.8.2 Thermal Interface Materials

A thermal interface material is required at the package-to-heat sink interface to minimize the thermal contact resistance. The performance of thermal interface materials improves with increasing contact pressure; this performance characteristic chart is generally provided by the thermal interface vendor. The recommended method of mounting heat sinks on the package is by means of a spring clip attachment to the printed-circuit board (see Figure 61).

The system board designer can choose among several types of commercially-available thermal interface materials.

3.8.3 Temperature Diode

The chip has a temperature diode on the microprocessor that can be used in conjunction with other system temperature monitoring devices (such as Analog Devices, ADT7461ATM). These devices use the negative temperature coefficient of a diode operated at a constant current to determine the temperature of the microprocessor and its environment.

The following are the specifications of the chip's on-board temperature diode:

- Operating range: $10 230 \mu A$
- Ideality factor over $13.5 220 \ \mu A$: $n = 1.00592 \pm 0.008$

4 Package Information

The following section describes the detailed content and mechanical description of the package.

4.1 Package Parameters for the FC-PBGA

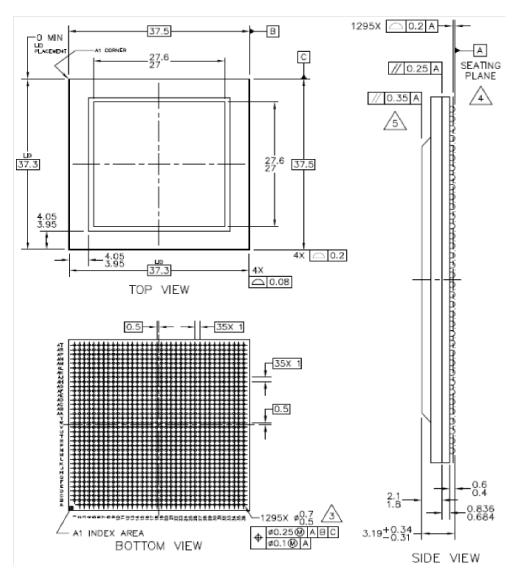
The package parameters are as provided in the following list. The package type is $37.5 \text{ mm} \times 37.5 \text{ mm}$, 1295 flip chip plastic ball grid array (FC-PBGA).

Package Information

| Package outline | 37.5 mm × 37.5 mm |
|-------------------------|------------------------------|
| Interconnects | 1295 |
| Ball Pitch | 1.0 mm |
| Ball Diameter (typical) | 0.60 mm |
| Solder Balls | 96.5% Sn, 3% Ag, 0.5% Cu |
| Module height (typical) | 2.88 mm to 3.53 mm (Maximum) |

4.2 Mechanical Dimensions of the FC-PBGA

This figure shows the mechanical dimensions and bottom surface nomenclature of the chip.



NOTES:

- 1. All dimensions are in millimeters.
- 2. Dimensions and tolerances per ASME Y14.5M-1994.
- 3. All dimensions are symmetric across the package center lines unless dimensioned otherwise.
- 4. Maximum solder ball diameter measured parallel to datum A.
- 5. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.

Security Fuse Processor

6. Parallelism measurement excludes any effect of mark on the top surface of package.

Figure 63. Mechanical Dimensions of the FC-PBGA with Full Lid

5 Security Fuse Processor

This chip implements the QorIQ platform's trust architecture, supporting capabilities such as secure boot. Use of the Trust Architecture features is dependent on programming fuses in the Security Fuse Processor (SFP). The details of the Trust Architecture and SFP can be found in the chip reference manual.

In order to program SFP fuses, the user is required to supply 1.5 V to the POV_{DD} pin per Section 2.2, "Power-Up Sequencing." POV_{DD} should only be powered for the duration of the fuse programming cycle, with a per device limit of two fuse programming cycles. All other times POV_{DD} must be connected to GND. The sequencing requirements for raising and lowering POV_{DD} are shown in Figure 8. To ensure device reliability, fuse programming must be performed within the recommended fuse programming temperature range per Table 3.

Users not implementing the QorIQ platform's Trust Architecture features are not required to program fuses and should connect POV_{DD} to GND.

6 Ordering Information

Please contact your local Freescale sales office or regional marketing team for ordering information.

6.1 Part Numbering Nomenclature

This table provides the Freescale QorIQ platform part numbering nomenclature.Not all possible combinations of part numbers implied by the part numbering scheme are supported. For a list of available part numbers, please contact your Freescale Sales office. Each part number also contains a revision code which refers to the die mask revision number.

| р | n | nn | n | X | t | е | n | С | d | r |
|------------|----------|---|------------|--|---|--|---|---|--------------------------------------|---|
| Generation | Platform | Number of Cores | Derivative | Qual Status | Temperature Range | Encryption | Package Type | CPU Freq | DDR Data Rate | Die Revision |
| P = 45 nm | 1–5 | 01 = 1 core 02 = 2 core 04 = 4 core | 0–9 | P = Prototype N = Industrial qualification | S = Std temp X= Extended temp (-40 to 105 C) | E = SEC present N = SEC not present | 1 = FC-PBGA Pb-free spheres 7 = FC-PBGA C4 and sphere Pb-free | M = 1200 MHz N = 1333 MHz P = 1500 MHz | M = 1200 MT/s N = 1333 MT/s | A = Rev 1.0 B= Rev 1.1 C = Rev 2.0 |

Table 114. Part Numbering Nomenclature

Ordering Information

6.2 Orderable Part Numbers Addressed by this Document

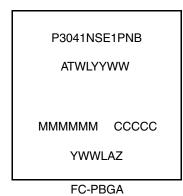
This table provides the Freescale orderable part numbers addressed by this document for the chip.

| Part Number | р | n | nn | n | x | t | е | n | С | d | r |
|------------------------------|---|---|-----------------|---|-------------------|------------------------|------------------------|-----------------------------|-----------------|------------------|--------|
| P3041NSE1MMB P3041NSE7MMC | Ρ | 3 | 04 = 4 cores | 1 | N = Industrial | S = Std temp | E = SEC present | | M = 1200 MHz | M = 1200 MT/s | B C |
| P3041NSN1MMB P3041NSN7MMC | | | | | qualification | | N = SEC not present | Pb-free spheres 7 = | | | |
| P3041NSE1NNB P3041NSE7NNC | | | | | | | E = SEC present | FC-PBGA C4 and sphere | N = 1333 MHz | N = 1333 MT/s | |
| P3041NSN1NNB P3041NSN7NNC | | | | | | | N = SEC not present | Pb-free | | | |
| P3041NSE1PNB P3041NSE7PNC | | | | | | | E = SEC present | | P = 1500 MHz | | |
| P3041NSN1PNB P3041NSN7PNC | | | | | | | N = SEC not present | | | | |
| P3041NXE1MMB P3041NXE7MMC | | | | | | X= Extended temp | E = SEC present | | M = 1200 MHz | M = 1200 MT/s | |
| P3041NXN1MMB P3041NXN7MMC | | | | | | | N = SEC not present | | | | |
| P3041NXE1NNB P3041NXE7NNC | | | | | | | E = SEC present | | N = 1333 MHz | N = 1333 MT/s | |
| P3041NXN1NNB P3041NXN7NNC | | | | | | | N = SEC not present | | | | |
| P3041NXE1PNB P3041NXE7PNC | | | | | | | E = SEC present | | P = 1500 MHz | | |
| P3041NXN1PNB P3041NXN7PNC | | | | | | | N = SEC not present | | | | |

Revision history

6.2.1 Part Marking

Parts are marked as in the example shown in this figure.



Notes:

P3041NSE1PNB is the orderable part number. See Table 115 for details.

ATWLYYWW is the test traceability code.

MMMMMM is the mask number.

CCCCC is the country code.

YWWLAZ is the assembly traceability code.

Figure 64. Part Marking for FC-PBGA Device

7 Revision history

This table provides a revision history for this document.

Table 116. Revision history

| Rev. number | Date | Description |
|----------------|---------|---|
| 2 | 02/2013 | In Table 7, "P3041 I/O Power Supply Estimated Values", updated the USB power supply with USB_Vdd_3P3 and updated the typical value with "0.003" in the Others (Reset, System Clock, JTAG & Misc.) row. In Table 8, "AVDD Power Dissipation," removed V_{DD_LP} from table. Added Table 10, "VDD_LP Power Dissipation". In Table 55, "MPIC Input AC Timing Specifications," added Trust inputs AC timing and footnote 2. In Table 100, "Processor Clocking Specifications," updated footnote 8 with Rev 1.1 silicon. In Table 114, "Part Numbering Nomenclature," added "C" in the Die Revision collumn. In Table 115, "Orderable Part Numbers Addressed by This Document," added the device part numbers for Rev 2.0 silicon. |

| Rev. number | Date | Description |
|----------------|---------|---|
| 1 | 10/2012 | In Table 1, "Pins List by Bus", added note 27 for pin V_{DD_LP} Updated Table 8, "AVDD Power Dissipation." In Table 12, "SYSCLK DC Electrical Characteristics (OVDD = 3.3 V)", updated the input current max value and added input capacitance max value. In Table 53, "eSDHC AC Timing Specifications", updated input setup times from 5 ns to 2.5 ns. In Section 3.1.6.2, "Minimum Platform Frequency Requirements for High-Speed Interfaces", updated the note description for "PCI Express link width". In Section 3.6, "Connection Recommendations", removed the sentence "If no aspect of Trust Architecture is to be used, all Trust Architecture pins can be tied to GND." In Section 4.1, "Package Parameters for the FC-PBGA", updated the solder ball composition and module height. |
| 0 | 06/2012 | Initial public release |

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